

DESIGN AND DEVELOPMENT OF EMBEDDED
DSP CONTROLLERS FOR POWER
ELECTRONIC APPLICATIONS

by

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ABSTRACT

DESIGN AND DEVELOPMENT OF EMBEDDED DSP CONTROLLERS FOR POWER ELECTRONIC APPLICATIONS

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Power applications like motor drives, inverters have complex algorithms that can be used to improve their efficiency. More often reduced manufacturing cost takes precedence over better efficiency. DSPs with their high computational power can provide reduced cost and higher efficiency. Though the cost of a standalone DSP chip has reduced, its integration to form a complete embedded product is an area often overlooked. High frequency of operation, reduced package size, and sensitivity to

component placement are some of the factors that affect the interface between input/output devices and the DSP.

This thesis presents the design and development of an embedded DSP controller board using TI's TMS320F2808. A three phase Space Vector PWM inverter is constructed and used to test the DSP board. This thesis also compares Space Vector PWM with other carrier based modulation schemes.

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CHAPTER 1

INTRODUCTION

1.1 Overview of DSP Processors

“DSP processors” may be defined as “microprocessors designed to perform digital signal processing” [1]. Over the years microprocessors have been used to perform complex computations with speed being the primary focus. Size and memory were never constraints in advanced microprocessor based systems. On the other hand microcontrollers, which are again derivatives of the microprocessor family, were designed for applications that had relatively simple computations, low memory requirements and extreme sensitivity to size. On the outset, DSP processors fall in between these two.

Architectural properties of conventional DSP processors:

1) *Multiply and accumulate or MAC*: Any digital logic implemented in hardware is usually faster than its corresponding software equivalent. This is one of the basis for ASIC (Application Specific Integrated Circuit). DSP processors have evolved based on DSP applications. Sum of products terms ($\sum xy$) are one of the most frequently used operations in DSP. FIR filter, IIR filter, convolution and Fourier transforms are few examples [2]. In all of these examples multiply-accumulate or a “MAC” operation as it popularly known is the common factor. Though DSP processor architectures have mutated over the years, “historically” one of the fundamental features

that differentiate it from general microprocessor is its support for single cycle MAC operations in hardware. An FIR (Finite Impulse Response) filter illustrated in Figure 1.1 can be defined by the following equation

$$y(n) = \sum_{k=0}^{N-1} a_k x(n-k) \quad (1.1)$$

where $y(n)$ represents the output response,

a_k : is the filter coefficient,

$x(n-k)$ represents the k th delayed input sample.

From this expression we find that the output is equivalent to a sum of products (SOP). Hence in order to speed the process of computation, DSP processors have a multiplier and accumulator unit implemented in hardware.

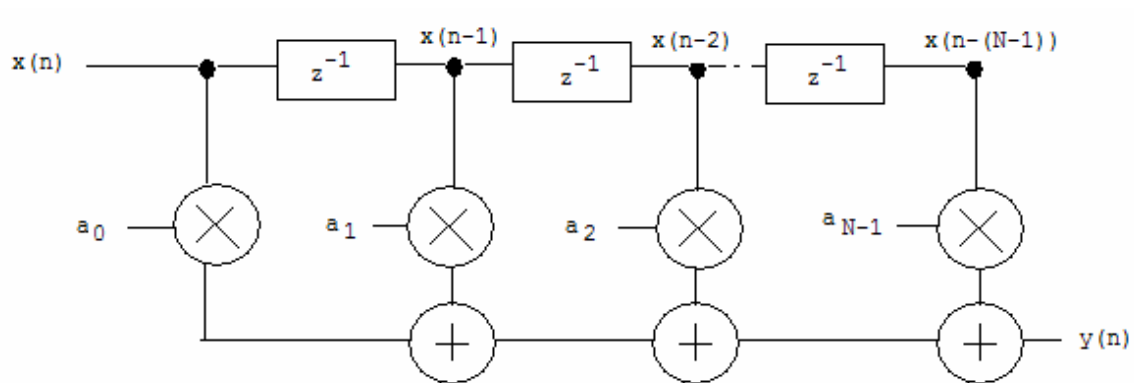


Figure 1.1 FIR filter

2) *Memory organization and access*: Conventional general purpose processors (GPPs) have a single bus to transport data and program instructions between memory and the processor (Von Nuemann architecture). Since programs in DSP applications and

most embedded applications are static (which means the program size is deterministic and usually designed for a specific application), better performance is achieved by having separate buses to access instructions and data from memory (Harvard architecture). The above property is characteristic of microcontrollers too. Since most data input in DSP applications is sequentially organized, memory access in DSP processors is improved by having specialized hardware to increment memory address pointers as well as support for specialized addressing methods like register indirect addressing with auto-increment. “Circular addressing” is another addressing mode characteristic of DSP processors, where in the memory address pointer automatically wraps around to the beginning address after a predefined set of memory accesses. As seen in the FIR filter equation above, the memory access to filter coefficients possess this circular pattern. In order to further speed up memory access, some DSP processors have multiple memory banks with separate buses. But since, this requires more chip space and power, the number of memory buses is limited. DSP processors tend to improve memory access by means of memory parallelism. In contrast, GPPs improve memory access using cache memory. Cache memory is small high speed memory closest to the processor. The objective is for the processor to always or most of the time access data/program from the cache. Implementation of cache is based on probabilistic theory and is bane for real time systems which require deterministic timing constraints. Since DSP processors more often deal with hard real time systems (systems with strict timing constraints), cache strategy is usually not implemented. As will be seen later, some DSP processors implement an instruction cache alone to aid looping.

3) *Arithmetic format*: Numbers are represented either as fixed point or floating point in all processors. In fixed point, as the name suggests, the binary point is placed at a fixed location within the data word resulting in a fixed range (usually between -1 and +1). On the other hand in floating point representation a number is represented in the form $mantissa \times 2^{exponent}$, the binary point is allowed to “float” according to the value of the exponent. Floating point representation has a higher dynamic range (ratio between the highest and smallest number) compared to fixed point. Intuitively DSP processors must favor floating point representation. But cost, size and power consumption of floating point hardware restrict its implementation. The lower end of the latest DSP processors being cost sensitive has fixed point representation. This places onus on programmers to understand the requirements of the application and perform scaling operations in software to overcome limitations of fixed point representation.

4) *Specialized Instruction set*: As seen above, DSP processors have hardware to perform multiple operations in a single cycle, which effectively means a single instruction performs more than one task. For example consider instruction from TI’s TMS320C24X series.

MACD pma,dma (multiply and accumulate with data move)

pma – program memory address; dma – data memory address. (Advantage of Harvard architecture can be seen here, with simultaneous access to two memory banks being possible in a single instruction cycle)

This instruction does the following:

- 1) Move PC (Program counter) -> MSTACK (stack).

- 2) Move pma -> PC.
- 3) ACC (Accumulator) + shifted PREG (product register) -> ACC.
- 4) (dma) ->TREG (temporary register)
- 5) (dma) x (pma) ->PREG (product register)
- 6) Increment dma.

It is apparent from this instruction that the DSP with multiple execution units is capable of performing multiple operations in a single instruction. With the need to have small programs, DSP processors are designed to have a relatively small instruction set. The number of register based instructions (common in GPPs) is reduced and more information is encoded within the opcode of the instruction. Hence most DSP processors possess a specialized and irregular instruction set. This does not ease programming, requiring programmers to have a complete understanding of assembly language. Most DSP processor manufacturers provide C language support, but the general trend towards efficient programming is to fine tune in assembly.

5) *Zero-overhead looping:* Going back to the FIR filter diagram above, we find that the operation is iterative with a fixed number of coefficients operating on a set of input samples in a loop. If implemented on a conventional GPP, few extra cycles would be spent on the loop test condition. For example consider the instruction JZ belonging to the 8086 instruction set. This instruction consumes 4 clock cycles when there is no jump and 13 clock cycles for a jump. DSP processors have a specialized hardware to circumvent this problem. The term zero-overhead looping means that the processor can execute loops without consuming cycles to test the value of the loop counter. [3]. Hence

even loop instructions effectively take a single instruction cycle due to this extra hardware implementation.

1.2 Timeline: DSP Processors

DSP processors have grown rapidly over the years, to such an extent that few of the properties considered essential to a conventional DSP processor are missing. For example the TI's TMS320C62XX which is considered one of the better DSP processors in the current era does not have "zero overhead looping" feature [2]. With more applications like motor control, power supplies embracing DSP technology, the current trend in DSP architecture may be broadly split into three categories:

1) Conventional or first generation DSP processors: These processors have most of the properties typical of a conventional DSP processor described above. The focus in this category of processors has been on cost and integration of peripheral units like Analog to Digital Converter, Serial Peripheral Communication (SPI) and Pulse Width Modulation (PWM) unit. They can compute 20-100 Millions Instructions Per Second (MIPS), which is sufficient for motor control, digital power supplies, automotive and consumer applications. This generation of processors, though initially designed for signal processing applications have gradually mutated towards control applications and are better known DSP controllers or Digital Signal Controllers (DSC). This thesis delves into this category of processors and will be explained in later part of this chapter. Examples of these DSP processors include Freescale's DSP56XXX series

and TI's TMS320C2XXX series. Figure 1.2 shows the diagram of conventional DSP processor [4].

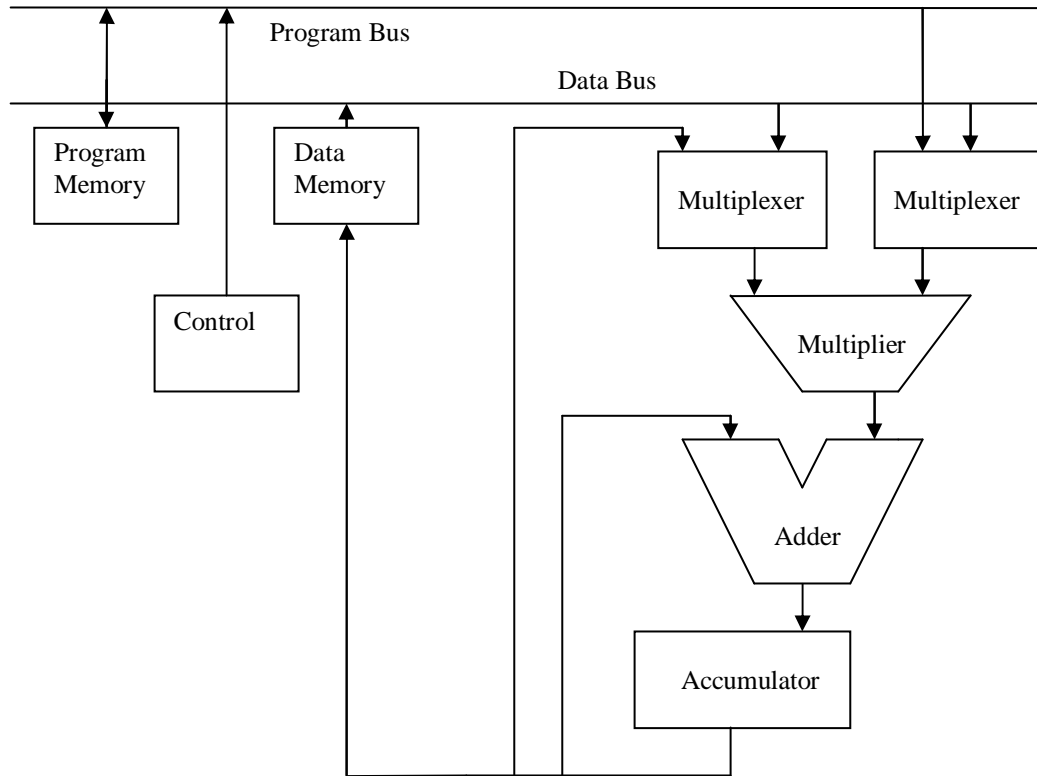


Figure 1.2 Simplified diagram of a conventional DSP processor

2) *Enhanced conventional or second generation DSP processors*: Increasing clock speed is one of the straight forward ways of improving speed of computation. But this comes at the expense of higher power dissipation, size and higher costs. One other way is to increase parallelism in the design by having multiple arithmetic units (AU), multiple memory ports and efficient address generation hardware [5]. Recent developments in fabrication techniques and use of lower voltage switching levels have reduced power dissipation and overall cost. There is very thin line of distinction

between the first and second generation processors. From a broad perspective, this generation of processor can be considered an “enhanced” [2] version of their predecessor. For example Lucent DSP16xxx processors have two MAC units, a 32-bit data bus and 8 accumulators in comparison to its first generation processor DSP16xx series having one MAC, 16-bit data bus and two accumulators. TI’s TMS320C5xxx series are another set of processors in this category which address needs of wireless modems, cell phones, GPS receivers and, digital audio players.

3) *Multi-issue or Third generation DSP processors*: Conventional DSP processor architecture is unfavorable to high level programming due to its irregular specialized instruction set. For this generation of processors, with speed of computation being the primary objective, DSP architects felt the need to borrow solutions from advanced GPP designs. High end applications like image processing required efficient programming tools in addition to fast computation. Two technologies currently used among these processors are VLIW (Very Long Instruction Word) and superscalar. In both these designs, the processor executes a group of instructions in parallel. The two designs differ in the order in which the instructions are executed. VLIW is more predictable with the order being determined when the program is assembled and does not change at runtime. On the other hand superscalar have specialized hardware to determine the order of instruction execution based on data dependencies [2]. This means that same set of instructions may be grouped differently by the processor when run at different occasions. This unpredictability is not favorable for real time DSP applications which have stringent time deadlines. This is one of the reasons for VLIW

being more popular among most manufacturers in this category. Another concept prevalent among both these architectures presented above is SIMD (Single Instruction Multiple Data). As the name suggests, the processor is designed to operate on different data for the same instruction. This can significantly improve throughput for algorithms that process data in parallel. For example in the FIR filter example above, the same MAC operation is performed on different sets of input data and hence more work is done when different data is presented to multiple execution units for the same instruction. DSP processors in this generation are characterized by larger data buses, higher clock frequencies, large number of execution units and a sophisticated control unit to synchronize data flow among the parallel units. Hence these processors are much more expensive, dissipate more heat and occupy more space than their predecessors. Examples of DSP processors in this category are TI's TMS320C6xxx series which operates at almost 1.1GHz, Analog Devices TigerSHARC and StarCore (built under partnership between Motorola and Lucent).

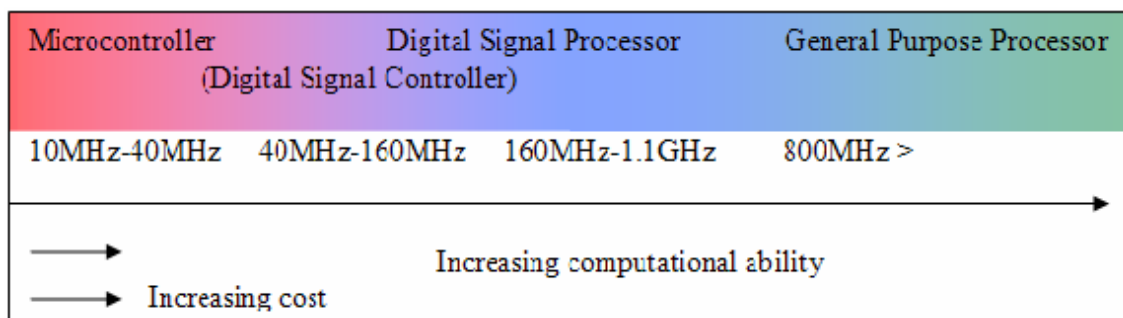


Figure 1.3 Graphical representation of processor complexity

1.3 Digital Signal Controller

Microcontrollers used to rule the roost for over a decade in almost all embedded control applications. They are known for their small size, efficient input-output communication ports and ability to perform real time control tasks. Some of their major applications include motor control, power converters and consumer electronics like disk drives and music players. During the same era, DSPs also co-existed and were mainly used in telecommunication, image processing and other number crunching applications. Complex control algorithms like vector control have existed for a while on paper, but never used commercially due to the lack of cost effective and fast microcontrollers. DSP manufacturers began to include more controller related features like on chip memory and peripheral units. Similarly microcontroller manufacturers tried to improve performance by increasing the data bus size from 8 to 16 bits. DSP processors that had controller abilities were called DSP controllers. In 2002, Microchip officially coined the term “Digital Signal Controller or DSC” [6]. Since then other companies have recognized the mergence. (like TIs TMS320C2000 series and Freescales 56800E series). Based on the evolution of DSPs mentioned above, DSCs may be placed in the first generation of DSPs. Figure 1.4 depicts the block diagram of the TMS320C28X digital signal controller [11].

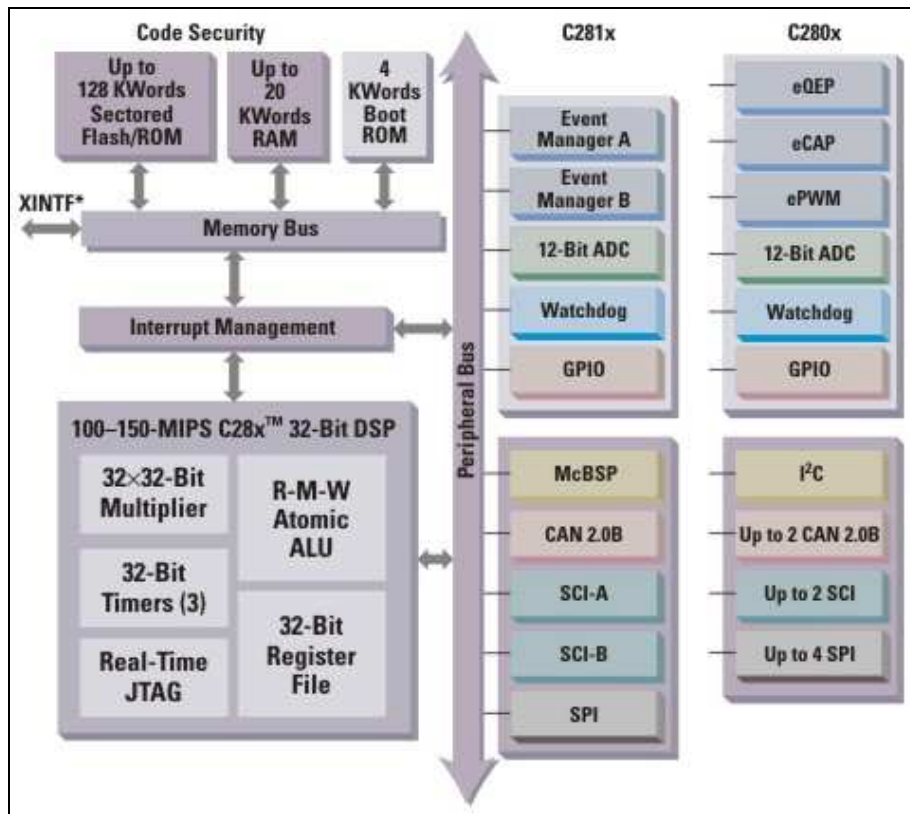


Figure 1.4 Block diagram of TMS320C28X Digital Signal Controller architecture

The table below illustrates the features of microcontrollers, DSP and DSC. [6]

Table 1.1 MCU, DSP and DSC comparison

Feature	MCUs	DSPs	DSCs
Single cycle MAC		✓	✓
Zero overhead looping		✓	✓
Modulo arithmetic		✓	✓
Dual operand fetch		✓	✓
Fast interrupt control	✓		✓
Execute from Flash	✓		✓
Large register set	✓		✓
Abundant Mixed signal	✓		✓

1.4 Need for DSP controllers or Digital Signal Controllers in power and motor control applications

DSPs were initially designed specifically for signal processing algorithms. With the focus shifting to cost effectiveness and efficiency, more control applications started utilizing the advantages of DSPs. Whether DSPs actually help control applications is not completely obvious. For some applications a high speed microcontroller with a larger data bus might help in faster computation. The need for DSP may be justified by considering the similarities between control and signal processing algorithms. Consider for example the PI controller. The transfer function in continuous time domain is represented by the equation [7]

$$U(s) = \left(K_p + \frac{K_i}{s} \right) I(s) \quad (1.2)$$

where U :controller output signal

I : input error signal

s : Laplace variable

K_p: proportional gain

K_i: integral gain

The above equation in discrete time domain may be represented by the following expression

$$U_{k+1} = A_1 I_{k+1} + A_0 I_k + U_k \quad (1.3)$$

where $A_1 = \frac{K_i}{2} T_z + K_p$ and $A_0 = \frac{K_i}{2} T_z - K_p$

From the above expression we find that the output is Sum of Products (SOP), which is favorable for DSP operation. Intuitively most continuous domain systems when converted to discrete domain form a system of difference equations. Hence most control algorithms can take advantage of DSP processors. Table 1.2 [10] provides a comparative study of computation time requirements of various algorithms.

In power electronics applications, DSP or DSCs are used to replace hardware component by performing the equivalent operation in software. Power conversion devices like DC-DC converters, DC-AC inverters operate by controlling switches at high frequency. Hence higher order harmonics are inevitably present in the output signal. Traditionally external hardware was used to perform the filtering operation. Now with the power of DSC, the filtering operation can be accomplished in software.

In motor control applications, DSC plays a significant role in improving efficiency, reliability and reducing manufacturing costs. Control routines like Field Oriented Control (FOC) have several matrix routines which are again MAC operations. Switched Reluctance (SR) motors are known for they low manufacturing cost, high reliability and excellent torque characteristics [9]. But control of these motors was difficult since it required precise excitation of the stator windings with respect to rotor position. With the help of DSC, rotor position could be estimated in real time by modeling the motor in software.

DSCs usually provide a bandwidth of 20 to 150 MIPS [8]. Motor control typically requires 20-40 MIPS. This leaves sufficient room for performing auxiliary functions in white good appliances like voice recognition, implementing networking

and wireless protocols. Hence use of DSC can reduce the size and cost of the overall system.

Table 1.2 Comparative study of various algorithms

Function	Cycle Count Equation	Conditions	Number of cycles	Execution time @ 40MIPS
Complex FFT**	-	N=64	3739	93.5 μ s
Complex FFT**	-	N=128	8485	212.1 μ s
Complex FFT**	-	N=256	19055	476.4 μ s
Single Tap FIR	-	-	1	25ns
Block FIR	53+N(4+M)	N=32, M=32	1205	30.2 μ s
Block FIR Lattice	41+N(4+7M)	N=32, M=32	7337	183.5 μ s
Block IIR Canonic	36+N(8+7S)	N=32, S=4	1188	29.7 μ s
Block IIR Lattice	46+N(16+7M)	N=32, M=8	2350	58.7 μ s
Matrix Add	20+3(C*R)	C=8, R=8	212	5.3 μ s
Matrix Transpose	16+C(6+3(R-1))	C=8, R=8	232	5.8 μ s
Vector Dot Product	17+3N	N=32	113	2.9 μ s
Vector Max	19+7(N-2)	N=32	229	5.7 μ s
Vector Multiply	17+4N	N=32	145	3.6 μ s
Vector Power	16+2N	N=32	80	2.0 μ s
PID Loop Core	-	-	7	175ns
*C=#columns, N=#samples, M=#taps, S=#sections, R=#rows				
**Complex FFT inherently prevents overflow				
1 cycle = 25 nanoseconds @ 40 MIPS				

Table 1.3 Comparison of currently available Digital Signal Controllers

No	Company-processor	Clock (MHz)	Memory (KB)	Timers	GPIO	ADC /conversion time	PWM	Other Peripherals	Supply (V)	Cost (\$/1000)
1	TI-TMS320LF240X	40	RAM: 2 -5 ROM: Nil Flash: 64	1 WD 4 -16 bit	41	1 -16 Ch 10-bit /500 ns	8 -16 bit	CAP:6 QEP:4 UART: 1 SCI SPI: 1 CAN: 1	Core: 3.3 IO: 3.3	3.5-9.75
2	TI-TMS320F281X	150	RAM:36 ROM: Nil Flash:128-256	1 WD 3 - 32 bit	56	1-16 Ch 12-bit /80 ns	8 -16 bit	CAP:6 QEP:2 UART: 2 SCI SPI: 1 CAN: 1	Core: 1.9 IO: 3.3	14-19
3	TI-TMS320F280X	100	RAM:12-36 ROM: Nil Flash: 32-256	1 WD 3- 32 bit	35	1-16 Ch 12-bit /160 ns	8-16 bit	CAP:4 QEP:2 UART: 2 SCI SPI: 4 CAN: 2	Core: 1.8 IO:3.3	6-12
4	Analog-ADSP219X	160	RAM:16 ROM: Nil Flash: Nil	1 WD 3-32 bit	16	1-8 Ch 14-bit /91 ns	8-16 bit	CAP: Nil QEP: 1 UART: called SPORT SPI: Nil CAN: Nil	Core: 2.5	5-10
5	Microchip dsPIC30F201X	30	RAM:1 ROM:Nil Flash: 12	1 WD 3 -16 bit	20	1-10 Ch 12-bit /10000 ns	8-16 bit	CAP: 4 QEP: 1 UART: 1 SPI: 1 CAN: 0 I2C: 1	Core: 2.5	3-4
6	Microchip dsPIC30F401X	30	RAM: 2 ROM: 1 Flash: 48	1 WD 5-16 bit	30	1-9 Ch 10-bit /2000 ns	6-16 bit	CAP: 4 QEP: 1 UART: 2 SPI: 1 CAN: 1 I2C: 1	Core: 2.5	4-5
7	Microchip dsPIC30D601X	30	RAM: 8 ROM: 4 Flash: 144	1 WD 5-16 bit 2-32 bit	52	1-16 Ch 10-bit /1000 ns	8- 16 bit	CAP: 8 QEP: 1 UART: 2 SPI: 2 CAN: 1 I2C: 1	Core: 2.5	8-9
8	Freescale MC56F81XX	40	RAM: 32 ROM: Nil Flash: 512	1 WD 8-16 bit	76	4- 4 Ch 12-bit /1200 ns	6 - 16 bit	CAP: 8 QEP: 2 UART: 2 SCI SPI: 2 CAN: Nil	Core: 2.5 IO: 3.3	15-18
9	Freescale MC56F83XX	60	RAM: 68 ROM: Nil Flash: 512	1 WD 16- 16 bit	76	4 - 4 Ch 12-bit /1200 ns	12- 16 bit	CAP: 8 QEP: 2 UART: 2 SCI SPI: 2 CAN: 2 flexCAN Temperature sensor	Core: 2.5 IO:3.3	18-25
10	Infineon TC1165	80	RAM: 56 ROM: 32 Flash: 1504	1 WD 32-16/24 bit (GPTA)	81	32 inputs 8, 10, 12 bit /262.5 ns	6 - 16 bit	CAP: 32 QEP: Nil ASC :1 SSC: 2 CAN: 2	Core: 1.5 IO: 3.3	NA

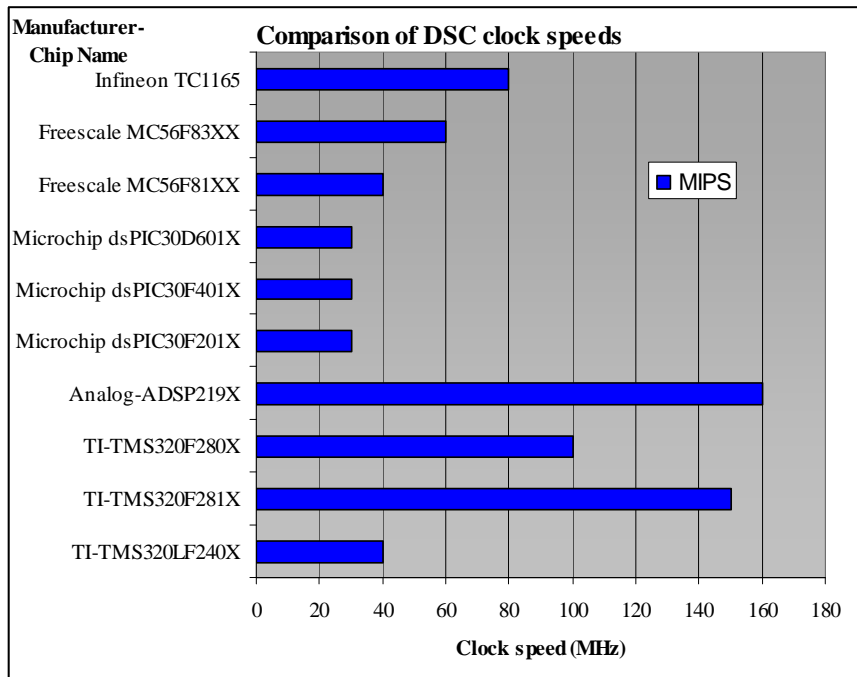


Figure 1.5 Comparison of clock speeds of various Digital Signal Controllers

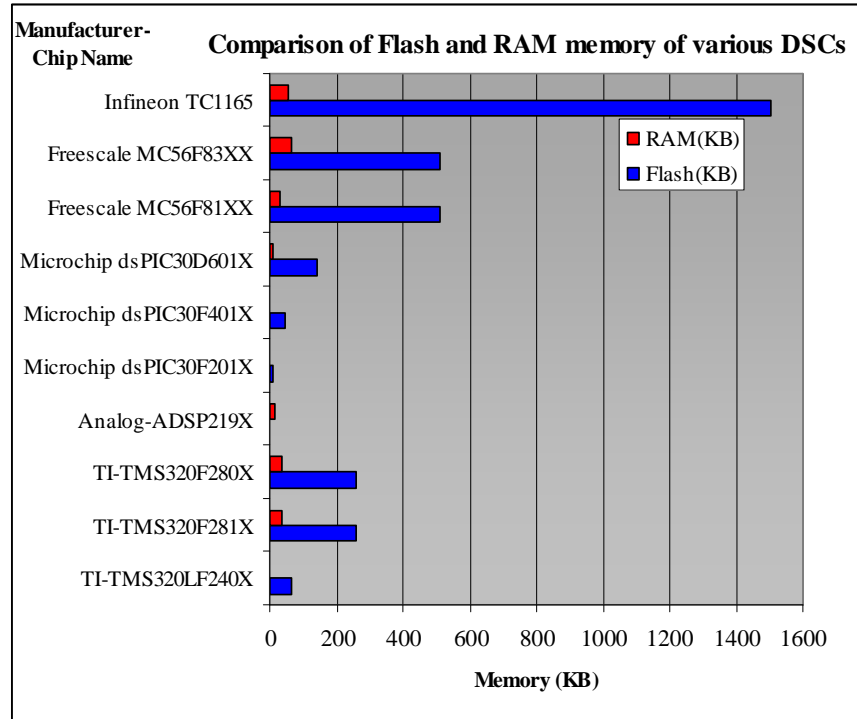


Figure 1.6 Comparison of Flash and RAM memory of various Digital Signal Controllers

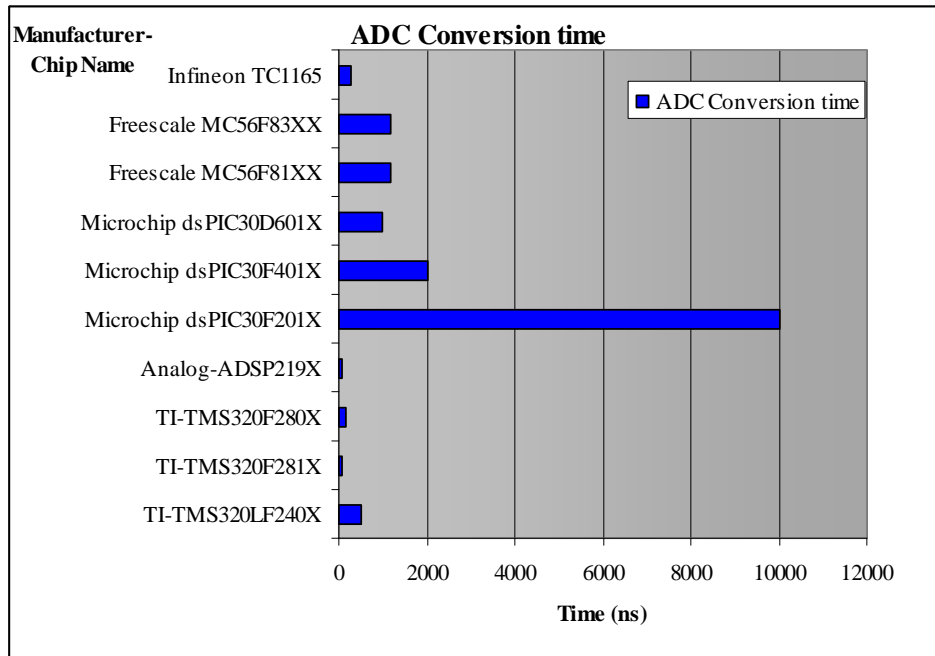


Figure 1.7 Comparison of ADC conversion times of various Digital Signal Controllers

In this thesis TI's TMS320F2808 Digital Signal Controller has been used in designing the controller board. Some of its features are as follow. [9]

- 1) 100 MHz (10-ns Cycle Time)
- 2) Low-Power (1.8-V Core, 3.3-V I/O) Design
- 3) 16 x 16 and 32 x 32 MAC Operations
- 4) Harvard Bus Architecture
- 5) On-Chip Memory : 64K X 16 Flash, 18K X 16 SARAM
- 6) 1K x 16 OTP ROM (F280x Only)
- 7) Boot ROM (4K x 16)
- 8) Watchdog Timer Module

- 9) Any GPIO A Pin Can Be Connected to One of the Three External Core Interrupts
- 10) Peripheral Interrupt Expansion (PIE) Block That Supports All 43 Peripheral Interrupts
- 11) 128-Bit Security Key/Lock
- 12) Enhanced Control Peripherals
- 13) 16 PWM Outputs , 4 HRPWM Outputs With 150 ps MEP Resolution
- 14) Four Capture Inputs
- 15) Two Quadrature Encoder Interfaces
- 16) Six 32-bit/Six 16-bit Timers, Three 32-Bit CPU Timers ,4 Serial Peripheral Interface (SPI) Modules
- 17) 2 Serial Communications Interface (SCI), Standard UART Modules
- 18) 2 CAN Modules
- 19) One Inter-Integrated-Circuit (I2C) Bus
- 20) 12-Bit ADC, 16 Channels ,2 x 8 Channel Input Multiplexer ,Two Sample-and-Hold
- 21) Single/Simultaneous Conversions , Fast Conversion Rate: 160 ns/6.25 MSPS Internal or External Reference
- 22) 35 Individually Programmable, Multiplexed General-Purpose Input/Output (GPIO) Pins.

CHAPTER 2

HIGH SPEED PRINTED CIRCUIT BOARD DESIGN

2.1 Overview of PCB Technology

Printed Circuit Board (PCB) is a board on which components are soldered and interconnected using wires (better known as traces) to form a functional circuit. They consist of several electrical and non-electrical layers [12]. The number of electrical layers usually varies between 2 and 20. Most common are 4, 6 and 8 layered boards. Each of the layers contains copper traces or copper planes. Interconnection among layers is made using “vias” which are holes drilled and filled with copper. The components of a typical six layer PCB is shown in figure 2.1 [13].

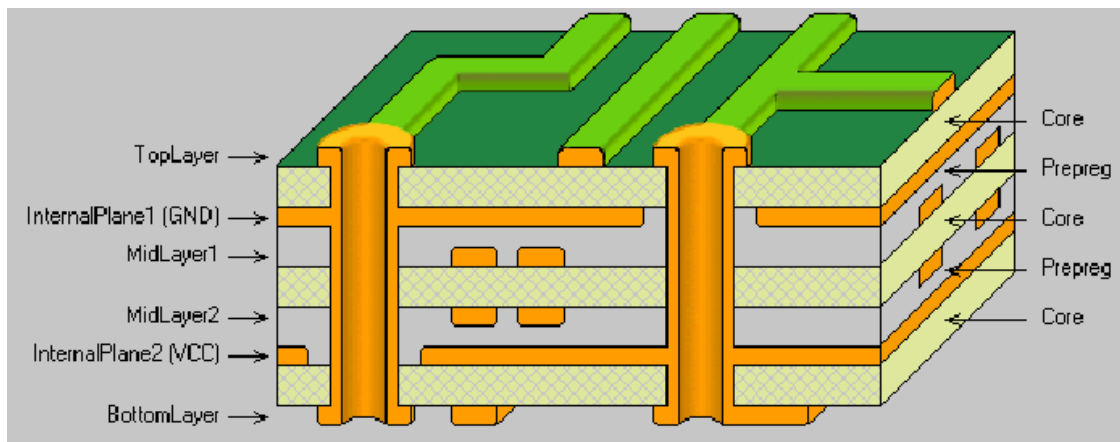


Figure 2.1 Typical six layer PCB

A brief explanation of each of the layers is provided below.

- 1) Core: The core material is a rigid sheet usually made of cured fiberglass resin material that provides isolation between layers. Most commonly used core

materials are FR-4 epoxy glass, cyanate ester, polyimide glass and Teflon. As will be seen later, the dielectric strength, coefficient of thermal expansion and cost of the cores play an important role in selecting cores for PCB design.

2) Prepreg: This layer is made of a material similar to core material but is uncured. They behave as an adhesive to bond the copper layers. When heated and pressed, the prepreg will cure (harden) holding the copper layers firmly.

3) Copper foil and traces: Copper foil is a thin sheet of copper that bonds to the prepreg layer. Traces are formed by etching the copper foil. The usual thickness of copper layers is 0.5 ounce, 1 ounce and 2 ounce [14]. The trace width is a design parameter depending on density of the board, current and required impedance of the trace.

4) Copper Plating: Copper plating is primarily used only on the finished board, on the external layers, and provides an additional thickness of copper to the board. The average thickness for the plating is 0.014". The external plating is usually done after the board is drilled and etched. [14].

5) Drill: This layer defines the location and sizes of drill holes and vias on the board.

6) Solder Flow/Paste: This layer is used to apply solder over exposed copper to prevent it from oxidation and also forms the base for surface mount devices. In a related process called SMOBC (Solder Mask Over Bare Copper), the board is "masked" and only exposed copper (usually pads or areas that have surface mount components) will be coated with solder.

7) Solder Mask: This coating on the top and bottom layers of the PCB, prevents solder from freely flowing on the board. It also insulates the board electrically, and protects the board from the environment. This layer provides the characteristic green color in most PCB boards.

8) Silkscreen: This is the documentation layer containing component references, pin numbers and PCB details like lot number, manufacturer logo etc.

2.2 Surface Mount Technology

Electronic components are available in various packages based on size constraints, cost and technological need. More often the same IC is available in different package types. There are two prominent technologies in PCB component packaging; namely 1) Thru Hole Mount (THM) and 2) Surface Mount Technology (SMT). In Thru Hole Mount, components contain pins that go through the PCB and are soldered on the bottom side of the board. Since the component pins must be mechanically strong to hold the chip firmly there is a limit on how small THM components can be made. One of the most common THM package types is the DIP (Dual-In-Line) package. Surface Mount components on the other hand are soldered on the surface of the PCB. They are many times smaller than THM components, reducing package size by 50%-60%. Surface mount devices have existed since 1950's, when they were better known as flat-pack devices. [15]. They were limited to specific military applications primarily because of high costs. Over the years manufacturers have tried to reduce the cost of surface mount devices relative to thru hole mount devices. Usage of

surface mount devices was more of a choice for PCB designers. But now, with the advent of high speed ICs, constraints to meet international laws on EMI/EMC (Electromagnetic Interference/Electromagnetic Compatability), surface mount devices are now a necessity. Apart from the apparent advantage of size, surface mount devices have lower parasitic inductance and capacitance. Packages having pin count greater than 84 must be fine pitch (distance between pins $\leq 0.5\text{mm}$). The benefits of SMT are listed below

- 1) Surface mount devices provide savings in weight and real estate.
- 2) Due to shorter leads, they have lower parasitic inductance and capacitance.
- 3) They provide improved resistance to shock and vibration due to lower mass.
- 4) Surface mount technology can reduce manufacturing costs, due to reduced board costs and reduced material handling cost.

Figures 2.2, 2.3 [15] provides a graphically comparison between SMT and THM devices.

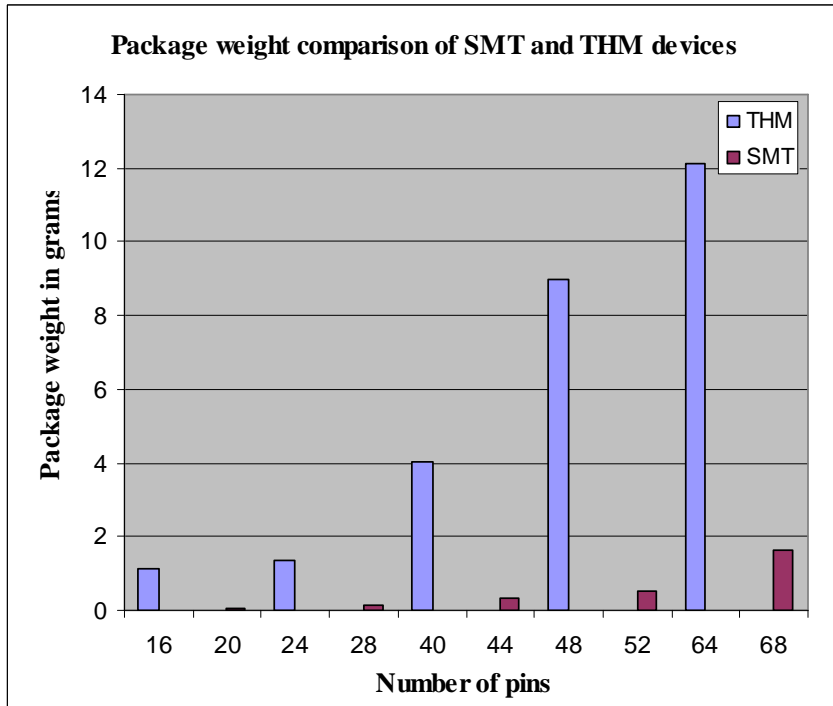


Figure 2.2 Package weight comparison of surface mount devices (chip carriers) with THM devices

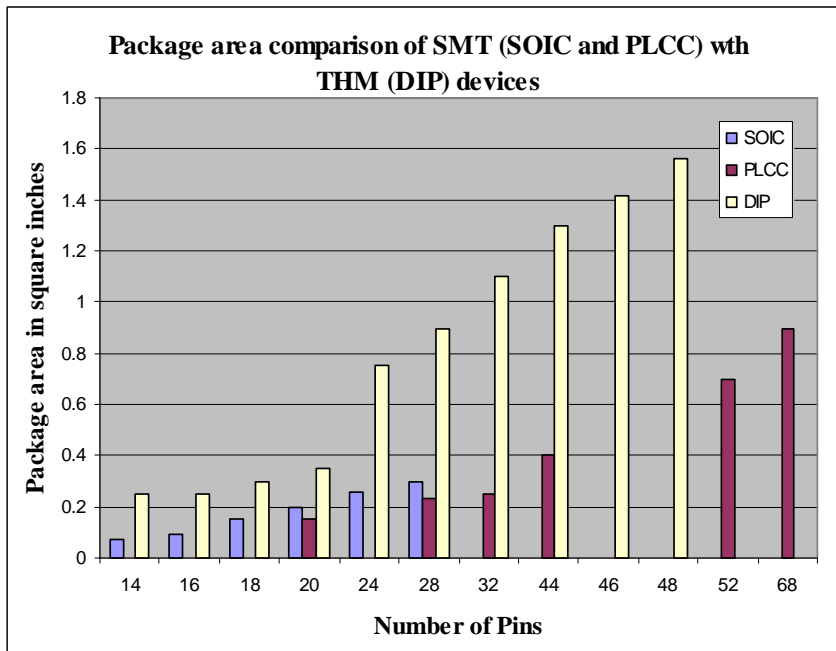


Figure 2.3 Comparison of package area with THM (DIP) and surface mount devices (SOIC, PLCC)

SMT though necessary in certain PCB designs, have a few demerits.

1) Due to the small size, SMT requires machines to handle and place components for PCB assembly (This is the process of placing and soldering components on a fabricated PCB). Although the surface mount device might cost as much as thru hole mount device, the cost of fabricating and assembling a PCB using SMT devices is much higher.

2) Though hand soldering of surface mount devices is possible, some fine pitch devices can only be soldered using wave or reflow soldering (mechanized soldering processes).

3) Since surface mount devices are placed in contact with the printed circuit board, they require careful selection of PCB core materials to match the thermal coefficient of expansion of the SMT device. For example ceramic packages cannot be used on the regular fiber glass epoxy PCB core due to disparity in coefficient of thermal expansion of the two materials.

Before dealing with PCB design using surface mount devices, a brief overview of measurement terminologies used in PCB design is presented. “Mil” is the commonly used measurement unit ($1\text{mil} = 1/1000^{\text{th}}$ of an inch) [13]. Pitch is defined as the spacing between pins in a component package. When the pitch is greater than 20mils, it is referred to in mils. Else it is referred to in mm. This is a standard set by international standard setting organizations such as Electronics Industries Association (EIA) and EIAJ (EIA Japan) [15]. 1 mil is also referred to as 1 “thou”. This term is frequently used in defining trace widths and spacing. Surface mount resistors and capacitors are also

defined in mils/inches. 0603 (0.060 inch or 60 mils long and 30 mils wide), 0402 (40 mil long and 20 mils wide) are the most frequently specified surface mount capacitor and resistor dimensions.

Surface mount assembly may be classified into three types

1) Type I: Contains only surface mount components on both the top and bottom layers of the PCB.

2) Type III: Surface mount devices are present only in the bottom layer of the PCB. Thru Hole components are used in the top layer.

3) Type II: Is a mixture of Type I and Type III. The top layer contains a combination of thru hole mount and surface mount components while the bottom layer contains only surface mount devices. Figure 2.4 shows the three types of surface mount assemblies. [15]

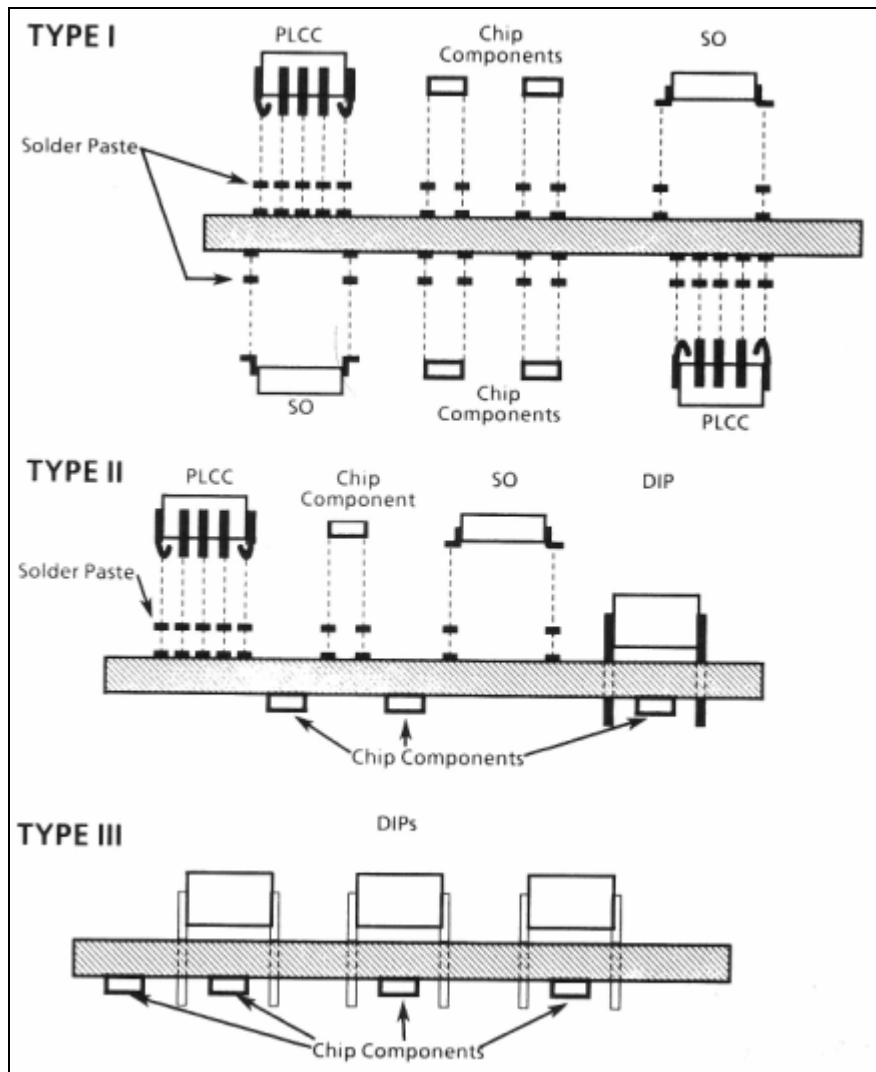


Figure 2.4 Three types of surface mount assemblies in SMT

Surface mount devices are available in numerous packages for the same pin count and component functionality. Selection of the right package depends on the PCB application, space constraints and cost. “Footprint” is the land pattern required by a component on the PCB board. Designing an accurate footprint is one of most important steps in the PCB design process. An incorrect footprint can cause the whole PCB design

to fail. Hence it is imperative to have a good understanding of most surface mount packages and their footprint designs. Frequently used SMT packages are listed below:

1) Resistors and Capacitors: Packages are defined by their dimensions: 0402 (40 mils long and 30 mils wide), 0603, 0805, 1206, 1210, 2010, 2512.

2) MELF (Metal Electrode Leadless Face): used for resistors, jumpers, ceramic capacitors, tantalum capacitors and diodes. They are cylindrical and have metal caps for soldering.

3) SOT (Small Outline Transistor): Used for 3 pin devices like transistors, MOSFETs etc

4) SOIC (Small Outline IC), SOJ (Small Outline J-leaded): They have 50 mil pitch and are generally used for pin count less than 20.

5) PLCC (Plastic Leaded Chip Carrier): These packages also have 50 mil pitch and are used when the pin count is between 20-84.

6) QFP (Quad Flat Pack): These packages are used when the pin count exceeds 84 and have a pitch less than 0.5mm.

7) BGA (Ball Grid Array): In contrast to the above packages, BGA has an array of steel balls underneath the package. They have ball pitches of 40, 50 and 60 mils. This facilitates better trace routing on the PCB. BGA has wide range of pin counts (16-2400).

2.3 High Speed PCB Design

The term “high speed” can be misleading into believing that circuits with high clock frequency are high speed. It is the rise/fall time of a driving device that determines whether a circuit design can be termed high speed or not. Figure 2.5 shows signal integrity effects for a trace driven by two drivers with different rise/fall times. [16]. Apart from signal integrity, modern PCBs are also required to comply with rules on EMI/EMC. Selection of number of layers, component placement and trace length are important parameters in PCB design. A related field known as “signal integrity analysis” subsumes transmission line effects, crosstalk and power/ground noise. In this section a theoretical overview of transmission lines effects, EMI/EMC considerations and use of decoupling capacitors is presented. Looking ahead, few of the output drivers on TMS320F280X series have a minimum rise/fall time of 2ns. Hence a review of transmission lines is pertinent to this discussion.

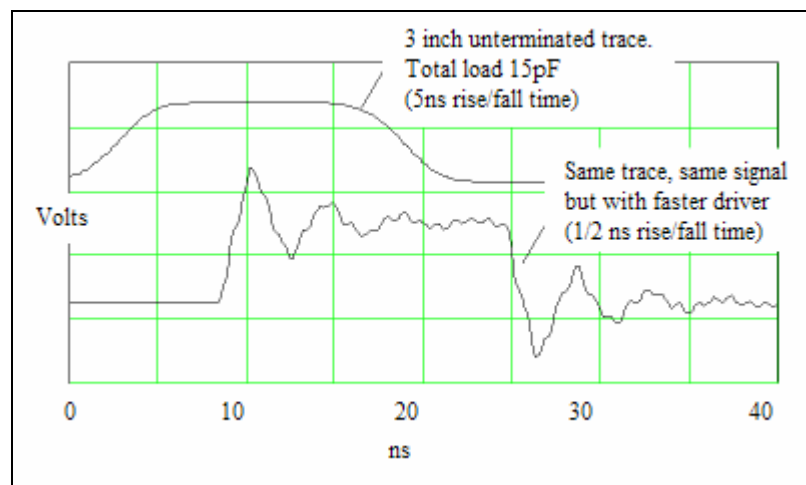


Figure 2.5 Comparison of signal output at load with two drivers with different rise/fall times

2.3.1 Transmission Line Analysis of PCBs

A transmission line may be defined as any pair of conductors that is used to guide energy in the form of an electromagnetic field from one place to another [18].

Electromagnetic field as the name suggests has two components, an electric and magnetic field, the two fields being at right angles to each other. The voltage difference between the transmission line trace and the surrounding planes is a measure of the strength of the electric field. The magnitude of current flowing in a transmission line is a measure of the strength of the magnetic field. Hence a PCB can be seen as flow of electromagnetic fields from point to point. Ensuring that this electromagnetic field does not exit the board and interfere with external devices is the topic of discussion on EMI.

Electromagnetic waves travel at the speed of light (3×10^8 m/s). Manipulating the units, it turns out that an electromagnetic wave travels 12 inches or 30cm of vacuum in one nanosecond. The distance reduces when traveling in a dielectric medium as in a PCB. The reduction factor is represented by the following equation

$$v = \frac{c}{\sqrt{\epsilon_r}} \quad (2.1)$$

where v is the velocity of EM wave in the dielectric medium

c is the velocity of light.

ϵ_r is the dielectric constant of the insulating medium.

FR-4 which is the commonly used core in PCB has a dielectric constant of 4.1. Hence using the above expression, the velocity ' v ' is halved while traveling in a PCB. This means that an electromagnetic wave requires one nanosecond to travel 6'' or 15cm

of a PCB trace (i.e 2ns/ft). This math is significant when devices operate faster with smaller rise/fall times. When the time required by an electromagnetic wave to travel a PCB trace exceeds the rise/fall time of the driving device, “reflection effects” become prominent. An example of a waveform with reflection was shown earlier in figure 2.5.

So far the time taken for an electromagnetic wave to travel in a trace was considered. This delay will be referred to as the propagation delay T_{PD} . Another parameter important in transmission line analysis is the characteristic impedance Z_0 . It is defined as the ratio of voltage to current in the circuit and hence determines the current and voltage waveforms of the source and receiving devices. The key point here is that reflection always occurs whenever there is an impedance mismatch between the output source driver and the transmission line impedance or a mismatch between the transmission line impedance and the load impedance. But it is the propagation delay T_{PD} that determines whether a signal will be degraded due to reflection. The following expression [17] is used to determine if transmission line effects must be considered for a PCB trace.

$$2 \times T_{PD} \times \text{trace length} > T_R \text{ or } T_F \text{ (minimum of the two)} \quad (2.2)$$

Based on the above expression, for a device with a rise/fall time of 2ns, the trace length above which transmission line effects take effect is 6”.(assuming $T_{PD} = 2\text{ns/ft}$).

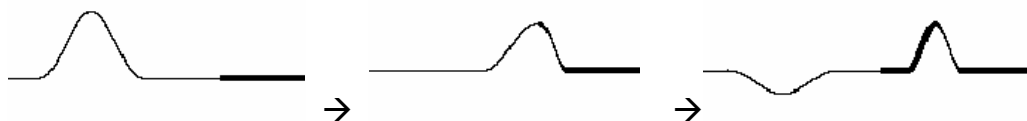


Figure 2.6 Wave moving from lower impedance medium to higher impedance

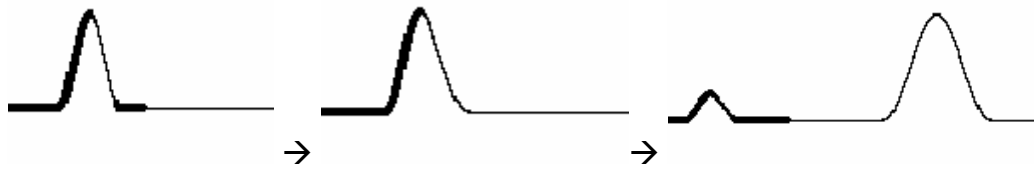


Figure 2.7 Wave moving from higher impedance medium to lower impedance

The concept of “reflection” may be explained with the above two figures (Figure 2.6 and Figure 2.7). When a transverse traveling wave encounters a change in density of medium (equivalent to change in impedance), it undergoes reflection. The amount of reflection is determined by the following relation

$$\text{Reflection \%} = 100 \frac{Z_l - Z_o}{Z_l + Z_o} \quad (2.3)$$

where Z_l is the load impedance or downstream impedance and Z_o is the output or upstream impedance . When the downstream impedance is greater than the upstream impedance ($Z_l > Z_o$), the reflection wave adds to the incident wave. This causes the overshoot as seen in figure 2.5. From equation (2.3), we notice that ensuring $Z_l = Z_o$ can eliminate reflection. This is primarily the principle behind using termination resistors. Lattice diagram and Bergeron plot are two methods used to analyze reflection in devices. The former method has been used in this thesis since it is more favorable to programming. It requires values of the rise and fall times of the driving device, the output impedance of the source driver, transmission line impedance and input impedance of the load. Before looking into details of this method, a review on the different types of transmission lines in a PCB and the lumped approximation of a transmission line is presented.

Microstrip and Stripline are the two kinds of transmission lines used in PCB. Microstrip consists of a transmission line traveling over a plane with only one plane as a partner. Stripline has a transmission line along with two planes as partners. Fig 2.8, 2.9, 2.10 and 2.11 illustrates the two types.



Figure 2.8 Surface Microstrip



Figure 2.9 Embedded Microstrip



Figure 2.10 Stripline



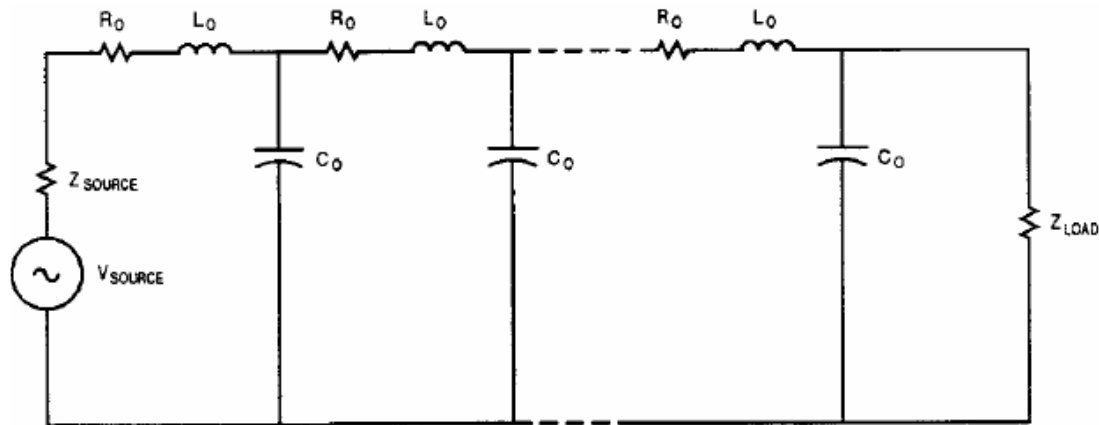
Figure 2.11 Dual Stripline

A transmission line contains inductance, resistance and capacitance effects distributed in it. One method of accounting for these effects is the lumped parameter model. Figure 2.12 depicts this model using the intrinsic capacitance, resistance and inductance of a PCB trace [17]. The characteristic impedance and propagation delay can be calculated with knowledge of these intrinsic parameters.

$$Z_o = \sqrt{\frac{L_o}{C_o}} + R_o \ \Omega \quad (2.4)$$

$$T_{PD} = \sqrt{L_o C_o} \text{ ns/length} \quad (2.5)$$

The intrinsic resistance R_o is small compared to the other two parameters and may be neglected in equation (2.4). The intrinsic inductance and capacitance are functions of the geometry of the transmission line.



- V_{SOURCE} = Switching Voltage Supply
- Z_{SOURCE} = Output Impedance of Voltage supply
- R_o = Intrinsic resistance of transmission line
- L_o = Intrinsic inductance of transmission
- C_o = Intrinsic capacitance of transmission line
- Z_{LOAD} = Load impedance

Figure 2.12 Lumped approximation of a transmission line

2.3.2 Lattice diagram method for transmission line analysis

This method uses equation (2.3) to calculate the voltage levels at the source and load side with reflections adding/subtracting the initial voltage waveform. For easier understanding, equation (2.3) may be split into two equations, one representing the reflection coefficient at the load side and the other representing the reflection coefficient on the source side

$$\rho_L = \frac{Z_L - Z_o}{Z_L + Z_o} \quad (2.6)$$

$$\rho_S = \frac{Z_D - Z_o}{Z_D + Z_o} \quad (2.7)$$

where ρ_L is load reflection coefficient, ρ_S is the source reflection coefficient, Z_L is the load or receiving device input impedance, Z_D is the driving device's output impedance and Z_o is the characteristic impedance of the transmission line. When $Z_D < Z_o$, reflection is characterized by an overshoot as shown in figure 2.13 (a). On the other hand when $Z_D > Z_o$, stair-stepped voltage can be noticed at the load side as shown in figure 2.13 (b).

In Figure 2.14 (a) the input voltage ΔV_{OUT} arrives “sees” the circuit shown figure 2.14 (b). Note that the input voltage waveform can only view the transmission line impedance at this point and the load impedance is invisible to it. This is because the load is separated by the propagation delay of the transmission line. At point A, the input voltage splits based on the voltage divider rule and a voltage.

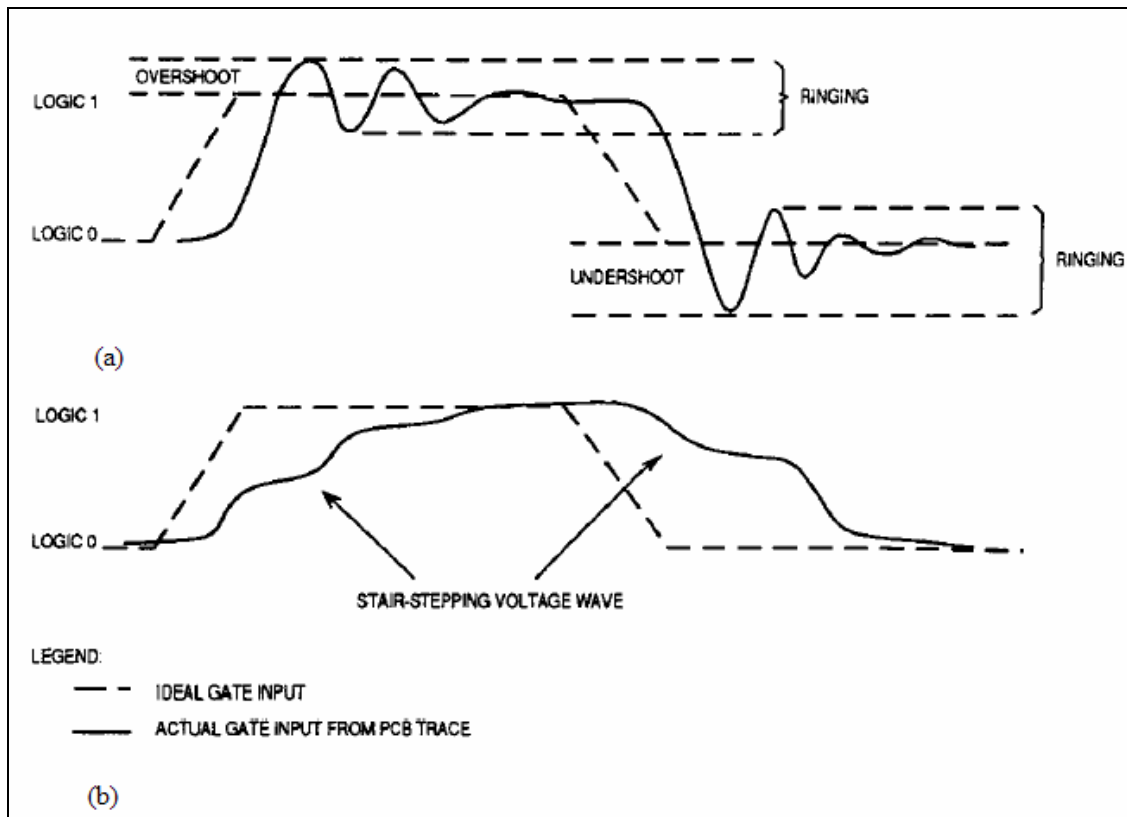
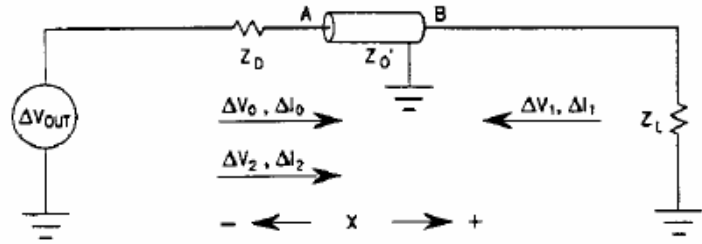


Figure 2.13 Transmission line effects

The voltage ΔV_O travels down the transmission line. At the end of the transmission line the voltage waveform ΔV_O sees circuit in figure 2.14 (c). Based on the value of reflection coefficient ρ_L , the reflected wave adds or subtracts from ΔV_O . One of the methods of eliminating reflection is to make $\rho_L = 0$ by ensuring $Z_L = Z_0$. As will be seen later, this method of termination is known as parallel termination. The reflected wave now travels down the transmission line and sees the circuit shown in figure 2.14 (d). The voltage waveform undergoes reflection based on the reflection coefficient ρ_S . Here again if ρ_S can be set to zero, reflection can be avoided. This method of termination is known as series termination. More on termination will be

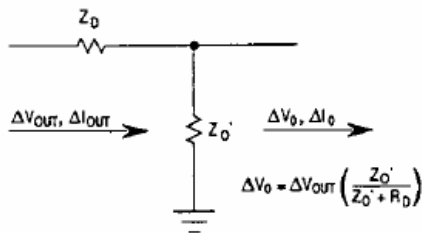
presented later in this section. Figure 2.15 provides a graphical representation of the lattice method.[17]



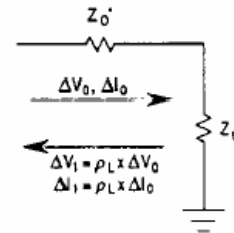
- ΔV_{OUT} = VOLTAGE SOURCE, V_{OH} AND V_{OL}
- Z_D = OUTPUT IMPEDANCE OF DRIVING DEVICE
- Z_L = LOAD IMPEDANCE
- ΔV_0 = INCIDENT VOLTAGE
- ΔI_0 = INCIDENT CURRENT
- A = DRIVING END OF TRACE
- B = RECEIVING END OF TRACE
- Z_O' = LOADED CHARACTERISTIC IMPEDANCE
- ΔV_1 = REFLECTED VOLTAGE AT LOAD
- ΔV_2 = REFLECTED VOLTAGE AT DRIVING DEVICE
- ΔI_1 = REFLECTED CURRENT AT LOAD
- ΔI_2 = REFLECTED CURRENT AT DRIVING DEVICE

(a) Transmission Line Representation with Z_O' and Load Resistance

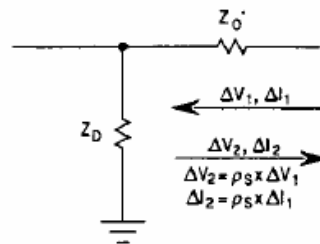
Figure 2.14 Simplified representation of transmission line



(b) Voltage Divider and Incident Wave at Driving Device



(c) Incident Wave and Reflected Wave at Receiving Device



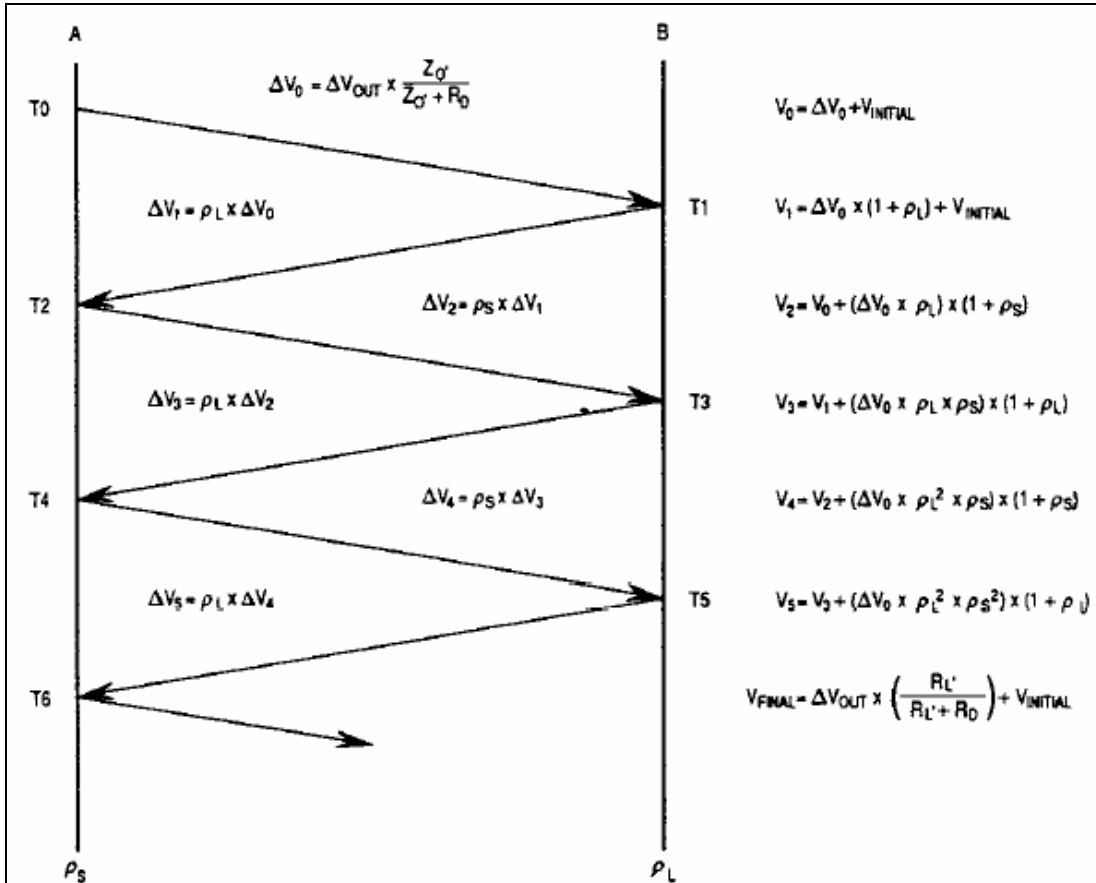
(d) Reflected Wave at Source

Figure 2.15 Analysis of incident and reflected wave

An important factor that needs to be considered in transmission line effects, is the effect of capacitive loading. It alters the propagation delay and characteristic impedance in the following manner

$$T_{PD'} = T_{PD} \sqrt{1 + \frac{C_D}{C_O}} \text{ ns/length} \quad (2.8)$$

$$Z_{O'} = \frac{Z_O}{\sqrt{1 + \frac{C_D}{C_O}}} \Omega \quad (2.9)$$



Note: ρ_L and ρ_S are the reflection coefficients and $V_{INITIAL}$ is the steady state voltage prior to switching of the gate. Each TD is a propagation delay (TPD) in duration. A and B represent the driving and receiving ends of the trace respectively.

Figure 2.16 Lattice diagram

where C_D is the distributed capacitance of the receiving devices. Hence adding a socket or connecting a single trace to multiple devices can affect the propagation delay and characteristic impedance. Intuitively, capacitive loading might be considered a positive outcome since it delays and slows the rise/fall time. But a closer look into the above equations (2.8) and (2.9) we find that the propagation delay increases where as the characteristic impedance decreases. Reduction in characteristic impedance results in ringing or stair stepped response while increased propagation delay only enhances transmission line effects.

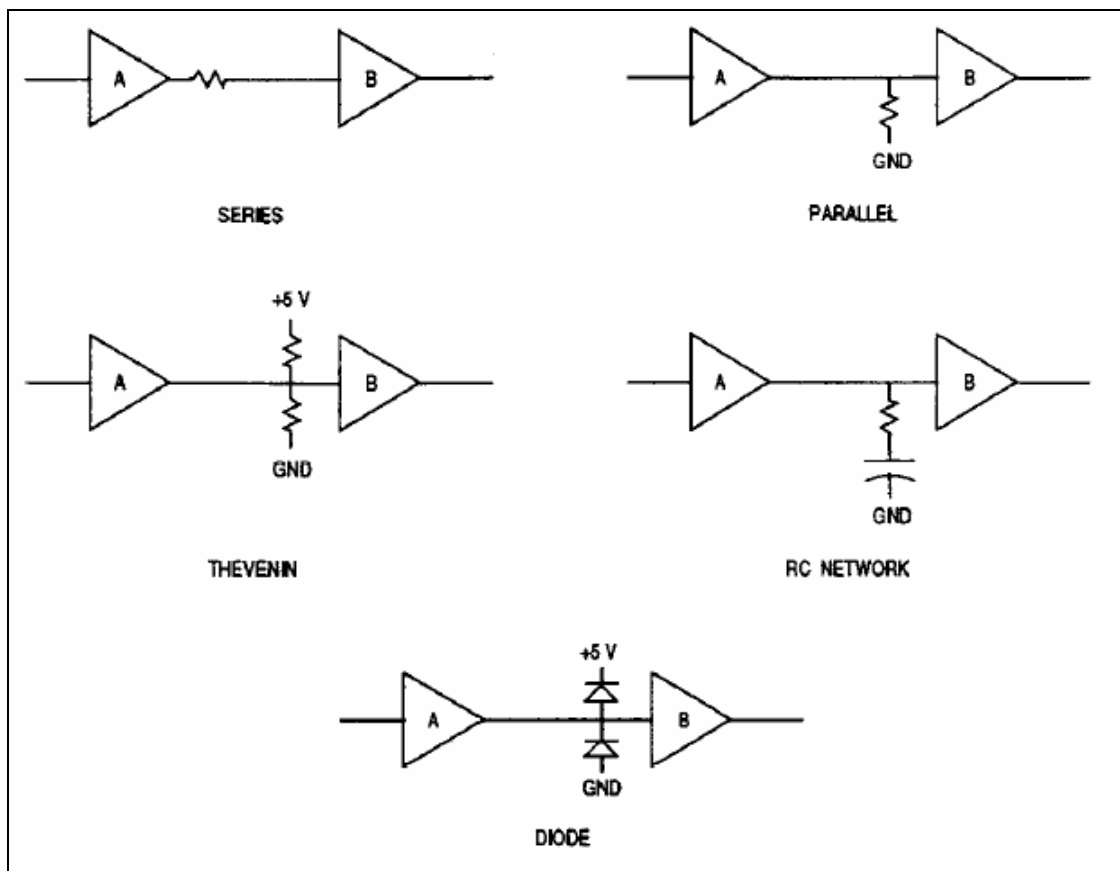
2.3.3 *How to avoid reflections?*

As mentioned earlier, reflections may be mitigated by manipulating the circuit such that the reflection coefficient (ρ_L or ρ_S) is set to close to zero. This is the basis for adding terminations to a transmission line. The five commonly used terminations are

- 1) Series termination resistor
- 2) Parallel termination resistor
- 3) Thevenin network
- 4) RC Network
- 5) Diode Network

1) Series Termination Resistor: With this solution, a resistor whose value is equal to $Z_o' - Z_D$ is placed very close to the driving devices output.(figure 2.17) With this series resistance added, the source voltage ΔV_{OUT} , is halved at point A (figure 2.14 (b)) by the voltage divider network such that $\Delta V_O = 0.5 \Delta V_{OUT}$. When the voltage waveform ΔV_O

arrives at B (figure 2.14(c)), it doubles due to reflection at the load side. When this reflected wave travels down the transmission line to the source (figure 2.14 (d)), it is does not undergo any more reflection due to impedance matching at the source ($Z'_O = Z_D + Z_S, \rho_S = 0$). Hence the voltage waveform settles down as shown in figure 2.17.[18]



- Note 1) A - driving device : B – receiving device
 2) Termination near A must very close to the driving devices output and B should be at the receiving devices input.

Figure 2.17 Types of termination

Note that it is necessary for the source impedance to be less than the transmission line impedance for this solution to be effective. In figure 2.18 it is seen

that the voltage waveform at the input is stepped being at half the total voltage for a small duration of time (the propagation delay of the transmission line). During this period when the voltage waveform is at a voltage level between 0 and logic 1, no valid information can be transmitted over the line. This reduces the bandwidth of the signal. For example for a device operating at 50MHz (20ns time period, high for 10ns, low for 10ns), a 2ns propagation delay can reduce the bandwidth by 40% ($2\text{ns}/10\text{ns} = 40\%$). Hence series termination is not suited for high clock rate devices.

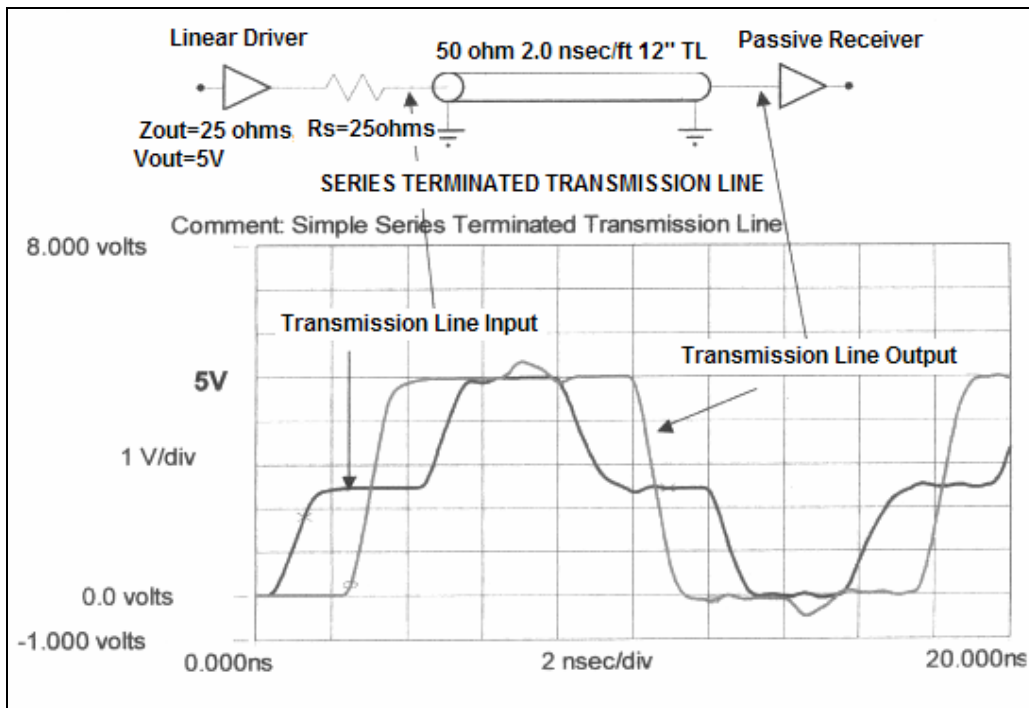


Figure 2.18 Rising and falling edges of 5V CMOS circuit showing effect of series termination

2) Parallel Termination Resistor: In parallel termination a resistor whose value is equal to the transmission line impedance is placed at the load side ($Z_1 = Z_0$). Hence reflection is

avoided since $\rho_L=0$. The input voltage waveform remains stable at its initial value. This implicitly means that the input voltage waveform at point A (figure 2.14 (b)) must be greater than recognizable logic high voltage for the circuit (V_{IH}). Hence output impedance of the input driver Z_D must be much lesser than the transmission line impedance Z_O . Parallel termination resistor values are generally low (equal to the transmission line impedance, 100-150 ohms); more current flows through them and hence more signal power loss.

3) Thevenin Network: As shown in figure 2.19, a Thevenin network can be used to pull up or pull down a voltage level, such that output voltage waveform does not settle at a point between logic and logic low [17]. It is particularly used in TTL families which have an unsymmetrical output. The output impedance when switching from logic high to low is much lower than when switching from logic low to high. Adding a pull-up can provide more current to charge up the line, resulting in an improved rising edge. [18].

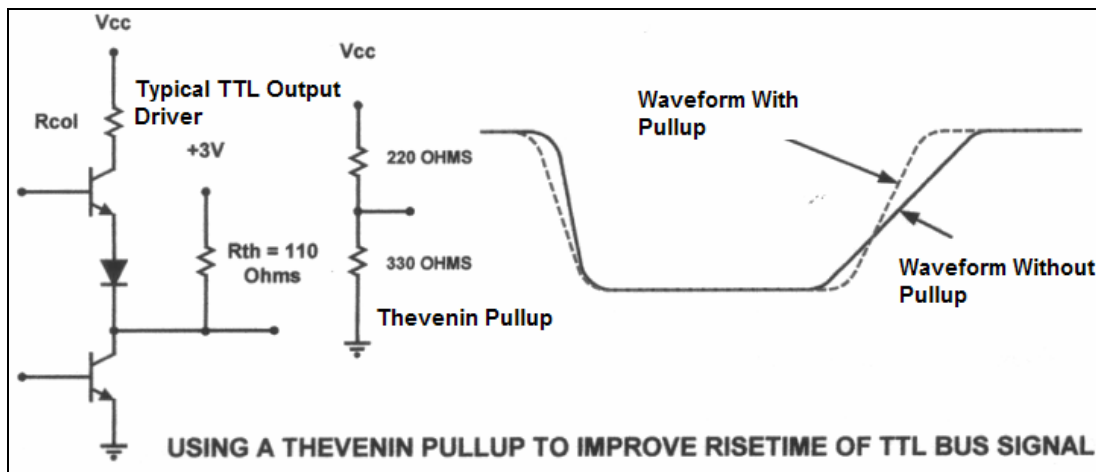


Figure 2.19 A Thevenin Network used as pullup for a TTL bus

4) RC Termination: The objective of this method is to provide termination during when the edges are “switching” and disconnect it when the logic levels are “steady”. [18]. The resistance is chosen to be equal to Z_0 , while the capacitor lies in the range 200-600pF. The RC time constant must be greater than twice the loaded line impedance [17]. The net result is that the RC time constant effectively slows down the signal while it limits the overshoot. This methodology is not a recommended for high clock rates, rather series or parallel termination is preferred [18].

5) Diode Termination: Diodes are generally used to limit the overshoot to approximately 1V. But they need to be extremely fast, to match the switching frequency of the driving device [17]. They do not prevent reflections and only helps to reduce overshoot.

The features of each of the terminations are enumerated in the following table. [17]

Table 2.1 Termination types and their properties

Termination Type	Added Parts	Delay Added	Power Required	Parts Values	Comments
Series	1	Yes	Low	$R_s = Z_0'$ R_d	Good dc noise margin
Parallel	1	Small	High	$R = Z_0'$	Power Consumption is a problem
Thevenin	2	Small	High	$R = 2 \times Z_0'$	High power for CMOS
RC Network	2	Small	Medium	$R = Z_0'$ $C = 300\text{pF}$	Check Bandwidth and added capacitance
Diode	2	Small	Low		Limits undershoot: Some ringing at diodes

Summarizing, terminations provide a solution for reflection. But the best engineering practice is to avoid reflection effects by keeping trace length small such that equation (2.2) is satisfied.

2.3.4 PCB design with EMI/EMC considerations

In the course of this discussion we will find that the techniques used to ensure signal integrity are closely related to “guidelines” for EMI compliance. It is important to understand that software and hardware tools that test a PCB for EMI/EMC compliance is an extensive field and will not be dealt in this thesis.

The cause for Electromagnetic Interference (EMI) can be better understood by analyzing Gauss Law. It states that

$$\oiint D \cdot dA = Q \quad (2.10)$$

where D represents the flux density, dA element of an arbitrary surface and Q is the total charge enclosed. The flux density is the product of electric field E and the permittivity of the medium. Gauss Law states that the surface integral of the dot product of the flux density and the enclosure surface area is equal to the charge enclosed. [19]

This implies that if the total charge enclosed remains constant then so does the field emanating from the system. This is equivalent to an earth ground which is characterized by the fact that no matter how much current is put into it, its potential does not change. For low frequency devices this is easily achievable by connecting the system ground to the earth ground of the power cable. But for high frequency devices, this would not work since the inductance of the cable impedes current flow to the earth

ground. Hence if it is possible to establish a surface over the system such there is no variation in potential, there would be no radiation. This is the basis for having a conductive enclosure over a circuit. The conductive enclosure behaves as a local ground. But for most systems a conductive enclosure is not viable and is generally considered a “band aid” solution for a bad PCB design. A good circuit design can prevent radiations from exiting the system and this is precisely the focus of this discussion.

As mentioned earlier in this thesis, a PCB circuit can be seen as flow of electromagnetic energy from point to point. Under certain circumstance, a part of the energy can amplify and exit the board when flowing through traces with a specific geometry. Keeping this in mind, we consider two modes of signals that usually flow in a PCB. They are 1) differential mode and 2) common mode signals. [20].

Differential mode signal is the one that is always considered in circuit analysis. Current flows from source to a receiver and then returns via ground path to the source. Since the flow of signal and its return path are opposite, they are known as differential mode signals.

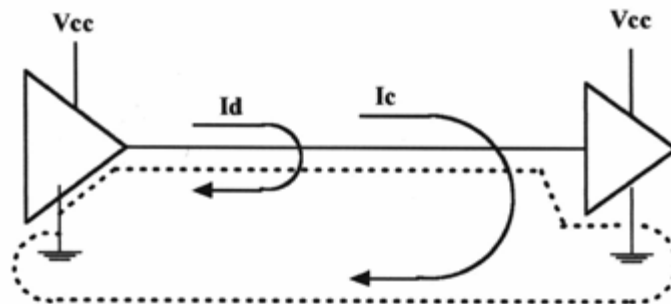


Figure 2.20 Differential and Common mode currents

What is assumed in the above description is that the ground is a perfect conductor and that return current flows in just one path. But more often due to parasitic inductance a voltage divider is formed such that majority of the return current flows in the expected return path (I_d) and a small portion in another unintended path (I_c). This latter current is known as common mode current. This path is unknown and it can potentially create large “loop areas”. Conventionally differential mode currents are represented by two currents traveling in opposite directions, while common mode current is represented by two currents traveling in the same direction as shown in figure 2.21 [20]

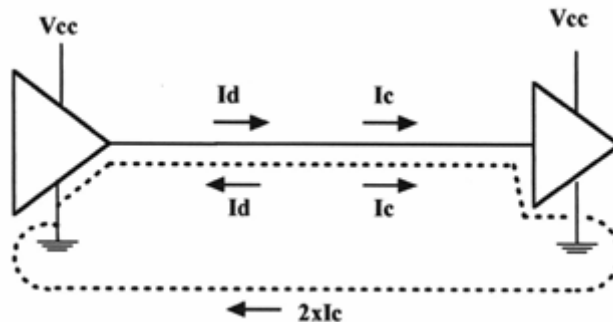


Figure 2.21 Conventional representation of differential and common mode currents

Differential currents if “properly routed” do not cause EMI since the currents flow in opposite direction; their magnetic fields cancel each other. With respect to Gauss law, since the currents cancel each other, the net charge Q remains constant and hence the concept of a local ground is preserved. Common mode currents are

detrimental in PCB design since their magnetic fields do not cancel and they create large loop areas, effectively creating an antenna radiating electromagnetic energy.

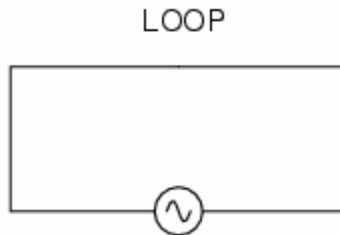


Figure 2.22 Basic antenna design

Low frequency currents return via the least resistance path while high frequency currents return via the least inductance path. [20]. At high frequencies inductance dominates and presents a higher impedance to the high frequency signal. Hence the signal tends to return through the least inductance path. Figure 2.23 and 2.24 shows the return path for low and high frequency currents.

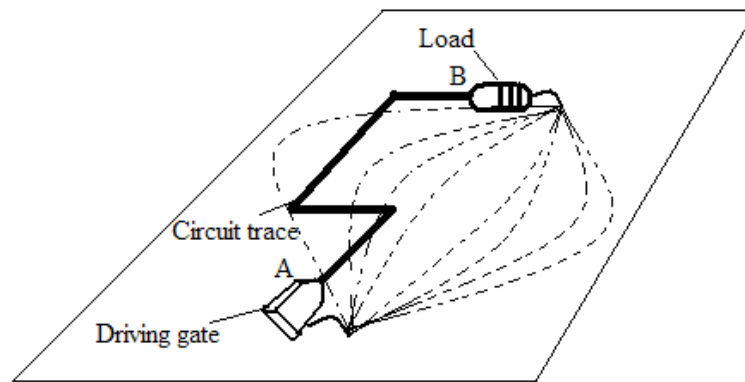


Figure 2.23 At low frequencies current follows path of least resistance

Inductance of single loop coil may be represented by the following equation [19]

$$\frac{(B \times A)}{I} = L \quad (2.11)$$

where B is the magnetic field in the loop, A is the area of the loop and I is the current in the loop. From this expression, we find that the inductance increases as the loop area A increases, the inductance L increases. Figure 2.21 shows a simple representation of antenna.

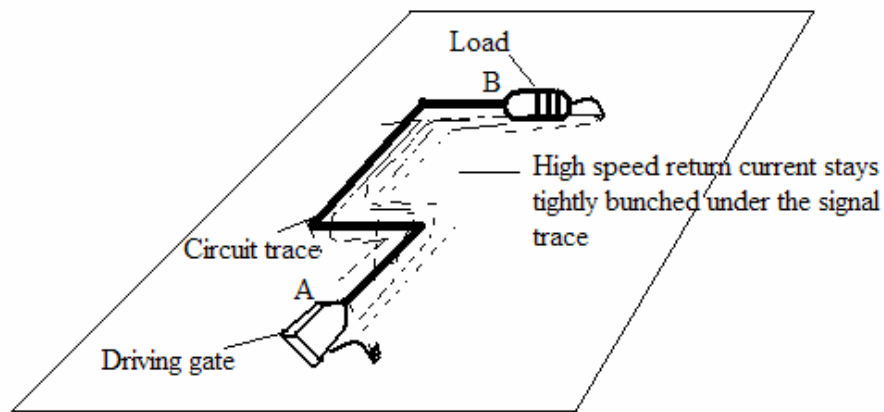


Figure 2.24 At high frequencies current follows the path of least inductance

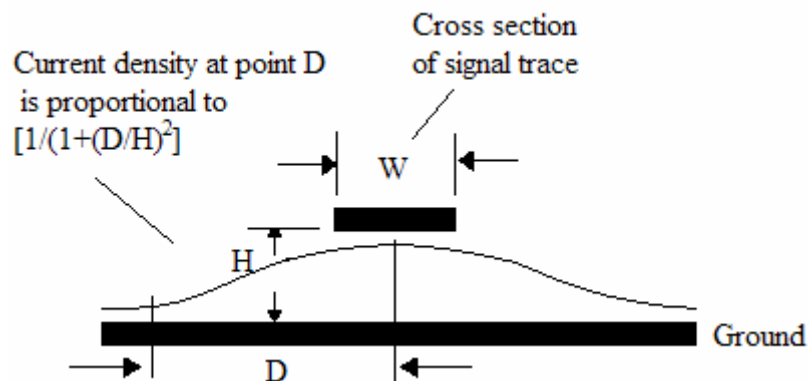


Figure 2.25 Distribution of high frequency current density underneath a signal trace

Traces in a PCB can behave as antennas if they form significantly large “loop areas”. Larger loop areas increases the inductance and hence the gain of the antenna that emits electromagnetic radiation. Moreover as shown in figure 2.25 [21], high frequency currents follow a return path right below the signal, which is the path of least inductance. If there are obstructions or slots in the ground plane, the return current will have to take a longer path, resulting in a larger loop area. This is shown in figure 2.26. Note that this geometry represents the well known “slot antenna”.

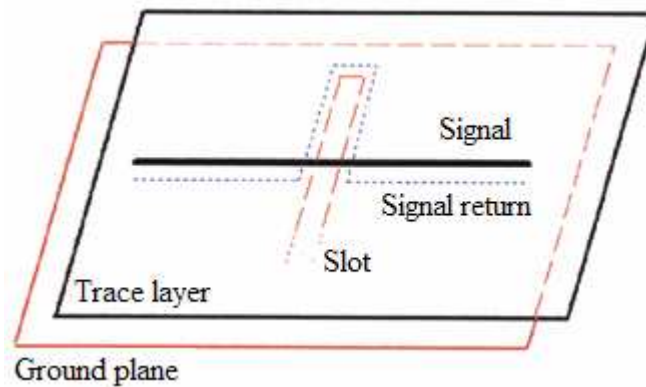


Figure 2.26 Routing a trace over a slot in a plane can cause large loop area

Summarizing, EMI can be reduced with the following:

- 1) High frequency traces must be kept as short as possible (example clock signals),
- 2) Signal traces must be close to a ground plane, to reduce loop area of the signal. Ensuring that only differential signals exists, automatically minimizes or eliminates common mode signals. Best EMI reduction can be achieved by having every signal layer associated with a ground layer beneath it.

3) The ground plane must be solid without too many discontinuities due to vias.

4) All sources of parasitic inductance must be minimized. (example sockets, leads of components etc).

The other factors key to a good PCB design are listed below

1) Board layer selection

2) Component placement

3) Decoupling capacitor

2.3.4.1 Board Layer Selection:

Selection of the number of layers for a PCB depends on a number of factors like

a) Complexity of schematic: The number of nets or connections in the circuit and the number of components.

b) Type of components: Surface mount devices, especially fine pitch devices have high density of pins and hence it becomes nearly impossible to route them on a 2 layer board.

c) Trace width: If the circuit requires high currents, trace widths must be wider, hence occupying more space on the board.

d) Real estate constraint: This is generally considered the prime motive for layer selection. It is possible to reduce the size of the board by increasing the number of layers. But higher number of layers cost more. At times to reduce cost, one might consider reducing the number of layers and increase the board size. This might not be

prudent for high speed designs that have constraints on trace length. More number of layers provides the extra degree of freedom in routing, allowing components to be placed closer and hence shorter trace lengths. Figure 2.27 shows trace length comparison between a 4 and 6 layer PCB.

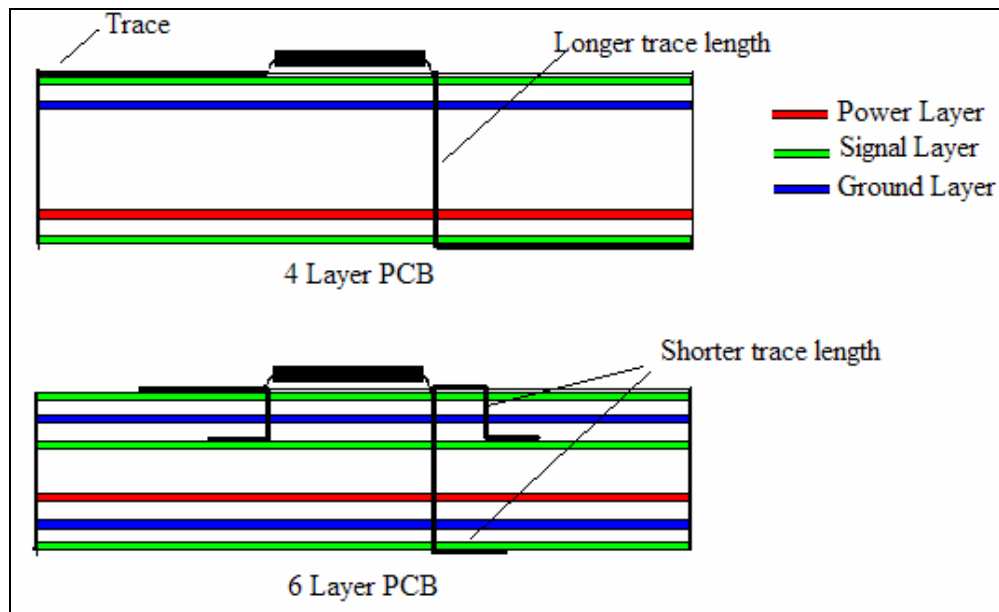


Figure 2.27 Comparison of trace length with number of layers in a PCB

e) Cost: Since higher number of layers provides extra latitude in routing and also better EMI suppression, one might be tempted to use it more frequently. But they cost much more than boards with lesser layers and hence must be considered in the design stage.

Figure 2.28 and 2.29 [22] depicts the commonly used PCB layer stack up.

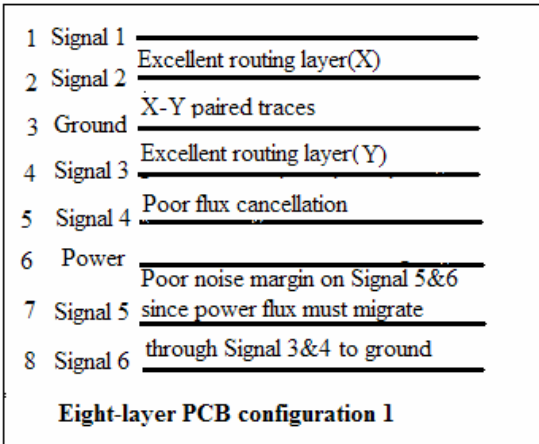
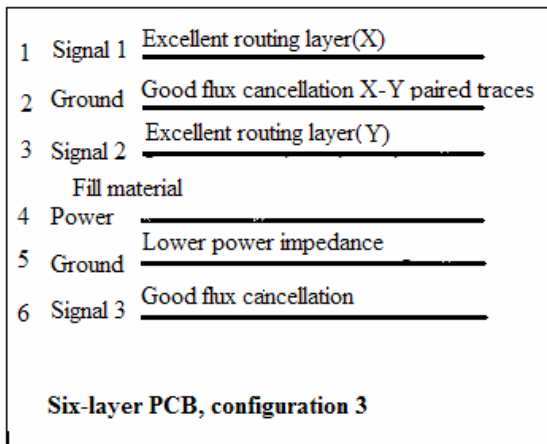
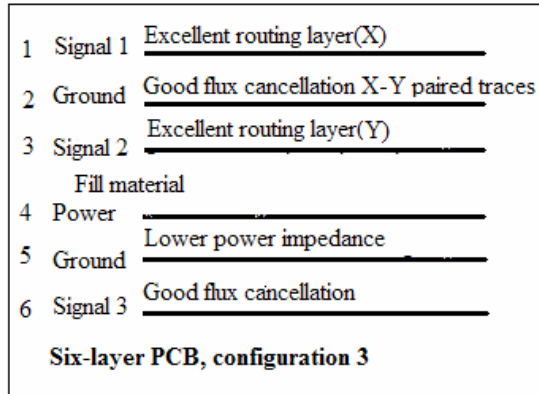
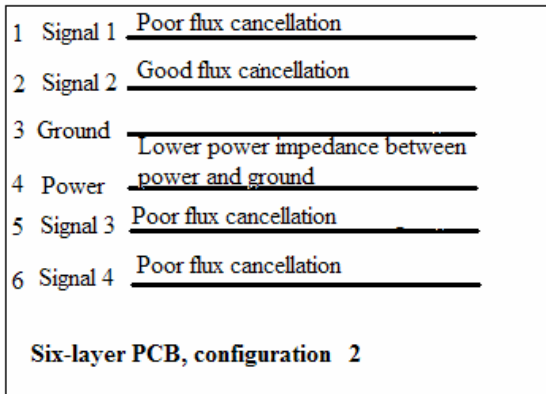
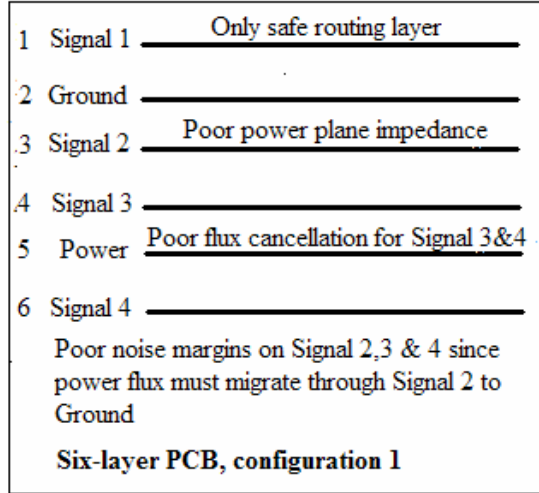
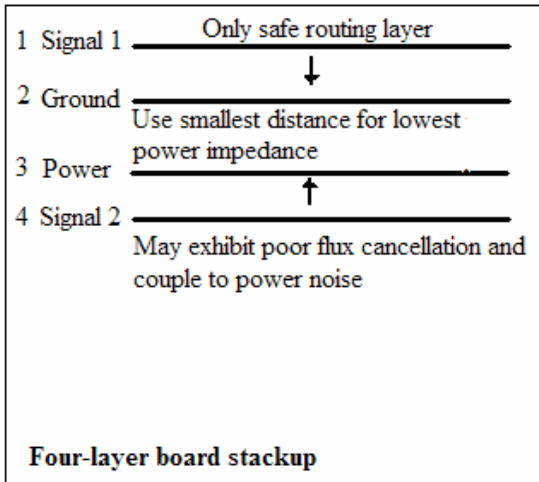


Figure 2.28 PCB layer stackup 1

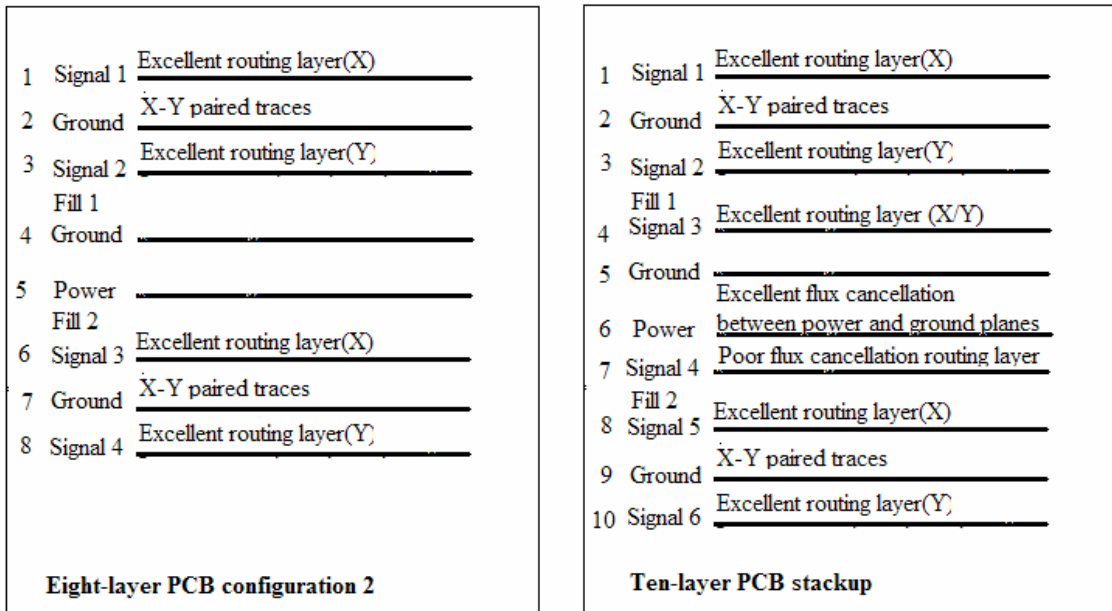


Figure 2.29 PCB layer stackup 2

2.3.4.2 Component Placement:

Optimal placement of components is one of the most important steps in PCB design. In the section on EMI considerations, emphasis was placed on having small loop currents. This can be achieved by placing functionally related components together. When placing components the length of traces must be estimated in high speed design. If the traces exceed the maximum permissible length to prevent transmission line effects, then termination resistor values must be calculated and updated in the schematic.

If the circuit has analog and digital circuitry, it is necessary to functionally separate the two modules. A separate analog and digital ground is not necessary. [23]. Since the return signal generally follows the path beneath the trace, the analog and digital sections are partitioned such that none of the signals cross each other. Hence

good routing discipline can prevent contamination of analog and digital signals with a single ground plane. Figure 2.31 shows the comparison between split and single ground planes [23]

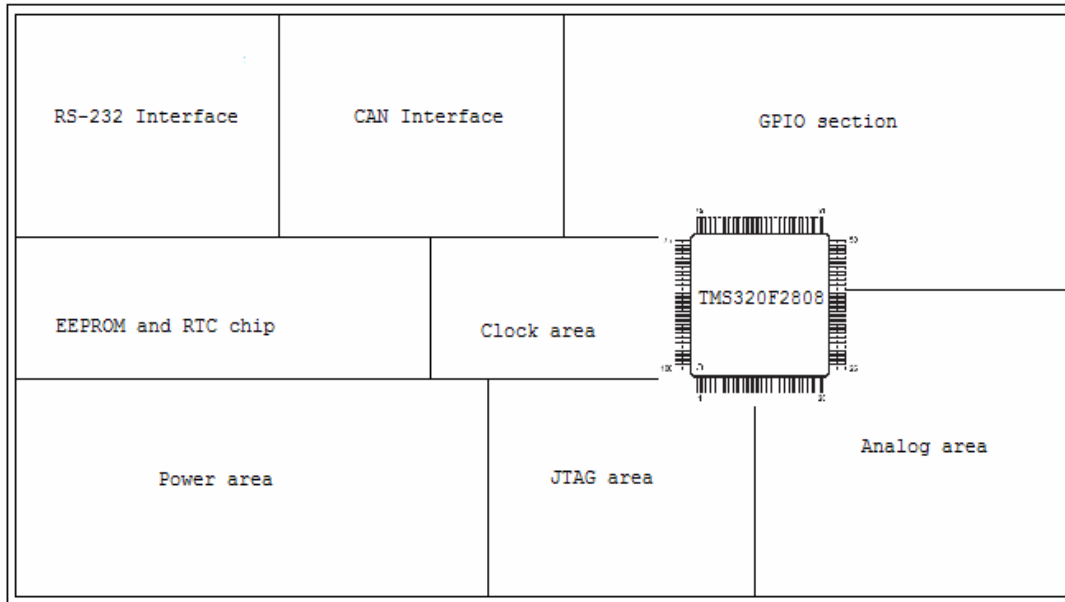


Figure 2.30 Functional distribution of the custom DSP board

2.3.4.3 Bypass Capacitor Selection and Placement

The term “bypass” may be defined as “a means of circumvention or to avoid (an obstacle) by using an alternative channel, passage or route”. [24]. While the term “decouple” may be defined as “to reduce or eliminate the coupling of (one circuit part from another)”. A capacitor plays the above two roles in PCB design.

Definition of a bypass capacitor – A bypass capacitor stores an electrical charge that is released to the power line whenever transient voltage spike occurs. It provides a low-impedance supply, thereby minimizing the noise generated by the switching outputs of the device. [25].

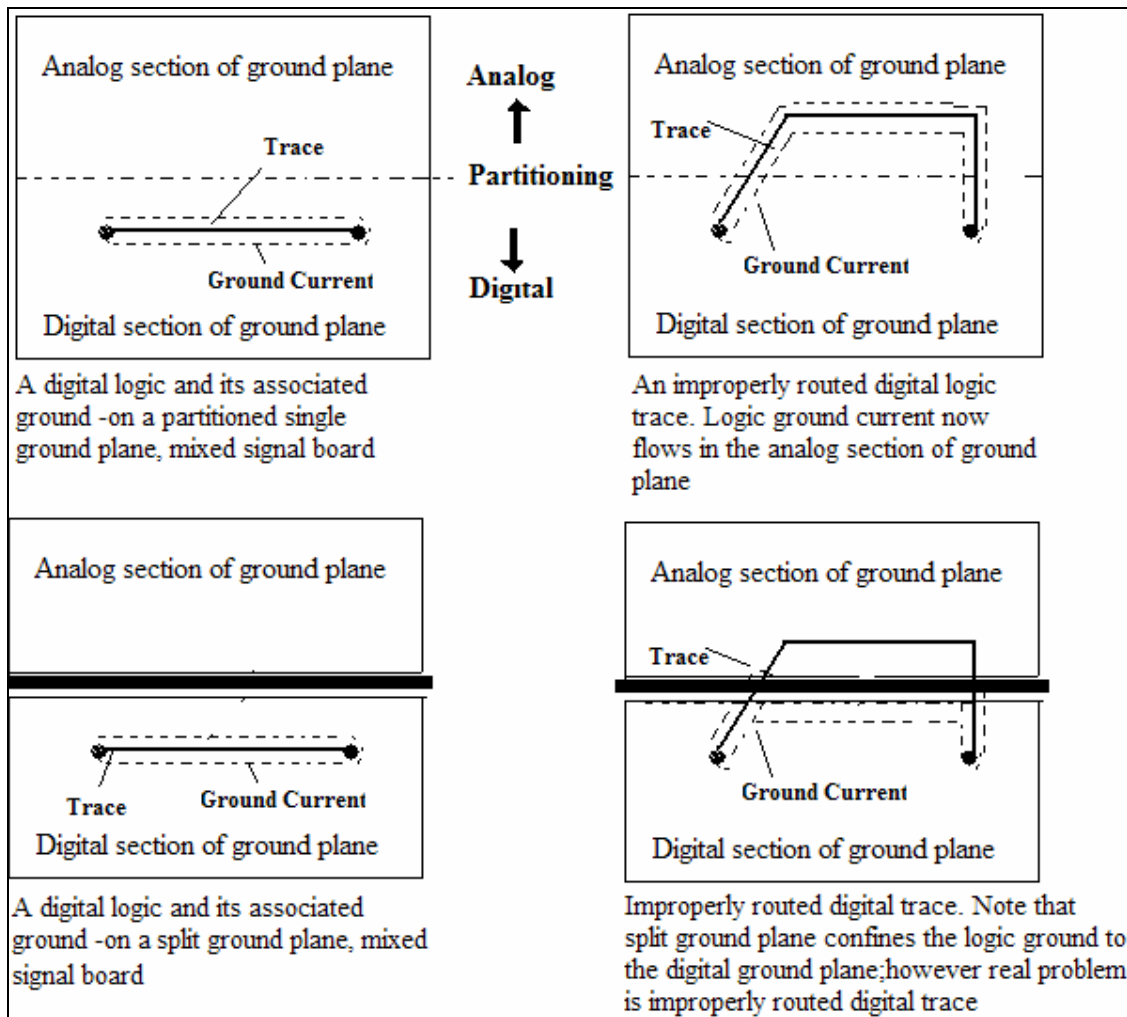


Figure 2.31 Trace and ground current on split and single ground planes

A decoupling capacitor is defined as one that “removes RF energy generated on the power planes by high frequency components. Decoupling capacitors also provide a localized source of dc power for devices or components, and are particularly useful in reducing peak current surges propagated across the board”[25].

In short bypass/decoupling capacitors 1) reduce high frequency components in the signal due to fast switching logic by shunting them to ground.

2) Prevents fluctuation of the power (Vcc) pin by acting as a low impedance voltage source.

Since the same capacitor can provide both the above features, the term bypass and decoupling has been used interchangeably. For this discussion the term decoupling capacitor will be used.

2.3.4.4 High frequency behavior of Decoupling Capacitor

The equivalent circuit of a decoupling capacitor is illustrated in figure 2.32 [18]

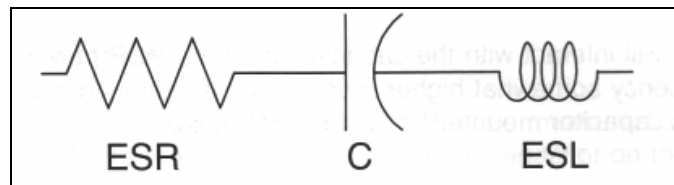


Figure 2.32 Equivalent circuit of decoupling capacitor

The effective impedance of the above circuit is given by the expression

$$Z = \sqrt{R_s^2 + (X_L - X_C)^2} \quad (2.12)$$

where R_s is the Equivalent Series Resistance (ESR)

X_L is the impedance of Equivalent Series Inductance (ESL) = $2\pi fL$

X_C is impedance of the capacitor $C = 1/2\pi fC$

For this series equivalent circuit, the impedance keeps decreasing from DC (0 Hz) till the series resonant frequency when $X_L = X_C$. At this frequency the impedance

offered by the capacitor is the least and is equal to R_s . Figure 2.33 illustrates this behavior.

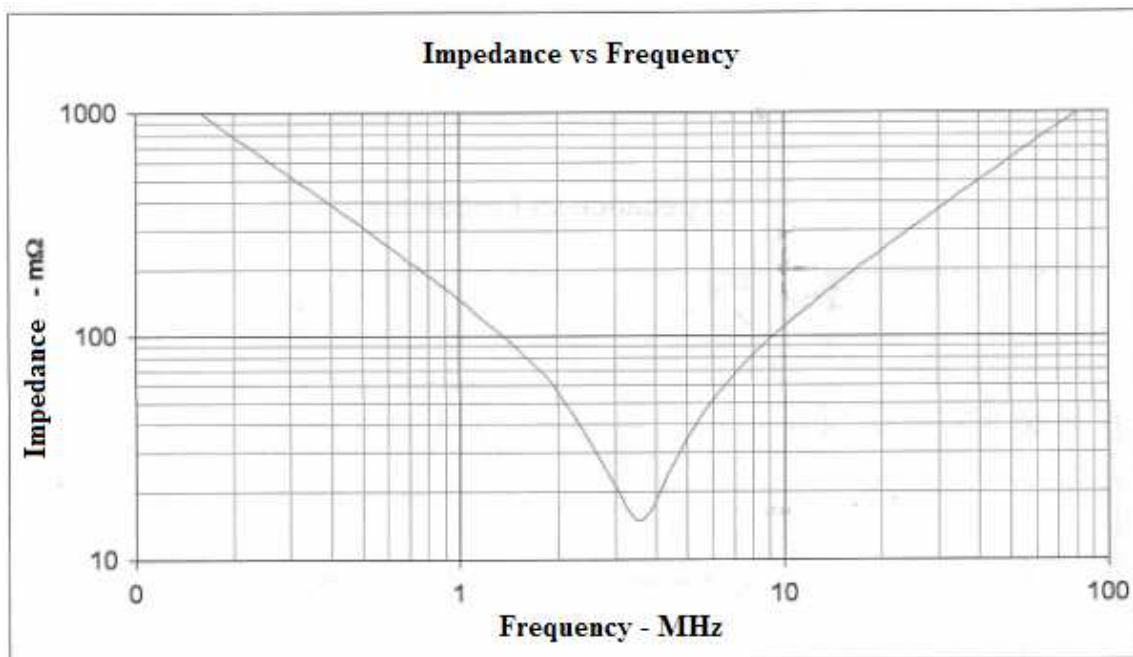


Figure 2.33 0603 ceramic capacitor impedance vs frequency ($C=1\mu\text{F}$, $\text{ESR}=12\text{m}\Omega$, $\text{ERL}=2\text{nH}$)

Hence as seen in figure 2.33, above the self resonant frequency, the inductive behavior of the decoupling capacitor dominates and prevents shunting of high frequency noise.

High speed logic families like “ACT or F” have fast rising edges (0.8-2ns) and hence have higher RF spectrum [C11]. Figure 2.34 provides a comparison of series resonant frequencies of different valued capacitors and their spectrum range. The leads of a capacitor are the major contributor to the inductance. Higher inductance reduces the series resonant frequency. Axial and radial capacitors have significantly large lead inductances. Hence surface mount capacitors are recommended for high speed

applications. Table 2.2 provides a comparison of series resonant frequencies of thru hole mount and surface mount capacitors.

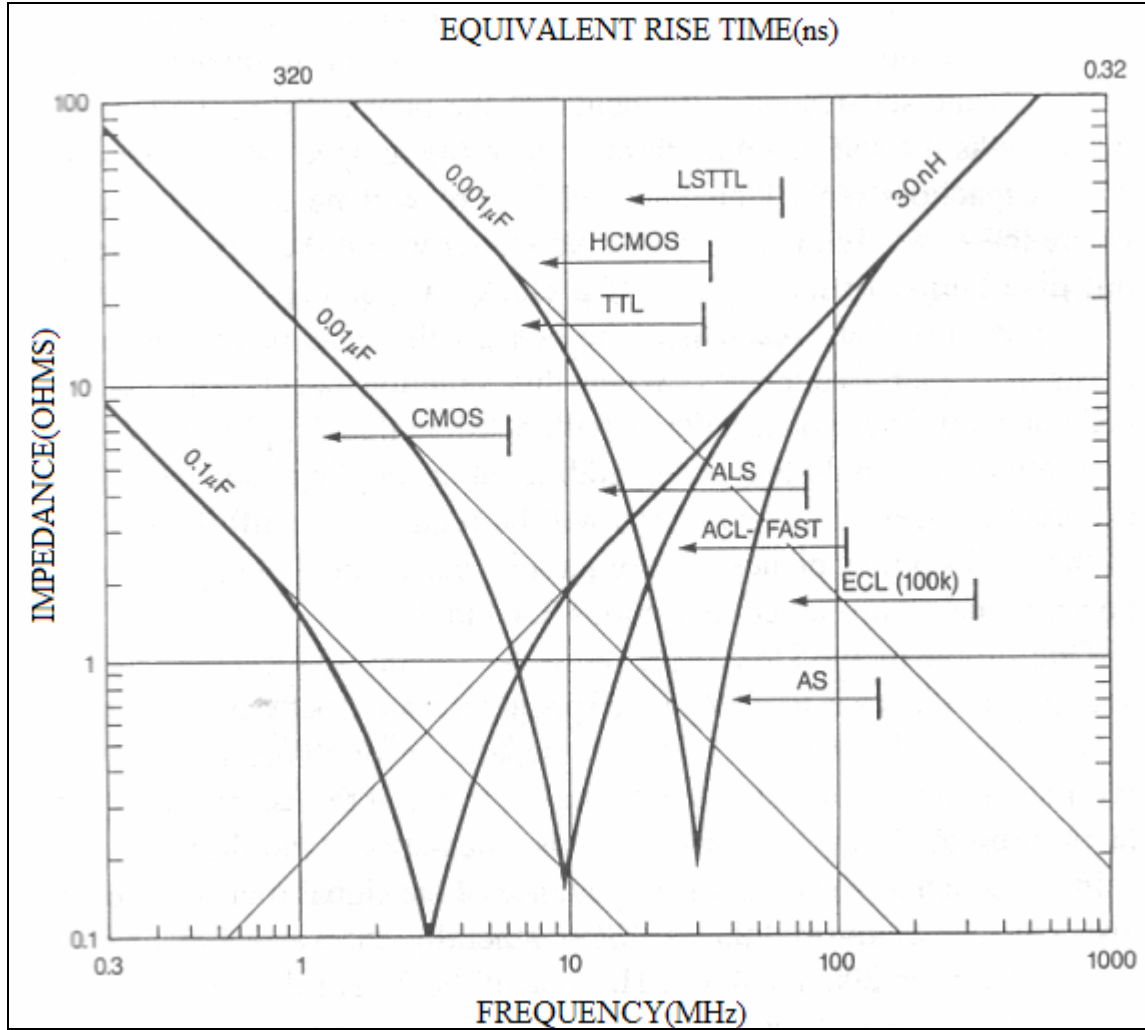


Figure 2.34 Self-resonant frequencies of capacitors vs logic families with 0.25' leads

Table 2.2 Comparison of Series Resonant Frequency of Thru Hole and Surface Mount capacitors [22] [18]

Capacitor	Axial 0.25' leads (Thru Hole Mount)		0603 Ceramic (Surface Mount)	
	Fres(MHz)	ESL	Fres(MHz)	ESL
1uF	2.5	15nh/inch	6	0.7nH
0.1uF	5	15nh/inch	18	0.6nH
0.01uF	15	15nh/inch	50	0.5nH

The power and ground planes of the PCB behave as a large parallel plate capacitor with capacitance given by the relation [22]

$$C = \frac{\epsilon_0 \epsilon_r A}{d} \quad (2.13)$$

where ϵ_0 is the dielectric constant of free space = 8.854×10^{-12} F/m.

ϵ_r is the relative dielectric constant = 4 for FR4 core material commonly used in PCBs

A is the area of the power planes in square meters

d is the distance between the power and ground planes in meters

For a distance of 0.01 inches, the power and ground planes will have a capacitance of 100pF/in². Decoupling capacitors can form a parallel resonant circuit with the PCB capacitance. For a parallel resonant circuit, the impedance offered tends to a very high value and is restricted only by the series equivalent resistance of the capacitor.

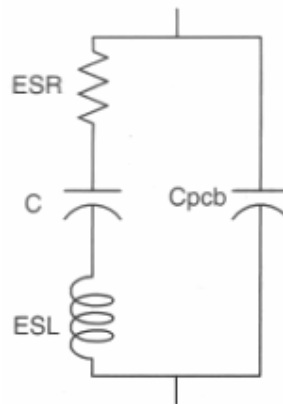


Figure 2.35 Equivalent circuit of decoupling capacitor with the equivalent PCB capacitance

At parallel resonance the magnitude of impedance offered by the parallel circuit is indirectly proportional to the ESR of the capacitor and is given by the following expression [18]

$$Z = \frac{ESL}{ESR \cdot x C_{pcb}} \quad (2.14)$$

Hence it is desirable to have ESR in the range sufficiently low to be an effective capacitor at low frequencies and sufficiently high to control the impedance spike at the parallel resonance frequency [18].

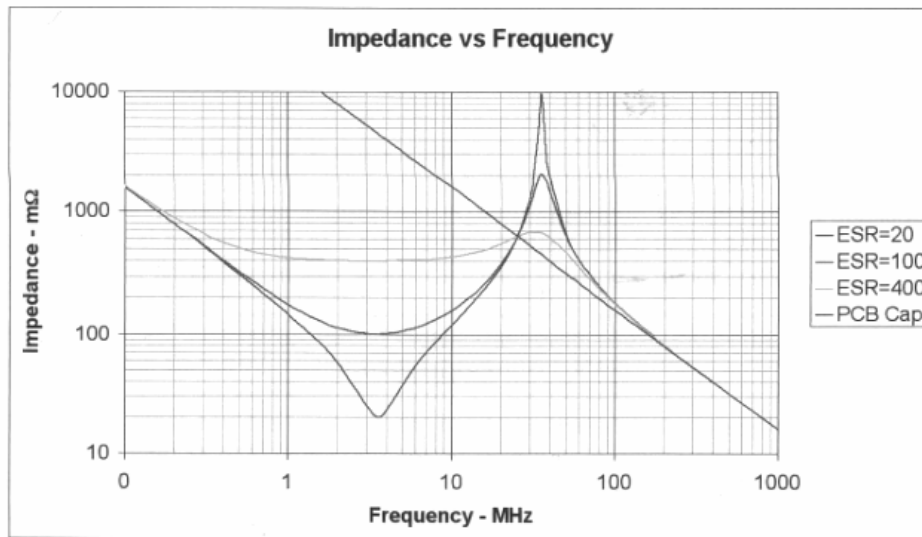


Figure 2.36 Impedance at parallel resonance versus ESR (1uF 0603 ceramic)

2.3.4.5 Selection of decoupling capacitor

The following procedure may be followed to select decoupling capacitors [22]

Determine the maximum current draw anticipated on the board. Assume all gates switch

at the same time. Include the effect of power surges by logic crossover (cross conduction currents)

1) Calculate the maximum amount of power supply noise permitted by the logic devices used. Factor in a safety margin.

2) Determine the maximum common-path impedance tolerable. This is determined by

$$X_{\max} = \frac{\Delta V}{\Delta I} \quad (2.15)$$

3) If solid planes are used, X_{\max} is allocated to the connection between power and ground.

4) Calculate the inductance of the interconnect cabling from the power supply to the board. Add this value to X_{\max} to determine the frequency below which the power supply wiring is adequate. If all gates switch simultaneously, power supply noise will be less than ΔV .

$$F_{psw} = \frac{X_{\max}}{2\pi L_{psw}} \quad (2.16)$$

5) Below frequency F_{psw} , the power supply wiring is fine. Above F_{psw} , bulk capacitors are required. Calculate the value of capacitor that has an impedance X_{\max} at frequency F_{psw} .

$$C_{bypass} = \frac{1}{2\pi F_{psw} X_{\max}} \quad (2.17)$$

Since one of the reasons for using decoupling capacitors is to provide a low impedance supply to the voltage pins of the chip, it is imperative to place them as close as possible to the IC pins. As mentioned earlier, inductance increases with loop area. By placing the decoupling capacitors closer to the IC, a smaller loop is formed; a lower inductance and lesser impedance to current. Figure 2.37[25] shows that the power line disturbance increases as the decoupling capacitor distance is increased.

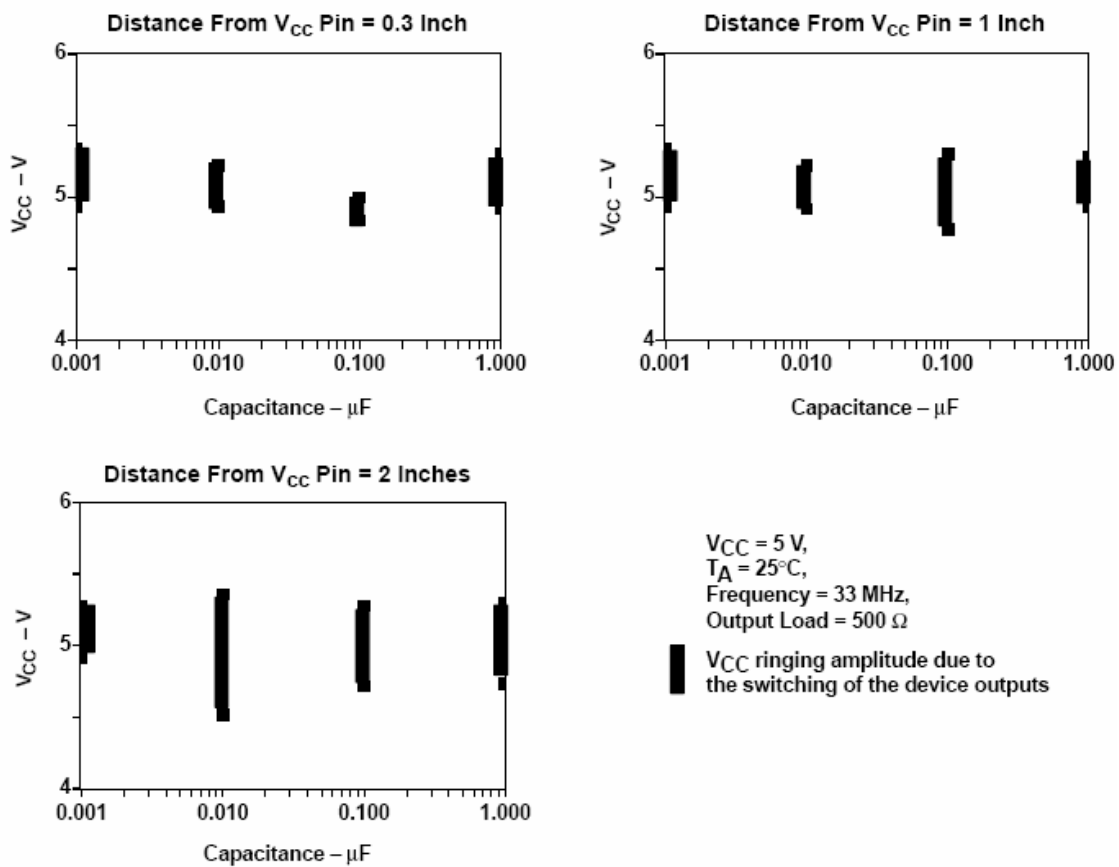


Figure 2.37 Test performed on TI ABT541, V_{CC} line disturbance versus capacitor size at different distances

2.3.5 Introduction to OrCAD Capture and Layout

OrCAD Capture and OrCAD Layout are PCB design softwares from Cadence Design Systems. This software has been used in this thesis for designing the PCB. OrCAD Capture is a software that helps in preparing schematics while OrCAD layout helps in component placement and routing of the connections. The following steps provide a broad overview in designing a PCB using OrCAD Capture and Layout. Figure 2.38 depicts a snapshot of OrCAD Capture.

OrCAD Capture:

- 1) Draw the schematic using OrCAD Capture.
- 2) Associate each component in the circuit with a footprint. (Most frequently used footprints for packages like DIP, SOT are available in the OrCAD library. New footprints can be created in OrCAD Layout)
- 3) Generate a netlist file (file containing all description of the circuit).

OrCAD Layout:

- 4) Import netlist to OrCAD Layout, specify number of layers for the PCB.
- 5) Draw PCB board and place components. The Design Rule Check (DRC) option can be used to check if the design meets the standards set for PCB design. (like minimum component spacing, via spacing etc)
- 6) Use a combination of manual and auto routing to route all the nets (connections between components are known as nets). OrCAD Specctra has the auto routing feature integrated with OrCAD Layout.

7) Verify whether the routed board meets all the design guidelines using the DRC option

8) Generate gerber files. Gerber files is the standard industry format accepted by PCB fabricators. It contains details of all the board layers and dimension of drill holes.

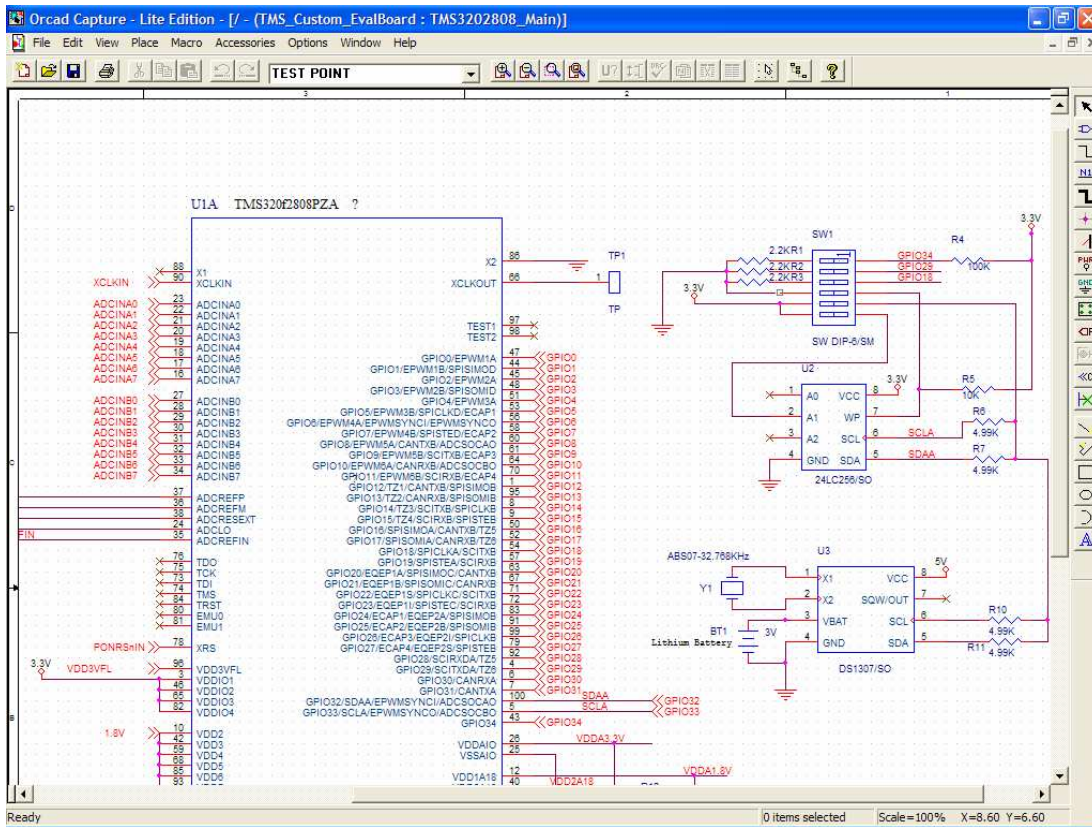


Figure 2.38 Schematic view of a circuit in OrCAD Capture

CHAPTER 3

THREE PHASE INVERTER

An inverter is used to convert DC signal to AC. AC Motor drives typically require 3 phase AC signals at the stator for their operation. The ability to control voltage and frequency of AC signals allows flexibility in improving the efficiency of AC motors. In this chapter an overview of the working of a three phase inverter is presented followed by techniques to produce modulating signals to control the inverter. Space Vector Modulation (SVM) and Sinusoidal Pulse Width Modulation (SPWM) are the popular PWM techniques in use to produce modulating control signals. Specifically SVM is analyzed and tested on a 3 phase inverter using the custom DSP board developed in this thesis. Over the years SVM has gained importance due to its inherent ability to increase the linear modulation range as well as improved Total Harmonic Distortion. [26]. At the same time research has shown that regular sampled sinusoidal modulation too can provide the same if not better performance than SVM. [27][28]. A comparison of these two techniques is presented in this chapter.

3.1 Three Phase Inverter - Working

Figure 3.1 shows a three phase inverter connected to a balanced three phase load. Switches S_a , S_b , S_c , S_a' , S_b' and S_c' are assumed to work ideally; i.e. when the switch is closed maximum current flows and there is zero voltage drop across the

switch, while when it is open, zero current flows and maximum voltage drop across the switch. Hence under ideal conditions there would be zero power loss in the switch. But practically switches have a small leakage current flowing through them in the OFF state, and a small voltage drop in the ON state (conduction losses). Moreover the transition from OFF to ON and vice-a-versa is not a perfect step function. Hence there would be losses during change of states (switching losses). But overall inverter efficiencies upto 95% [29] can be achieved in this mode of operation rather than operating the switch in its linear I-V region. The diodes across the switches are used to allow reverse inductive motor current to flow in the inverter, since switches (MOSFETs, IGBTs) allow current only in one direction. To prevent short-circuit, both the upper and lower switches are never turned ON together. The turn ON and turn OFF times of switches are usually not identical and hence it is necessary to place a deadband between the turn ON and turn OFF periods.

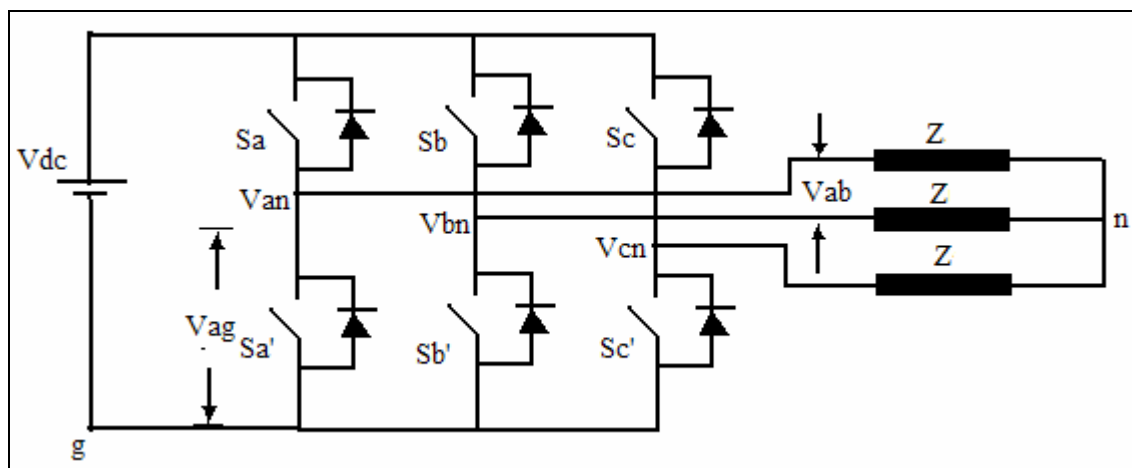


Figure 3.1 Three phase inverter with balanced load

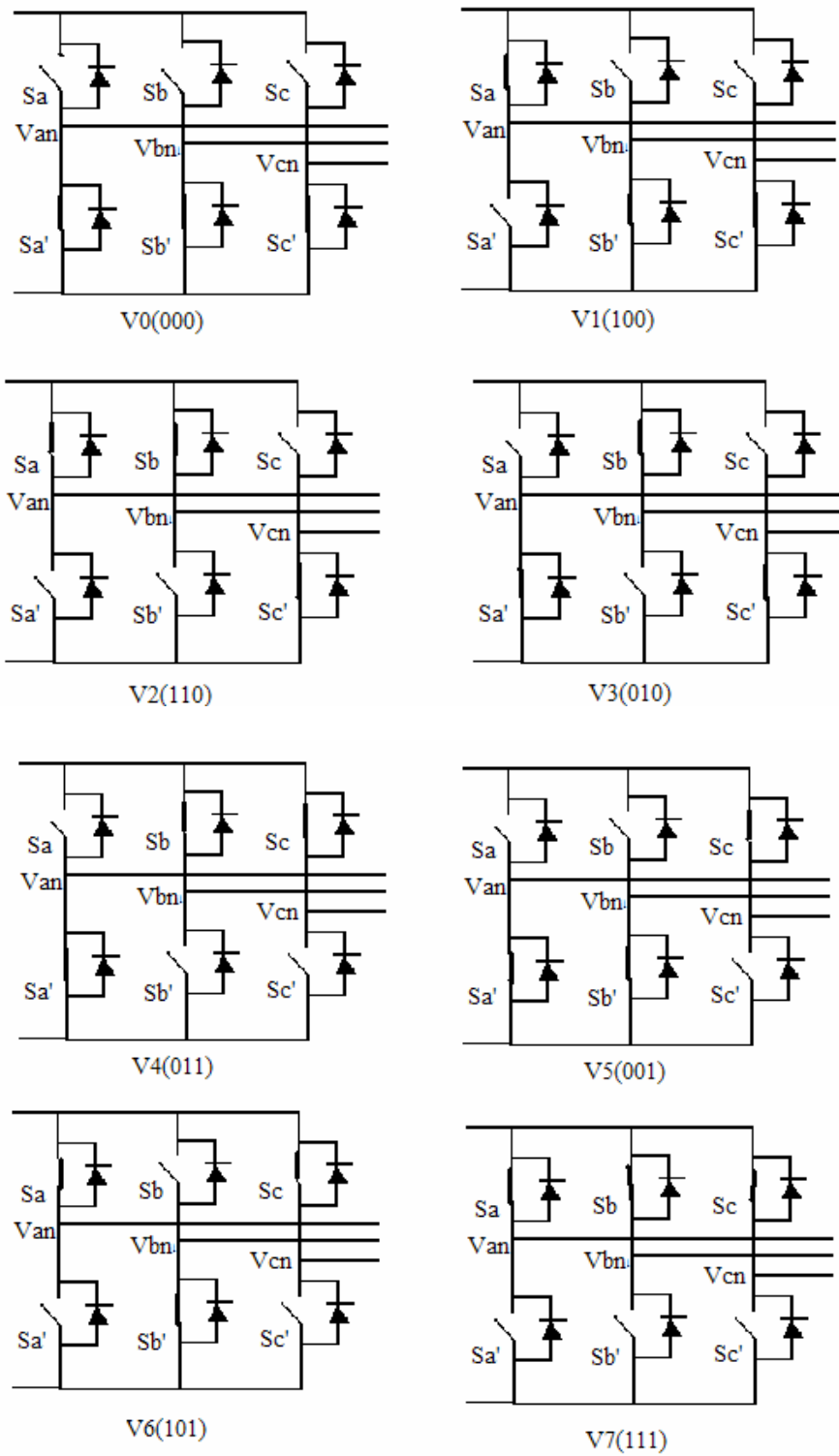


Figure 3.2 Switching states of a three phase inverter

With the three upper switches there are $2^3=8$ possible switching states. These switching states are represented in figure 3.2. For two of the switching states (000 and 111), the voltage produced across each of the phases is zero. Though these states produce “null voltage”, they play an important role in increasing the linear modulation range as well as reduction in Total Harmonic Distortion (THD).

Consider the case when switch $S_a=1$, $S_b=0$, $S_c=0$. The equivalent circuit is shown in figure 3.3

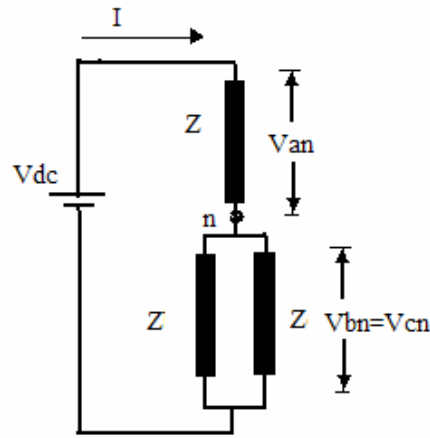


Figure 3.3 Equivalent circuit with switch sequence (100)

$$\begin{aligned}
 I &= \frac{V_{dc}}{\frac{3}{2}Z} = \frac{2V_{dc}}{3Z} \\
 V_{an} &= IZ = \frac{2V_{dc}}{3Z} \times Z = \frac{2}{3}V_{dc} \\
 V_{bn} &= V_{cn} = -\frac{Z}{2} \times \frac{2V_{dc}}{3Z} = -\frac{1}{3}V_{dc} \\
 V_{ab} &= V_{an} - V_{bn} = \frac{2}{3}V_{dc} - \left(-\frac{1}{3}V_{dc}\right) = V_{dc} \\
 \text{For a balanced system } V_{ng} &= 0. \text{ Hence } V_{an} = V_{ag} = \frac{2}{3}V_{dc}
 \end{aligned} \tag{3.1}$$

Using a similar approach the line-neutral and line-line voltages can be calculated for the remaining switching sequences and is shown in table 3.1. From the table we notice that the line to line voltages varies between $+V_{dc}$ and $-V_{dc}$. This is the maximum attainable voltage given a DC bus voltage of V_{dc} . [30].

Table 3.1 Switching patterns in a 3 phase inverter

Voltage V	Switching Pattern			Line to neutral voltages			Line to Line Voltages		
	Sa	Sb	Sc	Van	Vbn	Vcn	Vab	Vbc	Vca
V0	0	0	0	0	0	0	0	0	0
V1	1	0	0	(2/3)	(-1/3)	(-1/3)	1	0	-1
V2	1	1	0	(1/3)	(1/3)	(-2/3)	0	1	-1
V3	0	1	0	(-1/3)	(2/3)	(-1/3)	-1	1	0
V4	0	1	1	(-2/3)	(1/3)	(1/3)	-1	0	1
V5	0	0	1	(-1/3)	(-1/3)	(2/3)	0	-1	1
V6	1	0	1	(1/3)	(-2/3)	(1/3)	1	-1	0
V7	1	1	1	0	0	0	0	0	0

3.2 Pulse Width Modulation (PWM)

PWM is a modulation strategy wherein the amplitude of a low frequency signal is represented as the duty cycle of a fixed high frequency carrier signal. Figure 3.7 shows a low frequency sinusoid represented on a PWM signal. The aim is to create a train of switched pulses which have the same fundamental volt-second average as a target waveform at any instant of time. The secondary objective is determine the most effective way of arranging the switching processes to minimize unwanted harmonic distortion and switching losses. [34].

The two popular alternatives to determine the switch ON times in a PWM are

1) Naturally sampled PWM: Switching occurs at the intersection of a target reference waveform and a high frequency carrier.

2) Regular or Uniformly sampled PWM: Switching occurs at the intersection between a regularly sampled reference waveform and a high frequency carrier. These two switching strategies are shown in figure 3.4.

All fixed frequency open loop PWM strategies can be explained in terms of

- 1) Switched pulse width determination.
- 2) Switched pulse position within a carrier interval
- 3) Switched pulse sequence within and across carrier intervals.

The harmonic performance of a specific PWM implementation then results from the effects of the above three factors and the following.

- 1) The harmonics generated by the phase leg switched waveform.
- 2) Harmonic cancellation that may occur between individual phase leg switched outputs. [34].

The above factors will be considered when comparing Space Vector and Sinusoidal PWM techniques.

3.3 Space Vector Pulse Width Modulation (SVPWM)

The three phase voltages (V_{an} , V_{bn} , and V_{cn}) may be represented by a single space vector V_{ref} given by the following expression [31]

$$\vec{V}_{ref}(t) = \vec{V}_{an}(t)e^{j0} + \vec{V}_{bn}(t)e^{j\frac{2\pi}{3}} + \vec{V}_{cn}(t)e^{j\frac{4\pi}{3}} \quad (3.2)$$

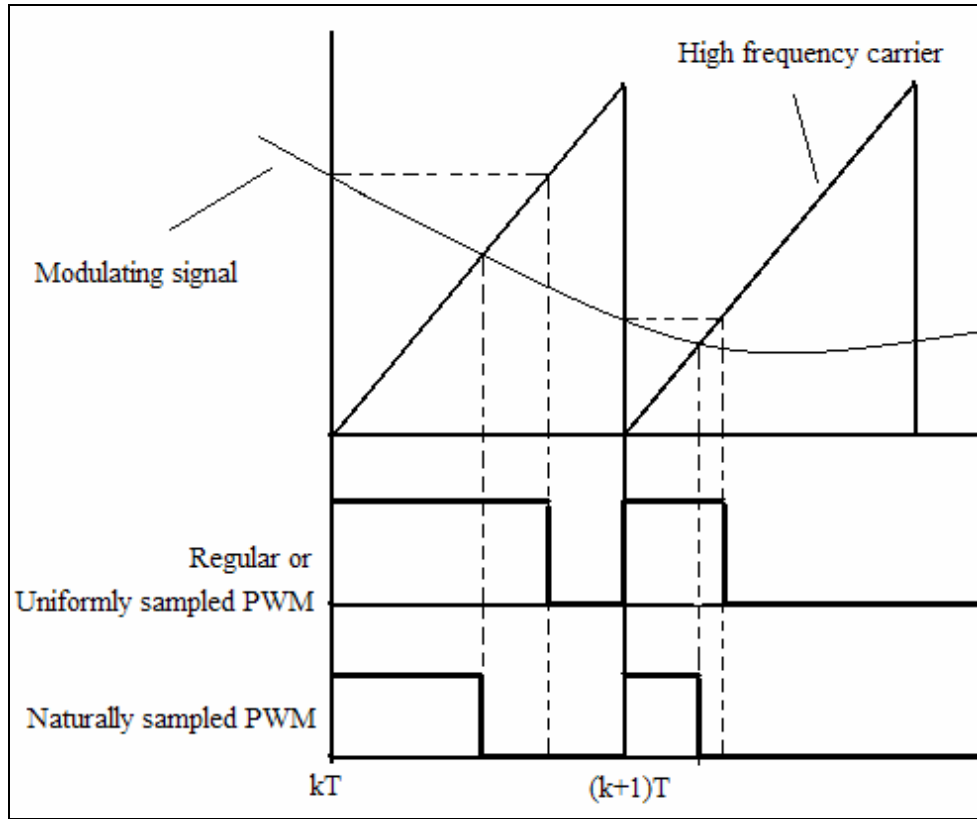


Figure 3.4 PWM switching strategy based on turn ON times

Each of the switching patterns represented in table 3.1 can be represented in the matrix form shown below

$$\begin{bmatrix} V_{an} \\ V_{bn} \\ V_{cn} \end{bmatrix} = \frac{V_{dc}}{3} \begin{bmatrix} 2 & -1 & -1 \\ -1 & 2 & -1 \\ -1 & -1 & 2 \end{bmatrix} \begin{bmatrix} S_a \\ S_b \\ S_c \end{bmatrix} \quad (3.3)$$

$$\begin{bmatrix} V_{ab} \\ V_{bc} \\ V_{ca} \end{bmatrix} = V_{dc} \begin{bmatrix} 1 & -1 & 0 \\ 0 & 1 & -1 \\ -1 & 0 & 1 \end{bmatrix} \begin{bmatrix} S_a \\ S_b \\ S_c \end{bmatrix} \quad (3.4)$$

One way of representing the three phase voltages as a single space vector is by using the d-q transformation shown below

$$f_{dq} = K_s f_{abc}$$

where (3.5)

$$K_s = \frac{2}{3} \begin{bmatrix} 1 & \frac{-1}{2} & \frac{-1}{2} \\ 0 & \frac{\sqrt{3}}{2} & \frac{-\sqrt{3}}{2} \end{bmatrix}$$

The d-q transformation is equivalent to projection of the three phase vectors on the orthonormal d-q axis.

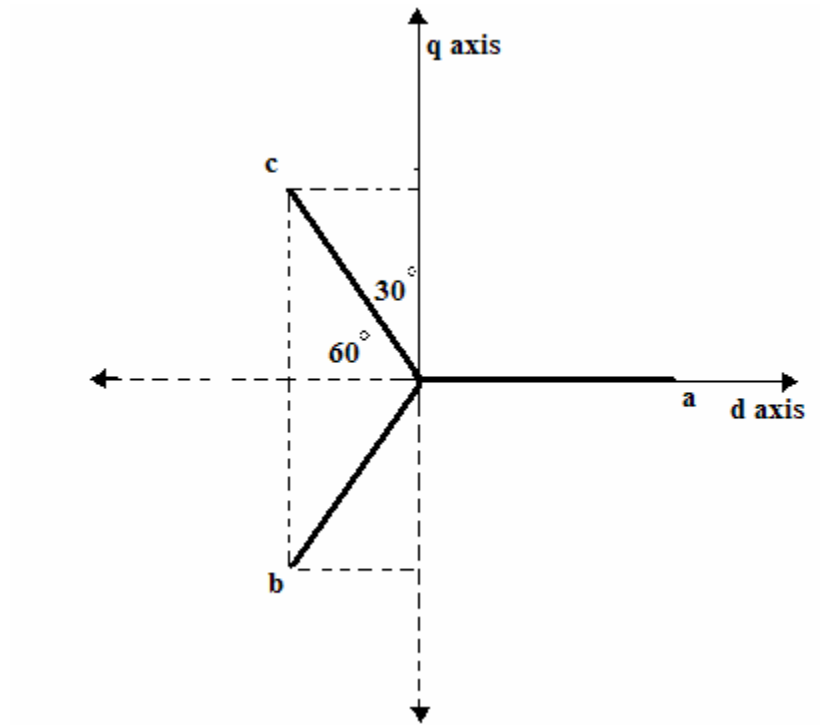


Figure 3.5 Representation of 3 phase signals in dq reference frame

$$\begin{aligned} V_d &= V_{an} - V_{bn} \cos(60) - V_{cn} \cos(60) \\ &= V_{an} - 0.5V_{bn} - 0.5V_{cn} \\ V_q &= 0 - V_{bn} \cos(30) + V_{cn} \cos(30) \\ &= 0 - \frac{\sqrt{3}}{2} V_{bn} + \frac{\sqrt{3}}{2} V_{cn} \end{aligned}$$
(3.6)

$$\begin{bmatrix} V_d \\ V_q \end{bmatrix} = \frac{2}{3} \begin{bmatrix} 1 & -1/2 & -1/2 \\ 0 & -\sqrt{3}/2 & \sqrt{3}/2 \end{bmatrix} \begin{bmatrix} V_{an} \\ V_{bn} \\ V_{cn} \end{bmatrix} \quad (3.7)$$

$$|V_{ref}| = \sqrt{V_d^2 + V_q^2}$$

For each of the switching patterns in table 3.1, a corresponding d-q voltage vector can be calculated. For example for the first non zero switching sequence (100) in table 3.1, V_d and V_q may be calculated using equation 3.7

$$\begin{bmatrix} V_d \\ V_q \end{bmatrix} = \frac{2}{3} \begin{bmatrix} 1 & -1/2 & -1/2 \\ 0 & -\sqrt{3}/2 & \sqrt{3}/2 \end{bmatrix} \begin{bmatrix} 2/3 \\ -1/3 \\ -1/3 \end{bmatrix}$$

$$V_d = 2/3$$

$$V_q = 0$$

$$V_{dq} = 2/3$$

The same is repeated for the rest of the switching patterns and is shown in table 3.2

Table 3.2 Switching pattern with V_d , V_q and V_{dq} voltages

Voltage V	Switching Pattern			Line to neutral voltages			Vd, Vq and Vdq		
	Sa	Sb	Sc	Van	Vbn	Vcn	Vd	Vq	Vdq
V0	0	0	0	0	0	0	0	0	0
V1	1	0	0	(2/3)	(-1/3)	(-1/3)	(2/3)	0	(2/3)
V2	1	1	0	(1/3)	(1/3)	(-2/3)	(1/3)	(-1/√3)	(2/3)
V3	0	1	0	(-1/3)	(2/3)	(-1/3)	(-1/3)	(-1/√3)	(2/3)
V4	0	1	1	(-2/3)	(1/3)	(1/3)	(-2/3)	0	(2/3)
V5	0	0	1	(-1/3)	(-1/3)	(2/3)	(-1/3)	(1/√3)	(2/3)
V6	1	0	1	(1/3)	(-2/3)	(1/3)	(1/3)	(1/√3)	(2/3)
V7	1	1	1	0	0	0	0	0	0

Each of the voltage vectors corresponding to the 8 switching states is shown in figure 3.6 [32]. Note the presence of the zero vectors at the origin (V0 and V7). They play an important role in the switching pattern and are primarily responsible for third harmonic injection.

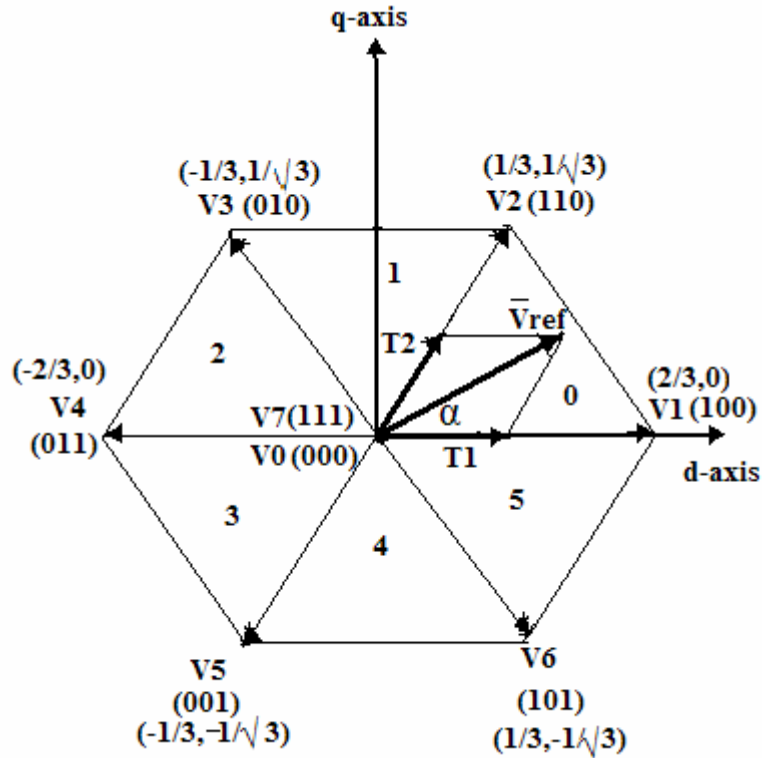


Figure 3.6 Switching patterns of space vectors

The required output voltage vector is represented by the reference vector V_{ref} . For example, if the required output line to line voltage is given by the following equations

$$\begin{aligned}
 V_{ab} &= V \cos(\alpha) \\
 V_{bc} &= V \cos(\alpha - 120) \\
 V_{ca} &= V \cos(\alpha + 120)
 \end{aligned}
 \tag{3.8}$$

, then $V_{ref} = V/\sqrt{3}$. This is because line to neutral voltages was used in the d-q transformation.

' α ' = $2\pi ft$; where 'f' is the fundamental frequency of the modulating signal.

The objective of space vector PWM technique is to approximate the reference voltage vector V_{ref} , by a combination of the eight switching patterns [33]. In a small period T_z (the period of the PWM signal), the average output voltage of the inverter is assumed to be same as V_{ref} in the same period. The reference output V_{ref} is approximated using the adjacent voltage vectors in each sector.

$$\int_0^{T_z} \overline{V_{ref}} = \int_0^{T_1} \overline{V_1} + \int_{T_1}^{T_1+T_2} \overline{V_2} + \int_{T_1+T_2}^{T_z} \overline{V_0} \quad (3.9)$$

Using d-q axis

$$T_z |\overline{V_{ref}}| \begin{bmatrix} \cos(\alpha) \\ \sin(\alpha) \end{bmatrix} = T_1 \frac{2}{3} V_{dc} \begin{bmatrix} \cos(n\pi/3) \\ \sin(n\pi/3) \end{bmatrix} + T_2 \frac{2}{3} V_{dc} \begin{bmatrix} \cos((n+1)\pi/3) \\ \sin((n+1)\pi/3) \end{bmatrix} \quad (3.10)$$

where 'n' is the sector number =0,1..5

Simplifying the above equation, T1 and T2, can be represented by the following set of equations for any sector

$$\begin{aligned} T_1 &= \frac{\sqrt{3}T_z |\overline{V_{ref}}|}{V_{dc}} \left(\sin\left(\frac{n\pi}{3} - \alpha\right) \right) \\ T_2 &= \frac{\sqrt{3}T_z |\overline{V_{ref}}|}{V_{dc}} \left(\sin\left(\alpha - \frac{(n-1)\pi}{3}\right) \right) \\ T_0 &= T_z - (T_1 + T_2) \end{aligned} \quad (3.11)$$

Hence in sector 0, voltage vector V_0 ($S_a=1, S_b=0, S_c=0$) is applied for T_1 units of time and V_1 ($S_a=1, S_b=1, S_c=0$) for T_2 units of time. This effectively means that in sector 0

- a) S_a is turned ON for T_1+T_2 units of time.
- b) S_b is turned ON for T_2 units of time.
- c) S_c is turned OFF.

T_0 represents the null pulse time (voltage vectors V_0 and V_7). In order to ensure minimum switching frequency of each inverter leg, it is necessary to arrange the switching sequence in such a way that the transition from one state to the other is performed by switching only one inverter leg [26]. This done by distributing the null state among $V_0(000)$ and $V_7(111)$ such that each voltage vector equals $T_0/2$.

One PWM (symmetrical) switching period in sector 0 is shown in figure 3.7. Table 3.3 shows the time instants for all the sectors

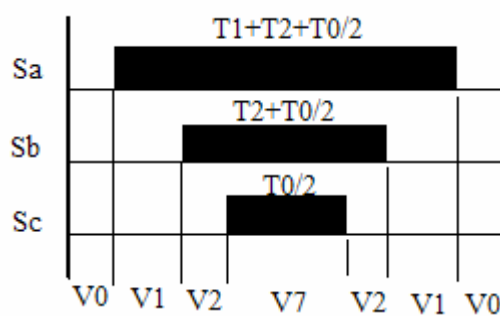


Figure 3.7 Switching time instants of S_a, S_b and S_c

In this thesis, Space Vector PWM signals are generated using the DSP board and tested on a 3 phase inverter.

Table 3.3 Switching time instants for each sector

Sector	Switch	Upper Switches	Lower Switches
0	S1	$T1+T2+T0/2$	$T0/2$
	S3	$T2+T0/2$	$T1+T0/2$
	S5	$T0/2$	$T1+T2+T0/2$
1	S1	$T1+T0/2$	$T2+T0/2$
	S3	$T1+T2+T0/2$	$T0/2$
	S5	$T0/2$	$T1+T2+T0/2$
2	S1	$T0/2$	$T1+T2+T0/2$
	S3	$T1+T2+T0/2$	$T0/2$
	S5	$T2+T0/2$	$T1+T0/2$
3	S1	$T0/2$	$T1+T2+T0/2$
	S3	$T1+T0/2$	$T2+T0/2$
	S5	$T1+T2+T0/2$	$T0/2$
4	S1	$T2+T0/2$	$T1+T0/2$
	S3	$T0/2$	$T1+T2+T0/2$
	S5	$T1+T2+T0/2$	$T0/2$
5	S1	$T1+T2+T0/2$	$T0/2$
	S3	$T0/2$	$T1+T2+T0/2$
	S5	$T1+T0/2$	$T2+T0/2$

3.4 Sinusoidal modulation and third harmonic injection

Consider the following line to neutral sinusoidal modulating signals

$$V_a = V \sin(\omega t) \quad (3.12)$$

$$V_b = V \sin(\omega t - 120) \quad (3.13)$$

$$V_c = V \sin(\omega t + 120) \quad (3.14)$$

Pulse Width Modulation of the switches of the inverter produces output voltages between 0 and V_{dc} . Figure 3.7 represents a sine wave imposed on a PWM signal. The peak value of the sine wave that can be produced equals $V_{dc}/2$.

i.e. $V = V_{dc}/2$.

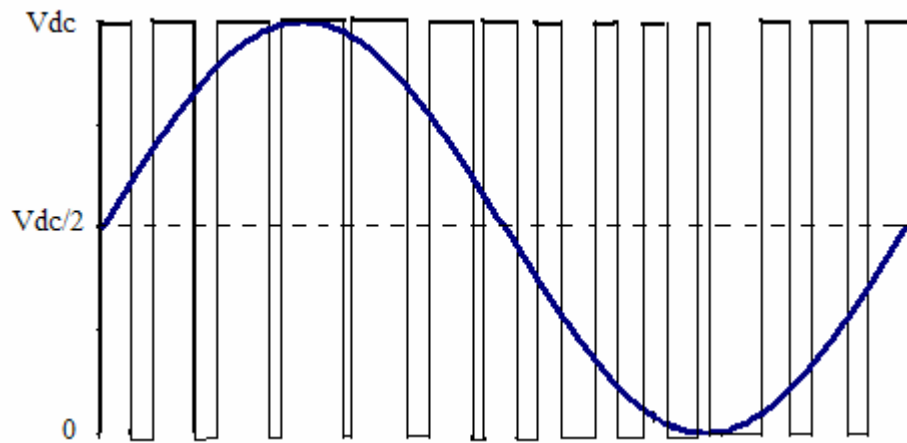


Figure 3.8 Sinusoidal Pulse Width Modulated Signal

With the line to neutral voltages represented by equation 3.12, 3.13 and 3.14, the peak line to line voltage that can be produced equal $\sqrt{3}V = \sqrt{3}V_{dc}/2 = 0.866V_{dc}$. Hence the peak possible voltage (V_{dc}) cannot be achieved using simple sinusoidal modulation. Figure 3.9 shows this condition. For ease of analyzing only V_a , V_b and V_{ab} are considered. The same results may be applied to V_{bc} and V_{ca} .

From equations (3.12) and (3.13)

$$\begin{aligned} V_{ab} &= V_a - V_b \\ &= V\sin(\omega t) - V\sin(\omega t - 120) \end{aligned} \quad (3.15)$$

The maximum value occurs when $dV_{ab}/dt = 0$

$$dV_{ab}/dt = V\cos(\omega t) + V\cos(\omega t - 120) \quad (3.16)$$

$$V\cos(\omega t) = -V\cos(\omega t - 120)$$

$\omega t = 60^\circ$ satisfies the above condition.

Hence a signal that peaks at $V_a = V\sin(60) = 0.866V$ can produce maximum V_{ab} .

From figure 3.9, we find that when V_{ab} reaches its maximum value of $\sqrt{3}V$, V_a and V_b

are not at their maximum values. Hence complete utilization of the DC bus voltage is not accomplished using sinusoidal modulation.

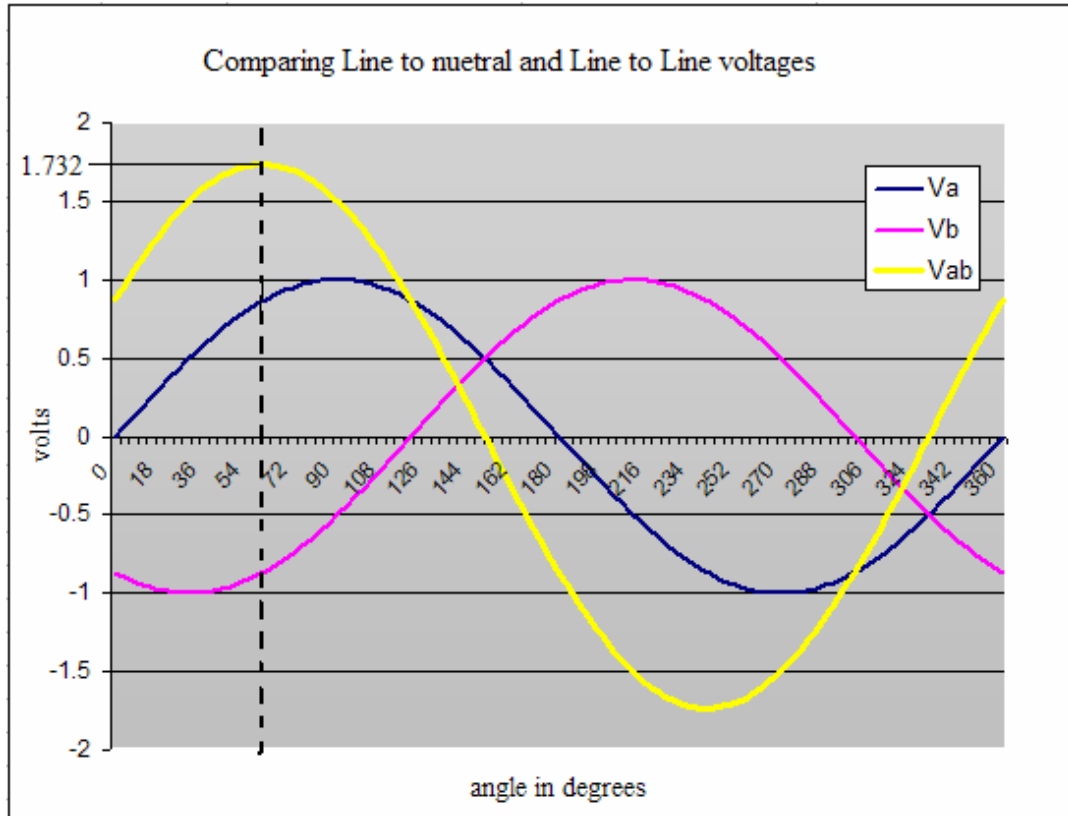


Figure 3.9 Comparison of line to neutral and line to line voltages

Third Harmonic injection is the addition of 3rd harmonic and its multiples into the reference line to neutral signal. One of the properties of third harmonic injection is that its harmonic components are cancelled out in the line to line voltage [34]. Hence the same line to line voltage is produced as in the case without 3rd harmonic injection. This is shown in figure 3.10. But note that the line to neutral is a notched sine wave with a peak value of 0.866V. Hence an effective line to neutral voltage of 0.866V produces an output line to line peak of 1.732V.

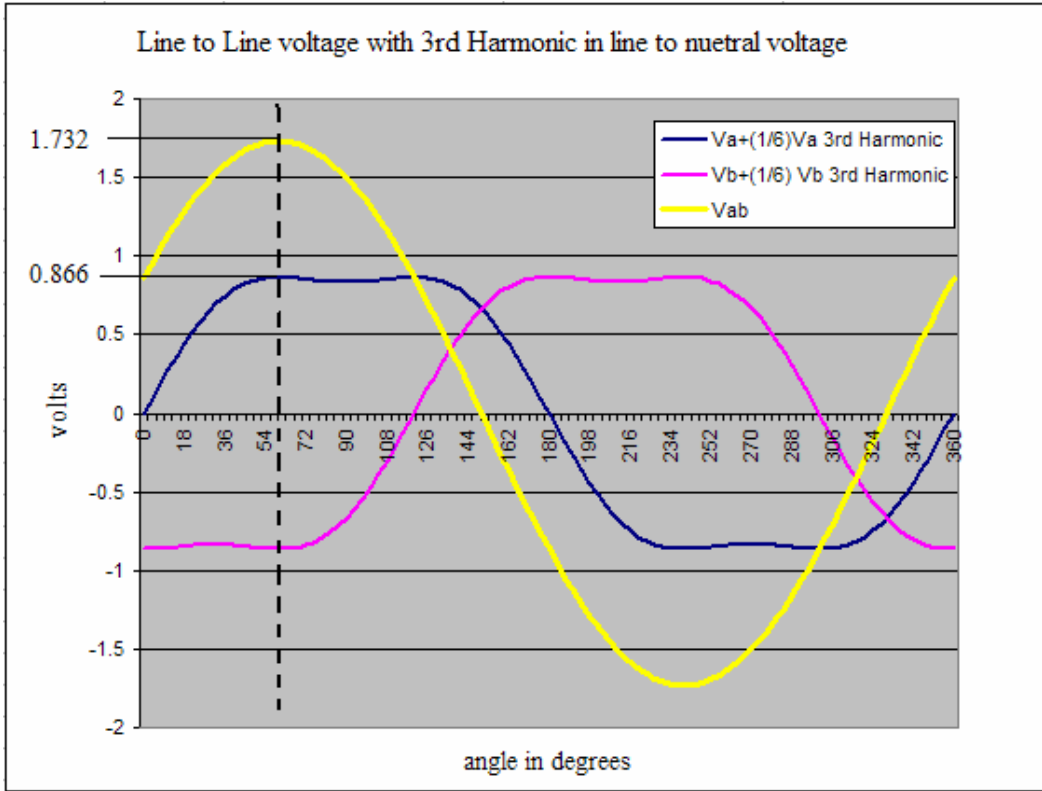


Figure 3.10 Line to line voltage with 3rd harmonic injected in the line to neutral voltage

Therefore if the effective line to neutral voltage is 1V (maximum possible value = $V = V_{dc}/2$), then the output line to line voltage would be

$$= \frac{1.732}{0.866} V = 2V = \frac{2V_{dc}}{2} = V_{dc}$$

Hence the maximum line to line voltage (V_{dc}) can be achieved by using this specific form of third harmonic injection. [27]. For the above case, note that all amplitudes of the 3rd harmonic and its multiples will produce the same output ($\sqrt{3}V$) as shown in figure 3.10. But one-sixth of the 3rd harmonic [27] is sufficient to bring the effective line to neutral voltage down to 0.866V such that maximum linear modulation is achieved.

For sinusoidal modulation, the modulation index m is defined as

$$m = \frac{V}{V} = 1$$

For sinusoidal modulation with 3rd harmonic injection, modulation index m is equal to

$$m = \frac{V}{0.866V} = \frac{2}{\sqrt{3}} = 1.15$$

3.5 Comparison of Space Vector and Sinusoidal PWM techniques

Space Vector PWM (SVM) as seen above can produce the maximum possible line to line voltage by increasing the linear modulation range ($2/\sqrt{3}$ or 1.15 times). This is accomplished due to third harmonic injection “inherent” in SVM. Comparisons with respect to SPWM has shown that SVM is much better due to higher linear modulation range and lower baseband distortion [27]. Figure 3.11 shows three kinds of modulating phase signals sinusoidal modulation (V_a), sinusoidal modulation + (1/6)th 3rd harmonic (V_a+3^{rd} harmonic) and space vector modulated signal (V_a_{SVM}).

From figure 3.11 we find that due to the similarity of the signals, it would be appropriate to compare SV signals with sinusoidal modulated signals + 3rd harmonic injection. In SVM, the switching times were calculated and assigned to a specific type of PWM representation. Hence SVM can also be regarded as form of carrier based PWM technique with a low frequency modulating signal on a high frequency carrier signal. With this perspective, comparison of the different modulating techniques can be distinguished between the form of the modulating signal and the carrier PWM.

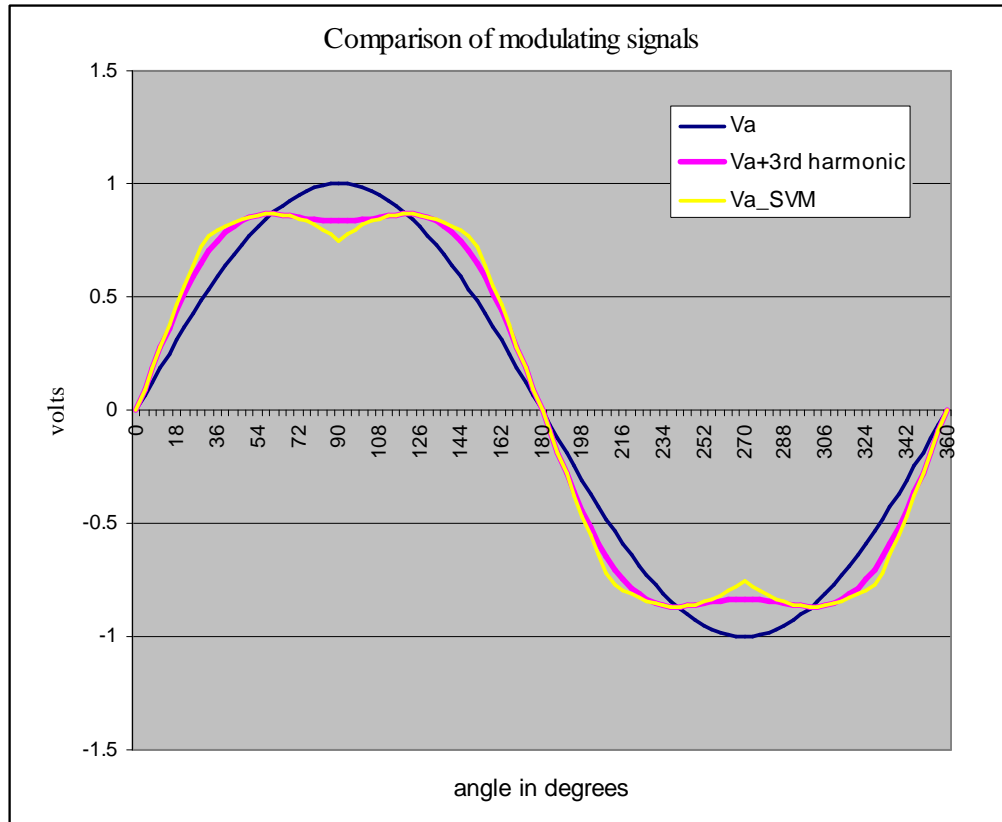


Figure 3.11 Comparison of phase modulating signals

The following features will be considered in comparing all the possible modulating signals.

- 1) Linear modulation range extension to the maximum value of 1.15.
- 2) Total Harmonic Distortion

The relationship between SVM and asymmetrical regular sampled PWM was established by considering a sector based 3rd harmonic injected sinusoid [28]. This was done in order to maintain equal null pulse times (t_0 and t_7) in the pulse pattern. The addition of equal null sequence (t_0 and t_7), increased the linear modulation range to $(2/\sqrt{3})$. The modulating signals were represented by the following expressions.

$$\begin{aligned}
F_A(T_k) &= [\sin(T_k) + x \sin(3T_k)] \\
F_b(T_k) &= [\sin\left(T_k - \frac{2\pi}{3}\right) + x \sin(3T_k)] \\
F_c(T_k) &= [\sin\left(T_k - \frac{4\pi}{3}\right) + x \sin(3T_k)]
\end{aligned} \tag{3.17}$$

where 'x' is given by

$$x = \left\{ \begin{array}{l} \frac{\sin(T_k)}{2\sin(3T_k)}; \quad T_k \in \left[\frac{-\pi}{6}, \frac{\pi}{6} \right], \left[\frac{5\pi}{6}, \frac{7\pi}{6} \right] \\ \frac{-\sin\left(T_k - \frac{\pi}{3}\right)}{2\sin(3T_k)}; \quad T_k \in \left[\frac{\pi}{6}, \frac{\pi}{2} \right], \left[\frac{7\pi}{6}, \frac{3\pi}{2} \right] \\ \frac{-\sin\left(T_k + \frac{\pi}{3}\right)}{2\sin(3T_k)}; \quad T_k \in \left[\frac{\pi}{2}, \frac{5\pi}{6} \right], \left[\frac{3\pi}{2}, \frac{11\pi}{6} \right] \\ \frac{1}{6}; \quad T_k = \frac{j\pi}{3}; j = 0,1,\dots,5 \end{array} \right. \tag{3.18}$$

This signal generated an identical phase modulating phase signal as SVM shown in figure 3.11. This expression established the time domain relationship between space vector modulated and regularly sampled sinusoidal modulation signals. Being sector dependent, it offered no advantage over SVM in computational complexity.

Considering double sided uniform sampled PWM (UPWM), the switching patterns was established to be identical to SVM [27]. Addition of 3rd harmonic to the sinusoidal UPWM, only increases the linear modulation range and does not cause base band distortion. This shows that SVM signals are quite similar to uniformly sampled SPWM signals with 3rd harmonic injection. But an important difference is that SVM signals have equal null pulse times ($t_0=t_7$), while SPWM have unequal null pulse times.

Research has shown that (1/6th) 3rd harmonic has higher THD in comparison with equal null pulse (t_0-t_7) (equivalently SVM signal) modulating signal. This is shown in figure 3.12 [28]

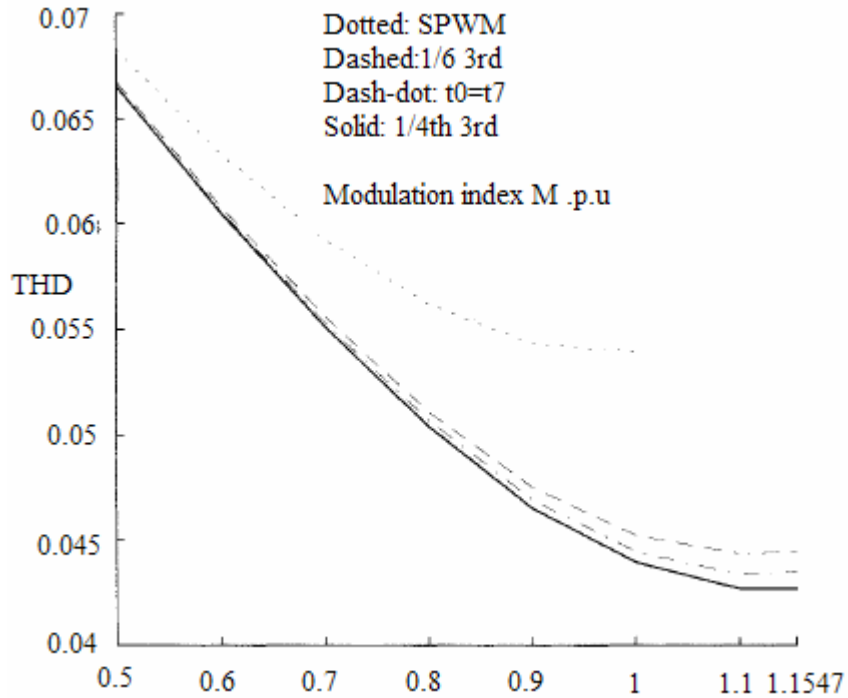


Figure 3.12 THD for four PWM strategies

In figure 3.11, analysis was performed on asymmetric regular sampled PWM signals. One fourth 3rd harmonic injection as shown in figure 3.12, is known to have lower THD compared to other modulation schemes. But this is at the cost of a slightly lower linear modulation range (1.12) [34].

Asymmetric naturally sampled PWM signals are known to have better THD than other PWM modulation strategies [31]. But such signals are usually difficult to implement in a DSP. In this thesis symmetrical regular sampled modulation signals will be simulated in MATLAB SIMULINK to compare the following modulation schemes

- 1) Space vector PWM
- 2) Sinusoidal with $(1/6)^{\text{th}}$ 3rd harmonic injection PWM.
- 3) Sinusoidal PWM.

CHAPTER 4

RESULTS

4.1 High Speed Printed Circuit Board Design

Based on the concepts presented in Chapter 2, a custom DSP board was successfully developed and tested to drive a 3 phase inverter. The PCB design process is shown in figure 4.1

4.1.1 Creation of schematic

The DSP board was designed to fully utilize the features of the TMS320F2808 DSP. They include the following

1. General Purpose IO Interface
2. Interface for analog inputs. The number of analog inputs was extended using a multiplexer configurable using one of the GPIO pins.
3. EEPROM (256K) and Real Time Clock support using I2C.
4. CAN Interface
5. RS-232 Interface
6. 14-pin JTAG

The schematics were prepared using OrCAD Capture with [35] as reference.

4.1.2 Component Selection, design of footprints

All the components selected were Surface Mount. As mentioned in chapter 2, this was done to reduce EMI, reduce space and satisfy trace length constraints. The

footprint for commonly used components like 0805 resistor is available in OrCAD Layout. For the rest, footprints were designed in Layout based on mechanical information provided in their respective datasheets.

As an industry standard, list of components numbers, their manufacturers and footprints are specified in a text file known Bill of Materials (BOM). This file is available in Appendix B.

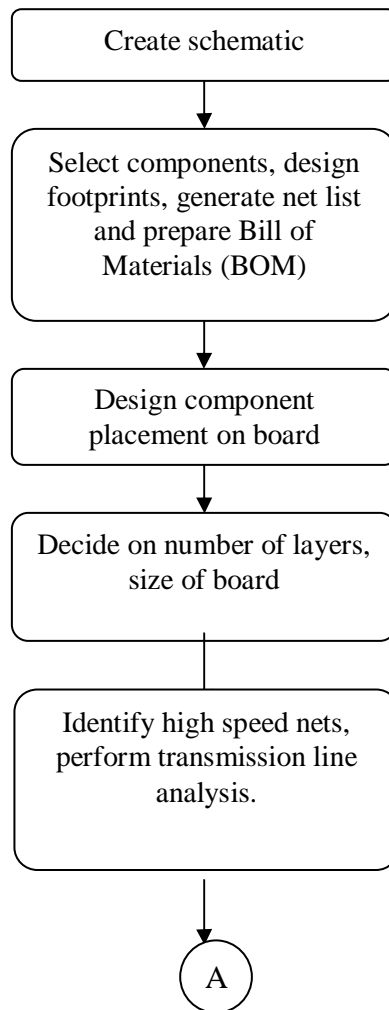


Figure 4.1 Flowchart of PCB design process

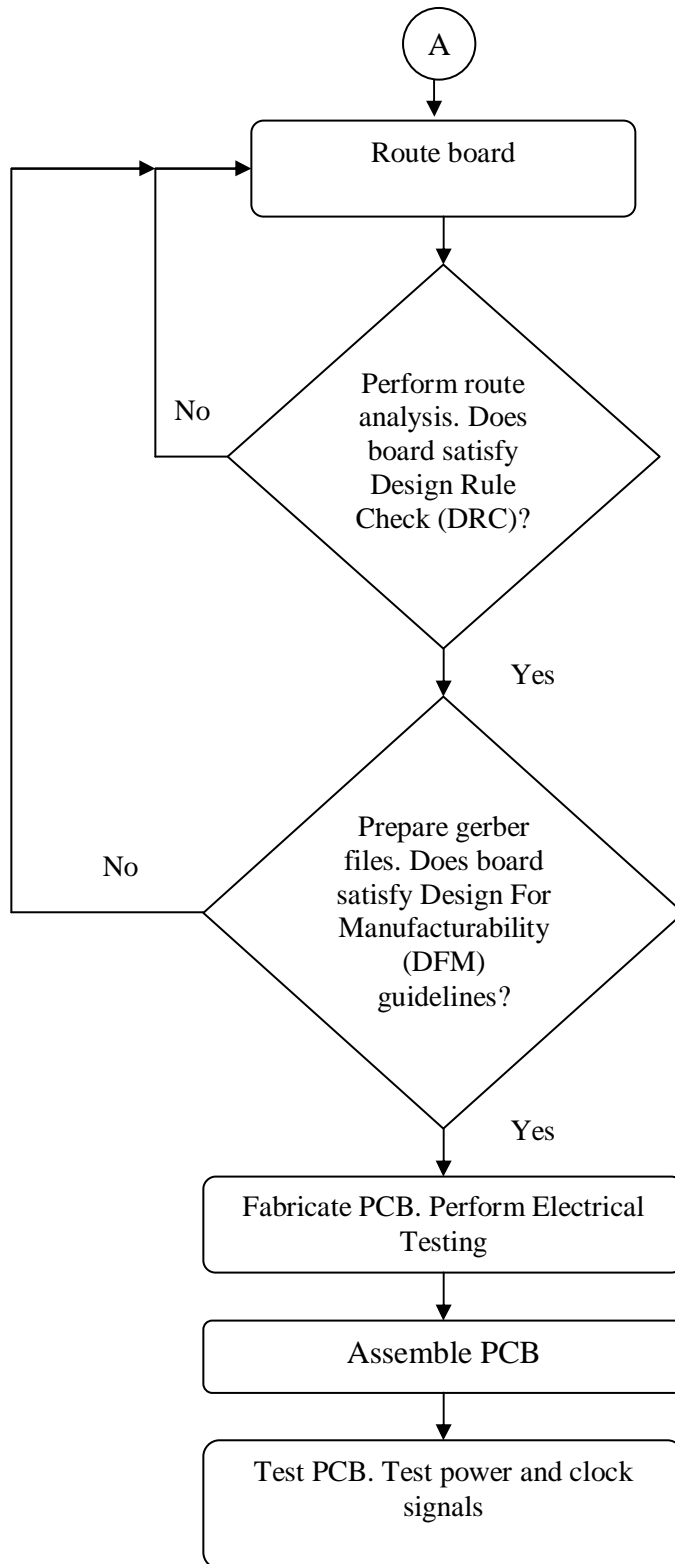


Figure 4.2 Continued-Flowchart of PCB design process

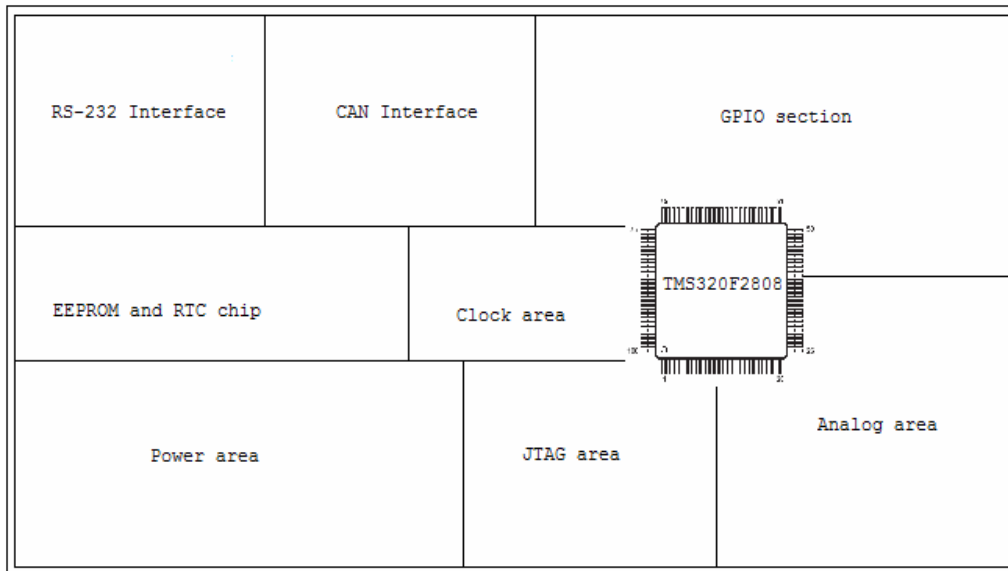


Figure 4.3 Functional distribution of the DSP board

4.1.3 Component Placement

This is one of most important steps in the PCB design process. The board was divided into functional areas as shown in figure 4.3. This step is revisited each time routing rules/design constraints fail.

4.1.4 Number of layers and size of board

The custom DSP board was designed to have a dimension of 4'' x 7''. This decision was based keeping in mind the size of the components and design constraints on their placement. To reduce EMI and cost, the DSP board was designed to have 6 layers and is shown in figure 4.4.

4.1.5 Circuit analysis for transmission line effects

Before analyzing the DSP board for transmission line effects, the characteristic impedance and propagation delay of the 6 layer PCB stack is found. From figure 4.4, it

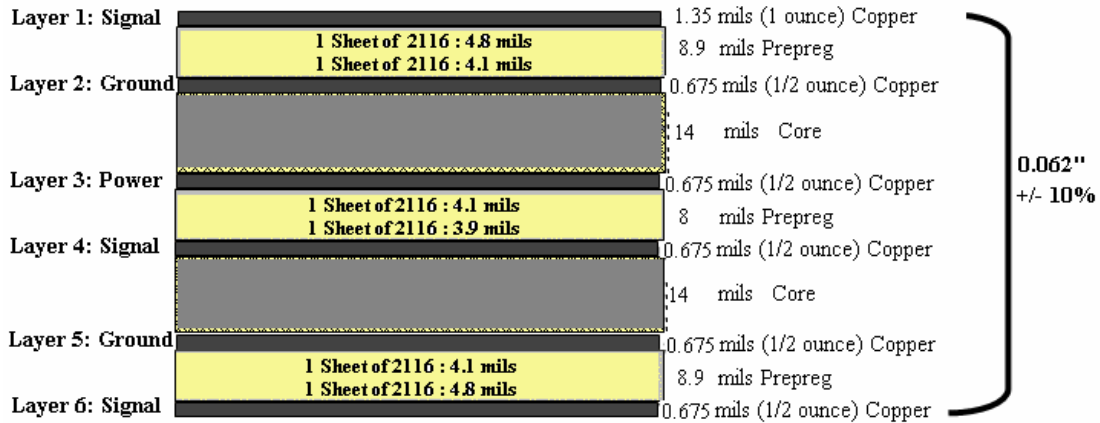


Figure 4.4 PCB Layer Stack up

is seen that signal layer 1 is a microstrip transmission line while signal layer 4 is an asymmetric stripline transmission line. The equations used to calculate characteristic impedance for microstrip and asymmetric stripline [36] are shown below

Microstrip trace impedance (Signal layer 1)

$$Z_0 = \frac{87}{\sqrt{\epsilon_r + 1.41}} \ln \left(\frac{5.98H}{0.8W + T} \right) \text{ohms} \quad (4.1)$$

$$t_{pd} = 1.016 \sqrt{0.475\epsilon_r + 0.67} \text{ns / ft} \quad (4.2)$$

Considering $\epsilon_r = 4.1$ (FR-4 material), trace width $W = 8$ mils

$H = 8.9$ mils (figure 4.3), $T = 1.35$ mils

Substituting in equation 4.1 and 4.2

$$Z_0 = 71.41 \text{ohms}$$

$$t_{pd} = 0.137 \text{ns / in}$$

Asymmetric stripline impedance (Signal layer 4)

$$Z_0 = \frac{80}{\sqrt{\epsilon_r}} \ln \left(\frac{1.9(2H + T)}{0.8W + T} \right) \left(1 - \frac{H}{4H_1} \right) \text{ohms} \quad (4.3)$$

$$t_{pd} = 1.016 \sqrt{e_r} \text{ns / ft} \quad (4.4)$$

From figure 4.4 $H = 8\text{mils}$, $H1 = 14\text{mils}$, $W = 8\text{mils}$, $T = 0.675\text{mils}$

Substituting in equation 4.3 and 4.4

$$Z_0 = 50.76\text{ohms}$$

$$t_{pd} = 0.171\text{ns/in}$$

The rise/fall time for clock signals for TMS320F2808 DSP is **2ns**, GPIO pins is **8ns** [37] and JTAG signals alone have rise/fall times of **500ps** [38]. The trace length beyond which transmission line effects like reflection become prominent is given by equation (2.2). For GPIO traces (considering asymmetric stripline traces)

$$2 \times 0.171\text{ns/in} \times \text{tracelength} > 8\text{ns}$$

Therefore for trace lengths greater than 23.4 inches, overshoot and ringing can occur. For JTAG signal traces, (Since asymmetric stripline, signal layer 4 has lower impedance than microstrip, the routing is done on the former)

$$2 \times 0.171\text{ns/in} \times \text{tracelength} > 0.5\text{ns}$$

The maximum tracelength for JTAG signals is 1.46 inch. Hence we conclude that JTAG signals must be analyzed for transmission line effects. Among the JTAG signals, only TDO is an output signal. It is assumed that termination for the other signals is provided at the driver end. Based on recommendations from TI [38], parallel termination was provided for TCLK pin (100 ohms in series with 22pF capacitor).

The JTAG signals have an output impedance of 7 ohms [38]. Series termination is provided to match the impedance of the source (7 ohms) and transmission line impedance (50ohms). Using the lattice method described in chapter 2, a series termination resistor of **33 ohms** was connected to TDO pin. In figure 4.3 it is seen that in the functional distribution block, JTAG was placed close to the DSP chip.

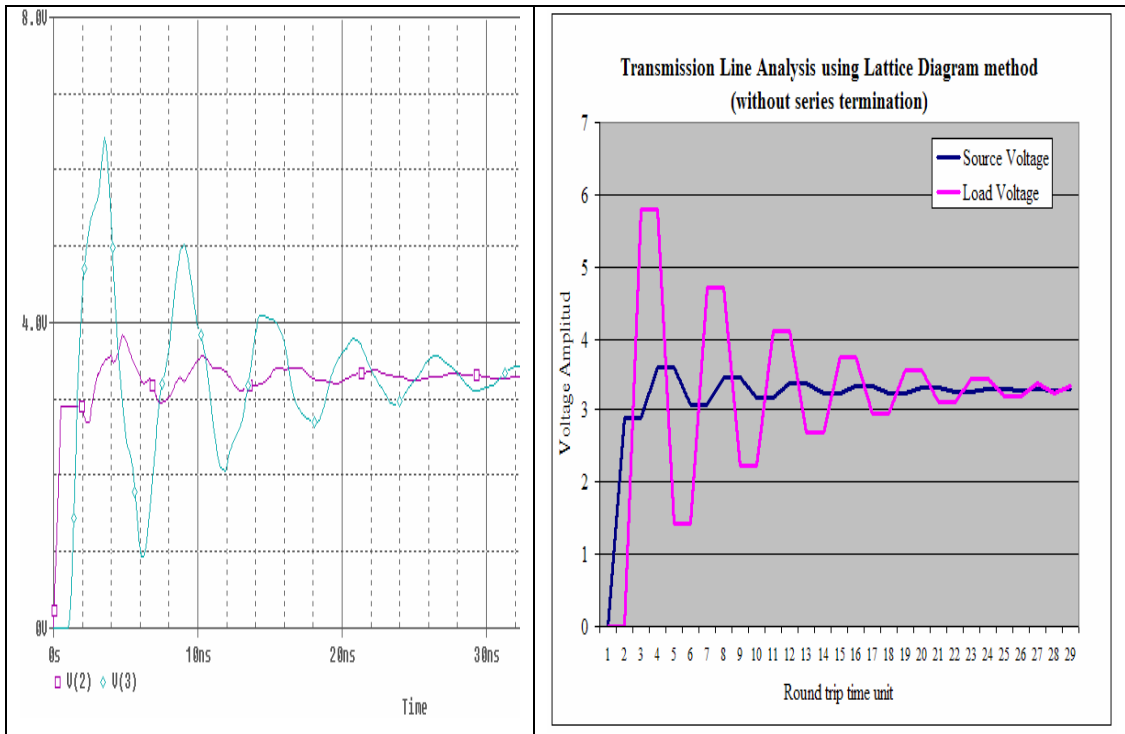


Figure 4.5 PSPICE simulation and Lattice diagram method using Excel, without series termination

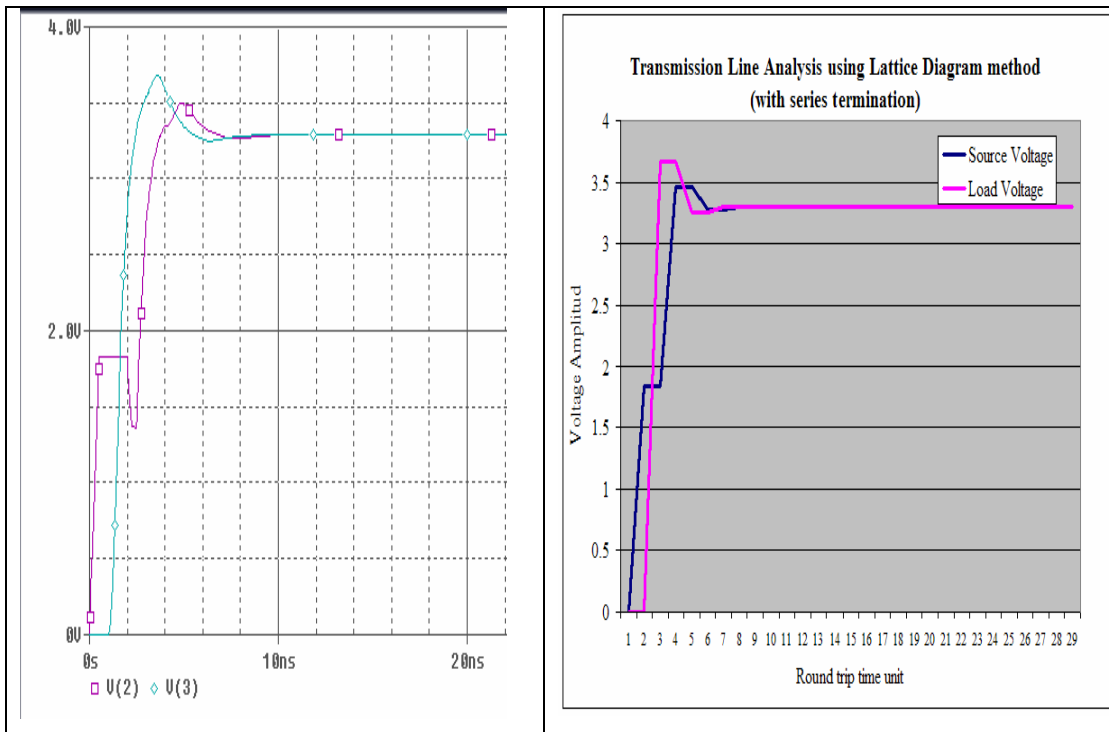


Figure 4.6 PSPICE and Excel simulation with series termination resistor

Figure 4.5 and 4.6 shows the simulation done in Excel (using lattice method) and PSPICE for a low to high transition.

4.1.6 Routing

A combination of manual and auto routing was used to route the PCB.

After each route, Design Rule Check (DRC) was performed. This option is available in OrCAD Layout and contains definitions on trace spacing, component spacing, via spacing etc. Routing was an iterative process involving DRC and component placement reorganization. A snapshot of the completely routed DSP board is shown in figure 4.7

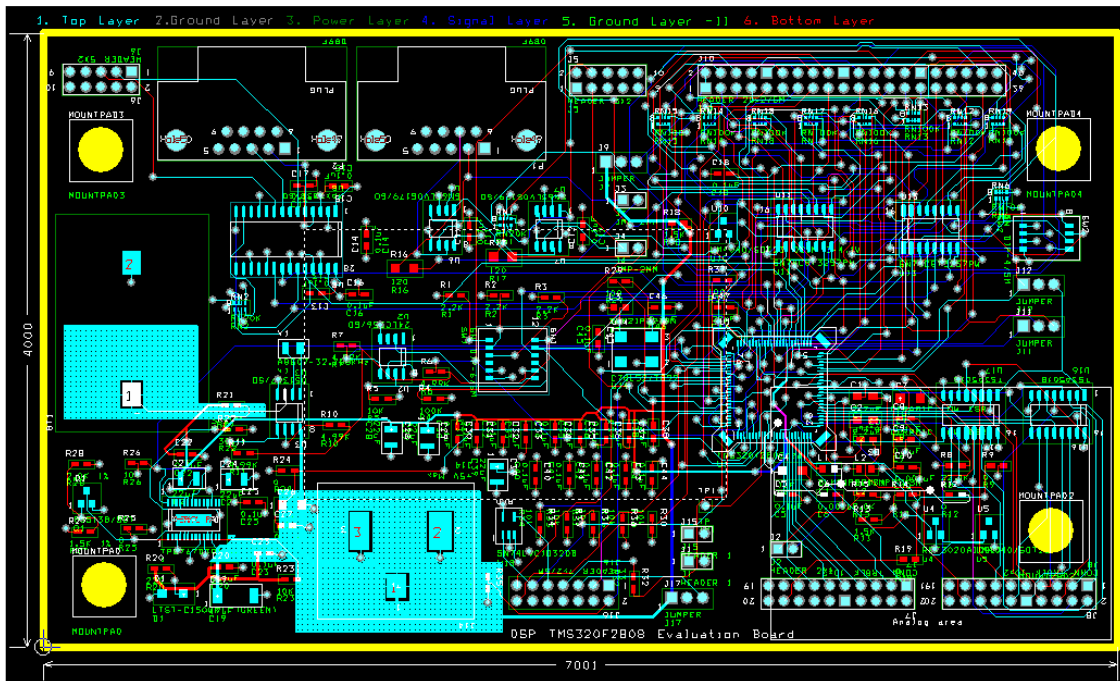


Figure 4.7 Completely routed PCB

4.1.7 Preparation of gerber files, fabrication, assembly and testing

Gerber files are one of the industry standards for accepting PCB designs for fabrication. It contains routing information for each of the layers, solder mask layers, drill sizes etc. This file was generated using OrCAD Layout and is available in

Appendix B. After fabrication and assembling the components, the PCB was tested for stability of the power signals. The integrity of the clock signals was also tested. Figure 4.8 shows the output of XCLKOUT pin of the DSP after it was powered up. The DSP was then programmed (using JTAG) to generate PWM signals.

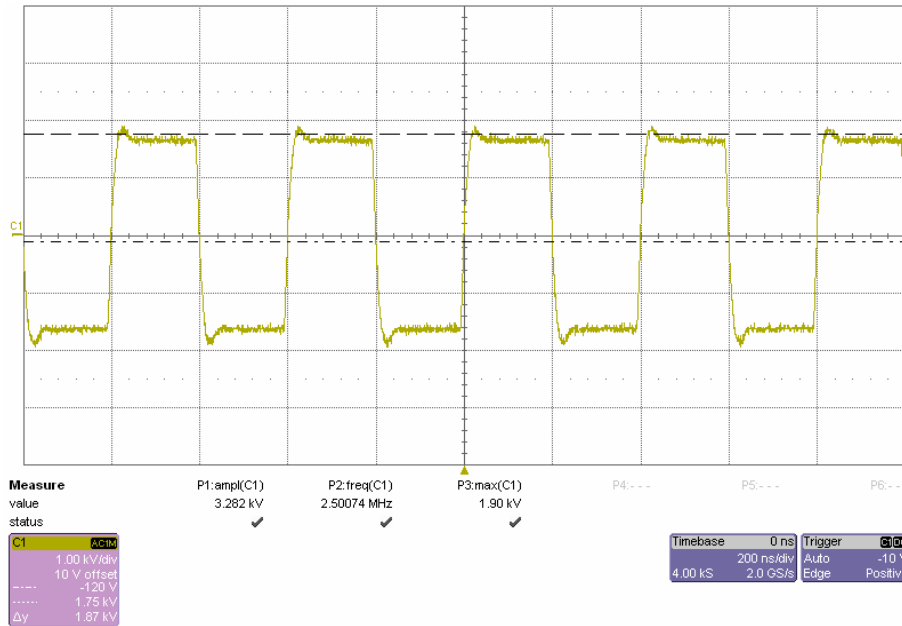


Figure 4.8 XCLKOUT in output of the custom DSP board after initial powerup

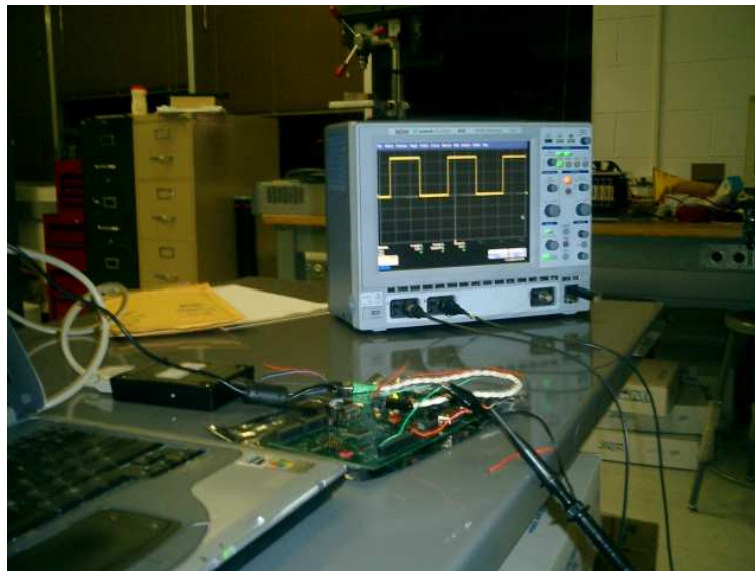


Figure 4.9 Output of custom DSP board generating PWM signals

4.2 Three Phase Inverter

The 3 phase inverter was designed given a supply DC voltage of 300V to drive a 2kW motor. Considering Space Vector PWM, the maximum peak line to line voltage achievable is 300V.

Hence $V_{\max}(\text{line-line})=300\text{V}$

$$V_{rms(\text{line-line})} = \frac{300}{\sqrt{2}} = 212.16\text{V}$$

Assume motor efficiency $M_e = 0.7$, motor power factor $M_f = 0.7$,

$$\sqrt{3}V_{rms(\text{line-line})} \cdot I_{rms(\text{line})} \cdot M_f = \text{Motor Power} \quad (4.1)$$

$$\sqrt{3} \times 212.16 \times I_{rms(\text{line})} \times 0.7 = 2000\text{W}$$

$$I_{rms(\text{line})} = 7.77\text{A}$$

$$I_{peak(\text{line})} = \sqrt{2} \cdot I_{rms(\text{line})} = \sqrt{2} \times 7.77 = 10.98\text{A}$$

In order to handle worst case scenarios in which power factor exhibits lower levels, MOSFET IRFP460PbF (VDSS=500V, ID=20A) was selected for the switches of the inverter.

Gate drive for the MOSFETs was provided using IRF2130 3 phase bridge driver. The key features of this driver are

- 1) High side can handle upto 600V.
- 2) Six gate drive outputs capable of supplying from 10V to 20V.
- 3) Compatible with CMOS and LSTTL logic inputs down to 2.5V logic.

High side gate drive supply was provided using bootstrap capacitors. The selection of bootstrap capacitors was based on the following expression [39]

$$C \geq \frac{2 \left[2Q_g + \frac{I_{qbs(max)}}{f} + Q_{ls} + \frac{I_{cbs(leak)}}{f} \right]}{V_{cc} - V_f - V_{LS} - V_{min}} \quad (4.2)$$

where

Q_g = gate charge of high side FET = 210nC [40]

$I_{cbs(leak)}$ = Bootstrap capacitor leakage current (assume = 50μA)

$I_{qbs(max)}$ = quiescent current for high side driver circuitry = 30μA [41]

Q_{ls} = level shift charge required per cycle = 5nC (500V / 600V ICs)

f = frequency of operation (assume minimum of 100Hz)

V_{cc} = supply voltage = 15V

V_f = forward voltage drop bootstrap diode = 1V

V_{min} = minimum voltage between V_B and V_S = 10V

V_{LS} = voltage drop across the low side FET (or load for high driver) = 1V

Substituting above values in equation 4.2, we get $C > 0.816\mu\text{F}$. Hence a **1μF** bootstrap capacitor is used. The schematics for the gate driver and 3 phase inverter is provided in Appendix B

4.3 Simulation results

Space Vector PWM signals were simulated in MATLAB (SIMULINK). The SVPWM line to line signals were filtered using an RC filter. Figure 4.10 shows the equivalent RC circuit used to filter the 3 PWM signals.

Input parameters used for the simulation

- 1) V_{dc} =24V %DC bus voltage
- 2) f_c =1e4Hz %Carrier frequency
- 3) f_o =100Hz % fundamental frequency
- 4) R_{fil} =2e3 ohms% filter resistance value

5) $C_{fil}=0.22e-6F$ filter capacitor value

6) $m=0.6667$ % modulation index= $V_{ref}/(V_{dc}/2)$ (4.3)

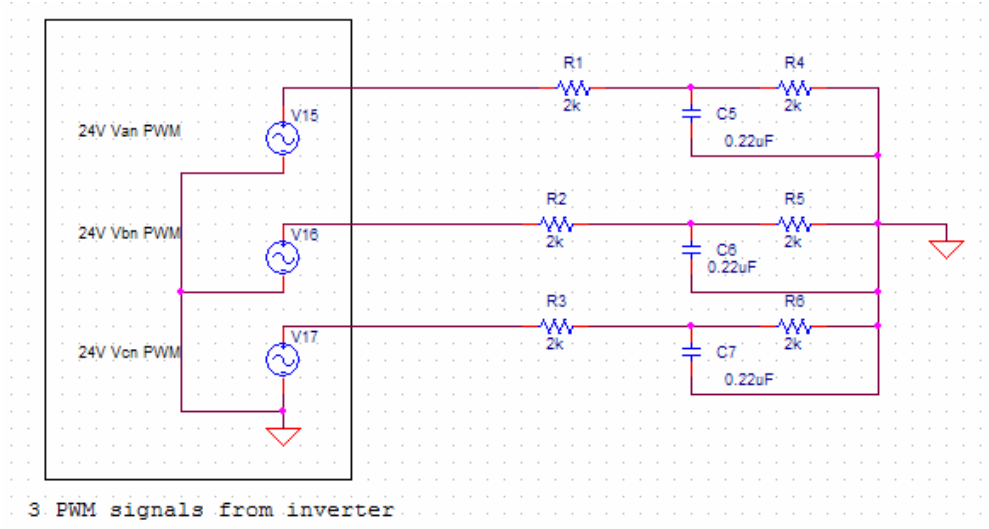


Figure 4.10 RC circuit used to filter SVPWM signals

Figure 4.11 shows the SIMULINK model of the SVPWM implementation along with the filter block. More details on the 3 phase SV PWM block is provided in Appendix B

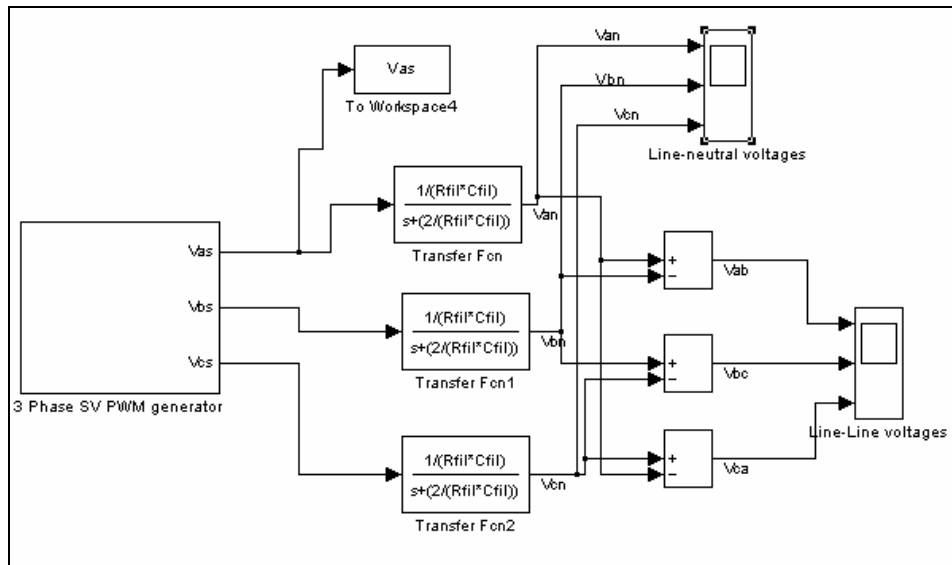


Figure 4.11 SIMULINK model of 3 phase SV PWM with filter block

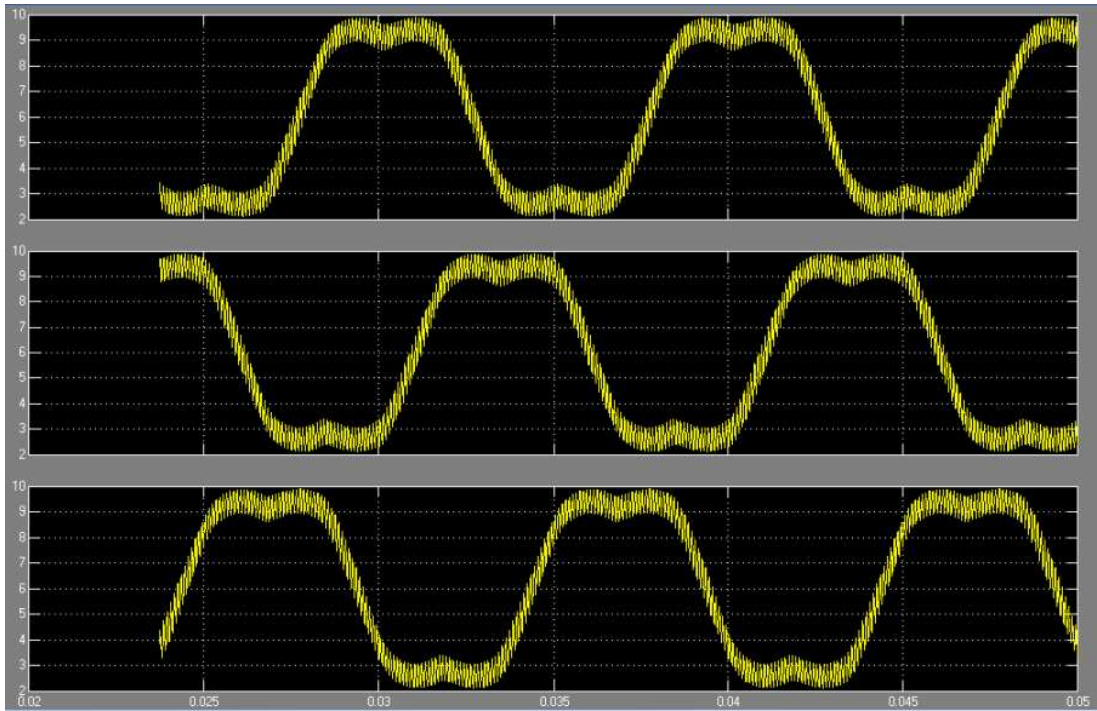


Figure 4.12 SVPWM line to neutral voltages

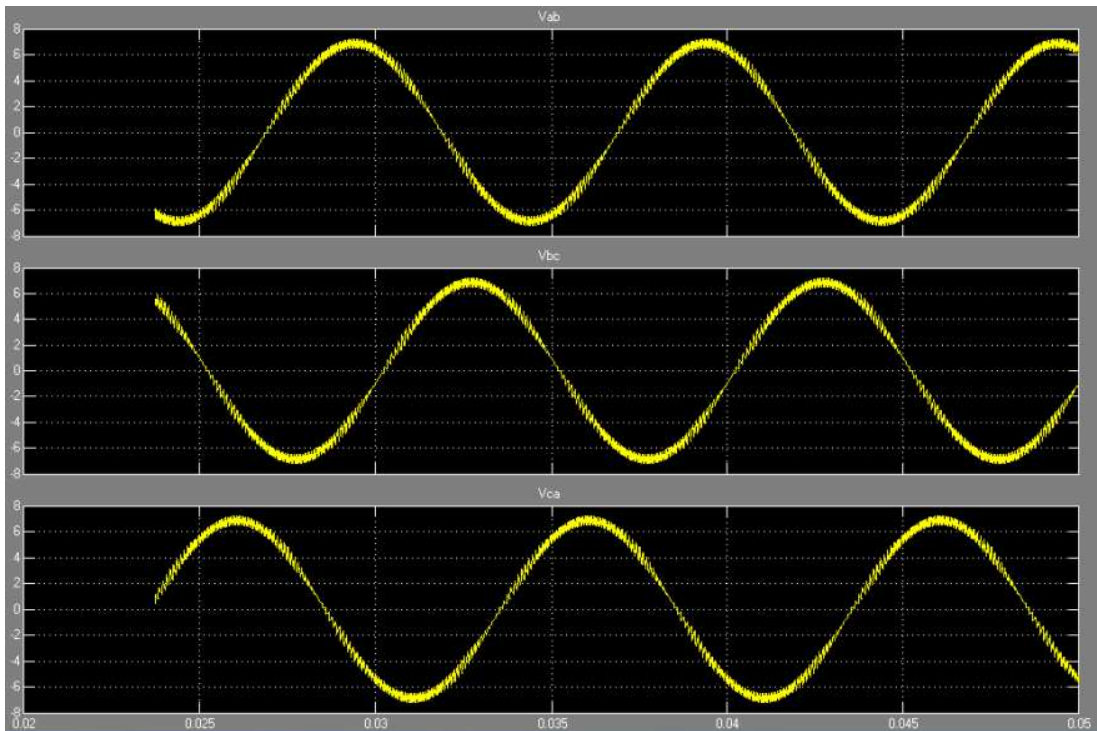


Figure 4.13 SVPWM Line to Line filtered waveforms

4.4 Experimental Results:

The input parameters used for the experimental setup was same as used for the simulation (4.3). Space Vector PWM signals were generated using the custom DSP board and provided to a 3 phase inverter. Figure 4.15 and 4.16 shows the line to neutral and line to line filtered voltage waveforms. As seen below the experimental results match the simulation waveforms.

4.5 Comparison of SVPWM, SPWM and SPWM with (1/6th) 3rd harmonic

SVPWM, SPWM and SPWM with one sixth 3rd harmonic were implemented in SIMULINK. The PWM signals were regular sampled and symmetric. Total Harmonic

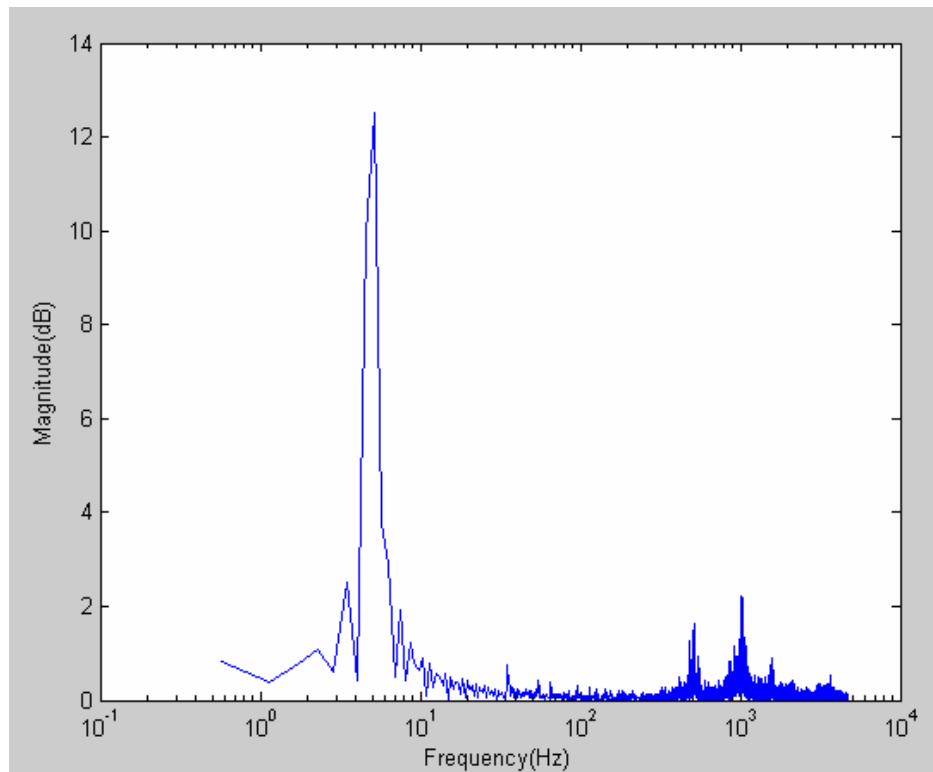


Figure 4.14 FFT of SVPWM (SIMULINK) Line to Line voltage V_{ab}

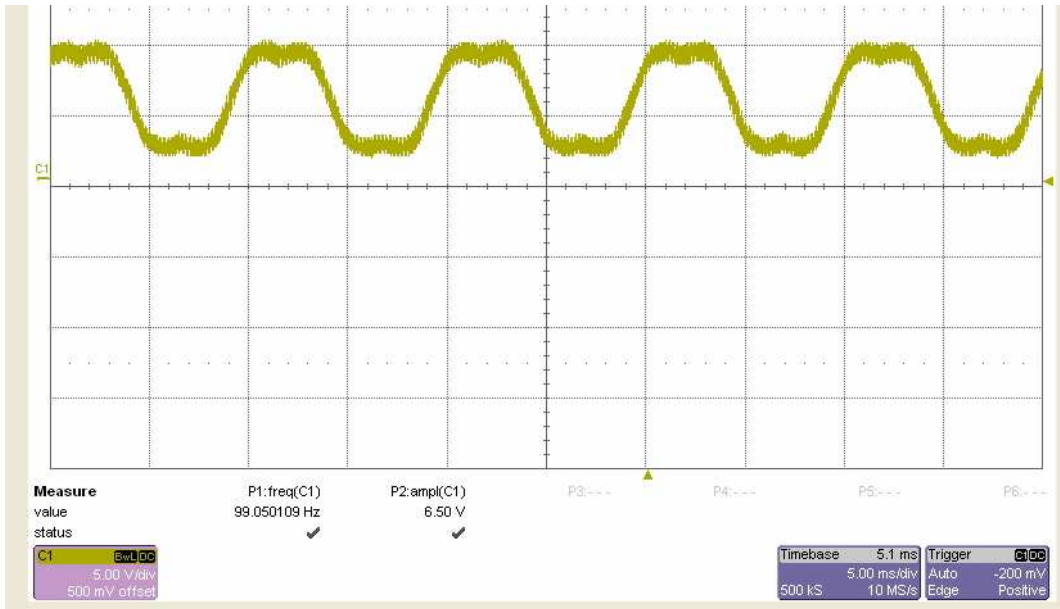


Figure 4.15 Filtered Line to neutral voltage V_{an} from 3 phase inverter

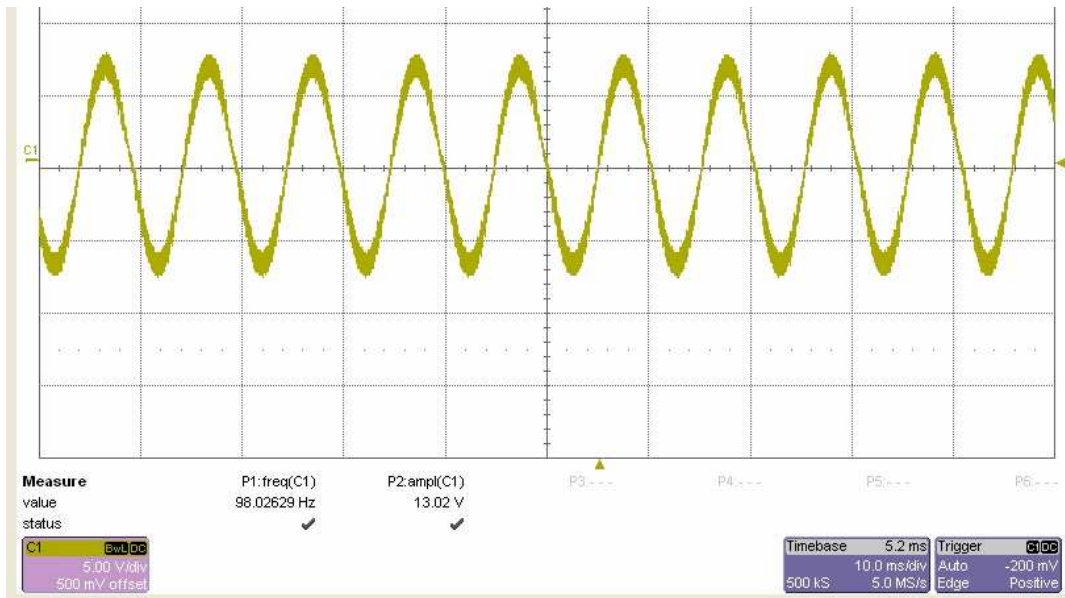


Figure 4.16 Filtered Line to Line voltage V_{ab} from 3 phase inverter

Distortion of the line to line voltage (V_{ab}) was measured using THD block of SimPowerSystems. THD is defined as [42]

$$THD = \frac{U_h}{U_1}$$

where U_h is the RMS value of the harmonics. (4.4)

$$= \sqrt{U_2^2 + U_3^2 + U_4^2 + U_5^2 + \dots + U_n^2}$$

$U_1 =$ rms value of fundamental component

Figure 4.17 shows the variation of THD with modulation index for each of the above modulation schemes. We find that the THD of all the three modulation schemes are very close to each other with SVPWM having a slightly better THD at higher modulation index values. Note that symmetric regular sampled SPWM also provides similar THD results in comparison with the other two modulation schemes.

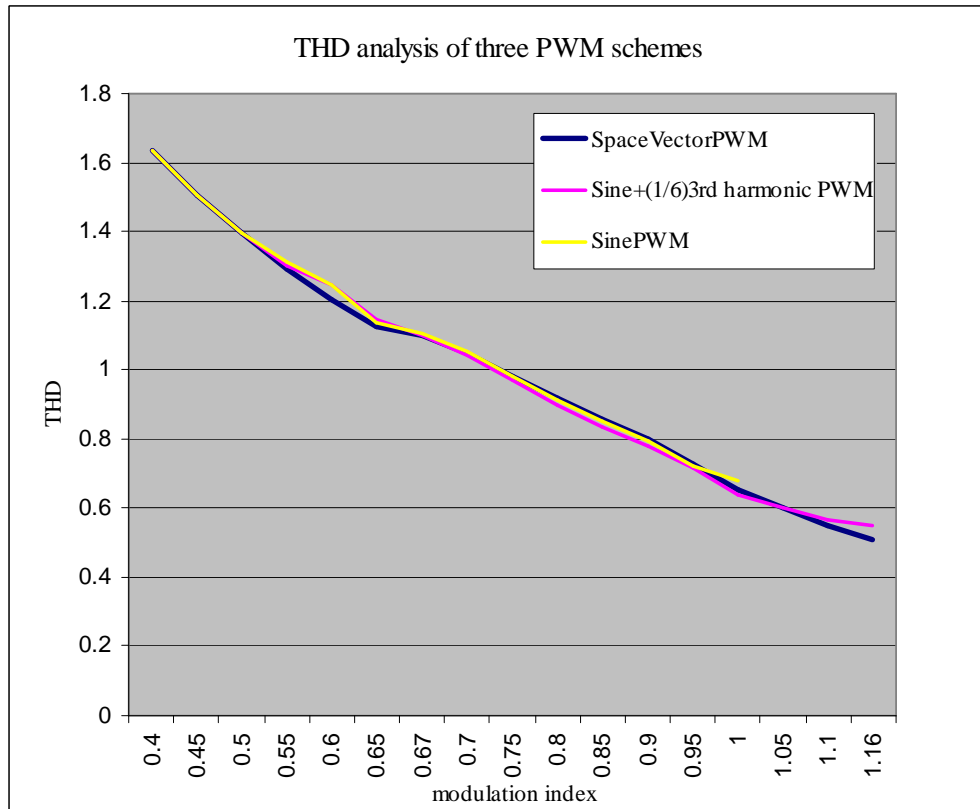


Figure 4.17 Comparison of THD of SVM, SPWM and SPWM with one sixth 3rd harmonic $f_c/f_o=10\text{kHz}/100\text{Hz}=100$

This observation is in line with the comparisons presented earlier in chapter 3. SPWM and SVPWM have identical switching patterns and hence are expected to have similar THD. The addition of one sixth third harmonic to SPWM only increased the linear modulation range ($m=1.15$); identical to the modulation range that can be achieved using SVPWM. Equal null pulse times (t_0-t_7) provided no significant advantage in THD performance. The representation of the modulation schemes (symmetric regular sampled PWM) plays a major role in determining THD. Hence Sinusoidal PWM with one sixth third harmonic injection provides similar features as Space Vector PWM, and hence is preferable due its simplicity of implementation.

CHAPTER 5

CONCLUSIONS AND FUTURE WORK

5.1 Conclusions

In this thesis the design and development of an embedded DSP controller was presented. The concepts on high speed PCB design were presented in Chapter 2. The DSP board was designed to use all the features of the TMS320F2808. During initial layout the board was divided into functional components. Though PCB design tools have the auto place feature, it is not used since manual placement is easier and better control of trace lengths can be achieved. The board had a single ground for both analog and digital signals with the analog section separated from the digital section. This was based on the fact that the return path for high frequency signals lies right beneath the trace. JTAG signals, with rise time of 500ps were found to be most sensitive to trace length. Series termination was provided to match the impedance of source and the trace.

In the second part of the thesis, a three phase inverter was designed. Space Vector PWM signals were generated using the DSP board and tested on the three phase inverter. It is seen that generation of Space Vector signals involves calculation of duty cycle times based on the sector of a rotating reference vector signal. This modulation scheme is known to better utilize the DC bus voltage and produce lesser Total Harmonic Distortion. A comparison between Sinusoidal PWM with one sixth third harmonic injection and Space Vector PWM has shown that the former modulation

scheme produces similar results as Space Vector and is favorable due to its simplicity of implementation.

5.2 Future work

The integration of power application devices like inverters, DC/DC converters on a single DSP controller board is an area for future work. This will involve careful considerations for separating power signals from electronic high frequency of the DSP. Reduced size, EMI/EMC and tolerance to external influences like vibrations are factors that would be challenging in designing an integrated DSP controller board. This would enable its pervasive use in home appliances and automotive industry.

APPENDIX A

DSP BOARD SCHEMATICS AND LAYOUT

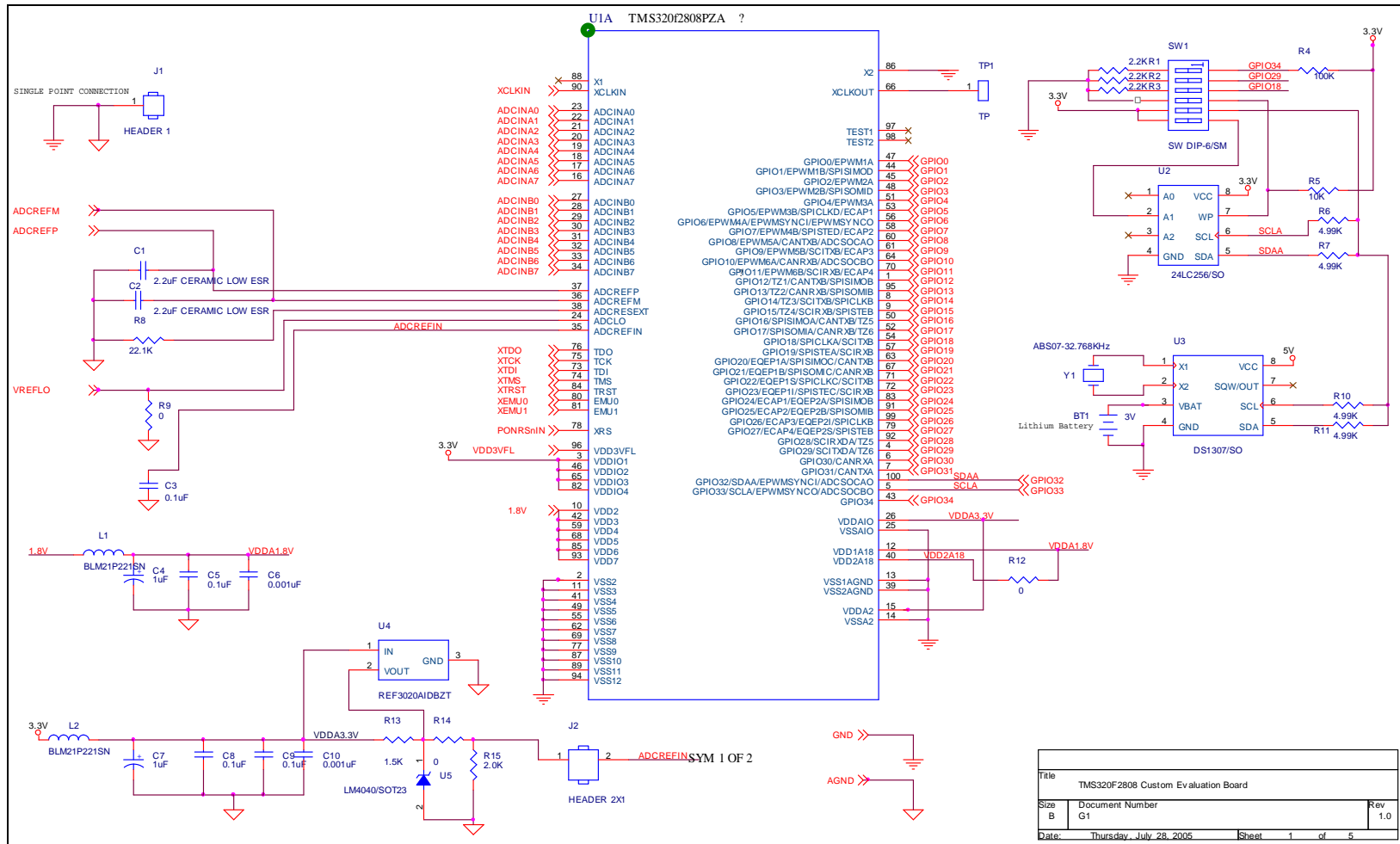


Figure A.1 OrCAD schematic: DSP interface with EEPROM, RTC and analog inputs

Title		
TMS320F2808 Custom Evaluation Board		
Size	Document Number	Rev
B	G1	1.0
Date:	Thursday, July 28, 2005	Sheet 1 of 5

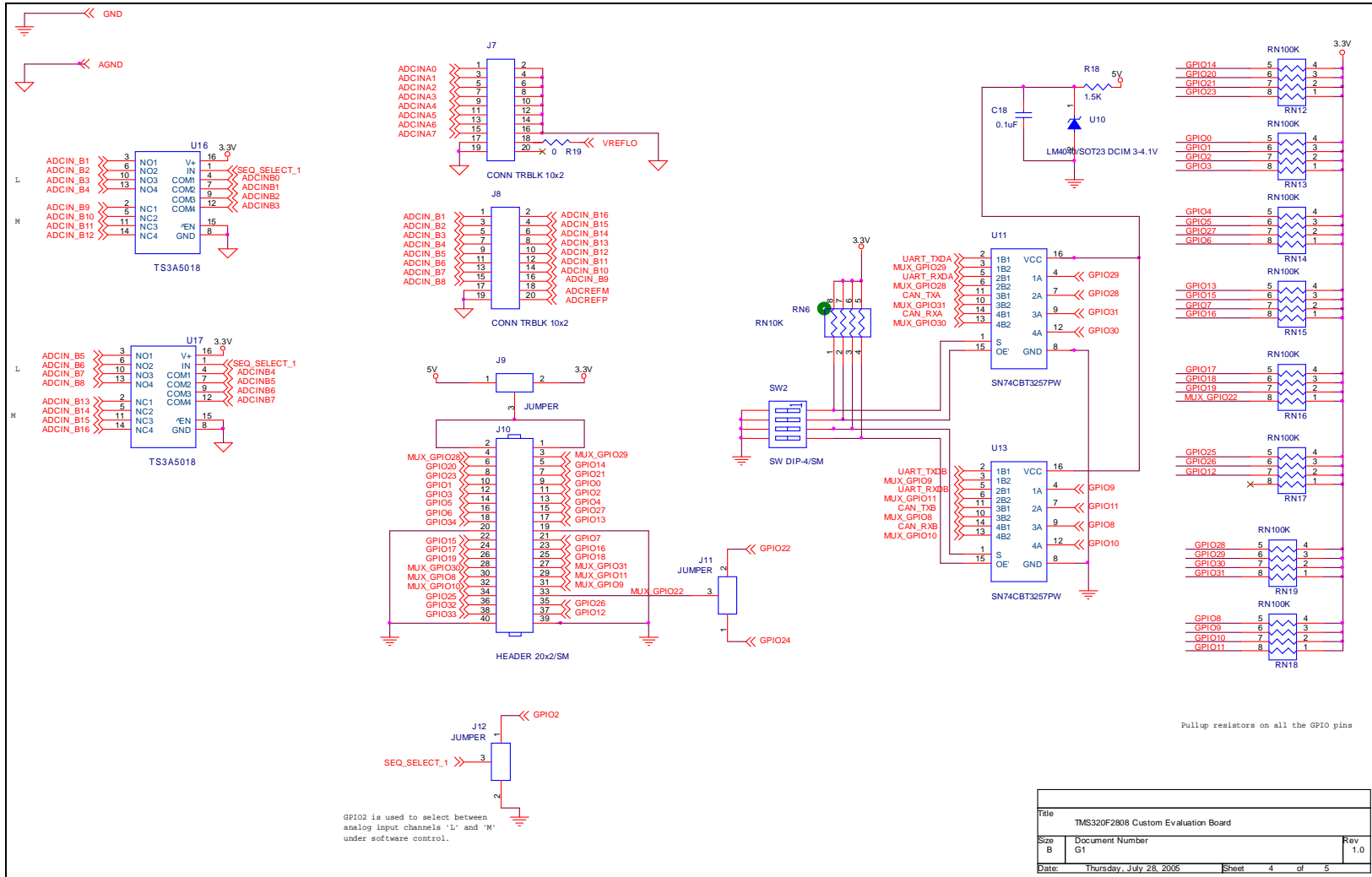


Figure A.2 OrCAD schematic: analog multiplexer, GPIO interface

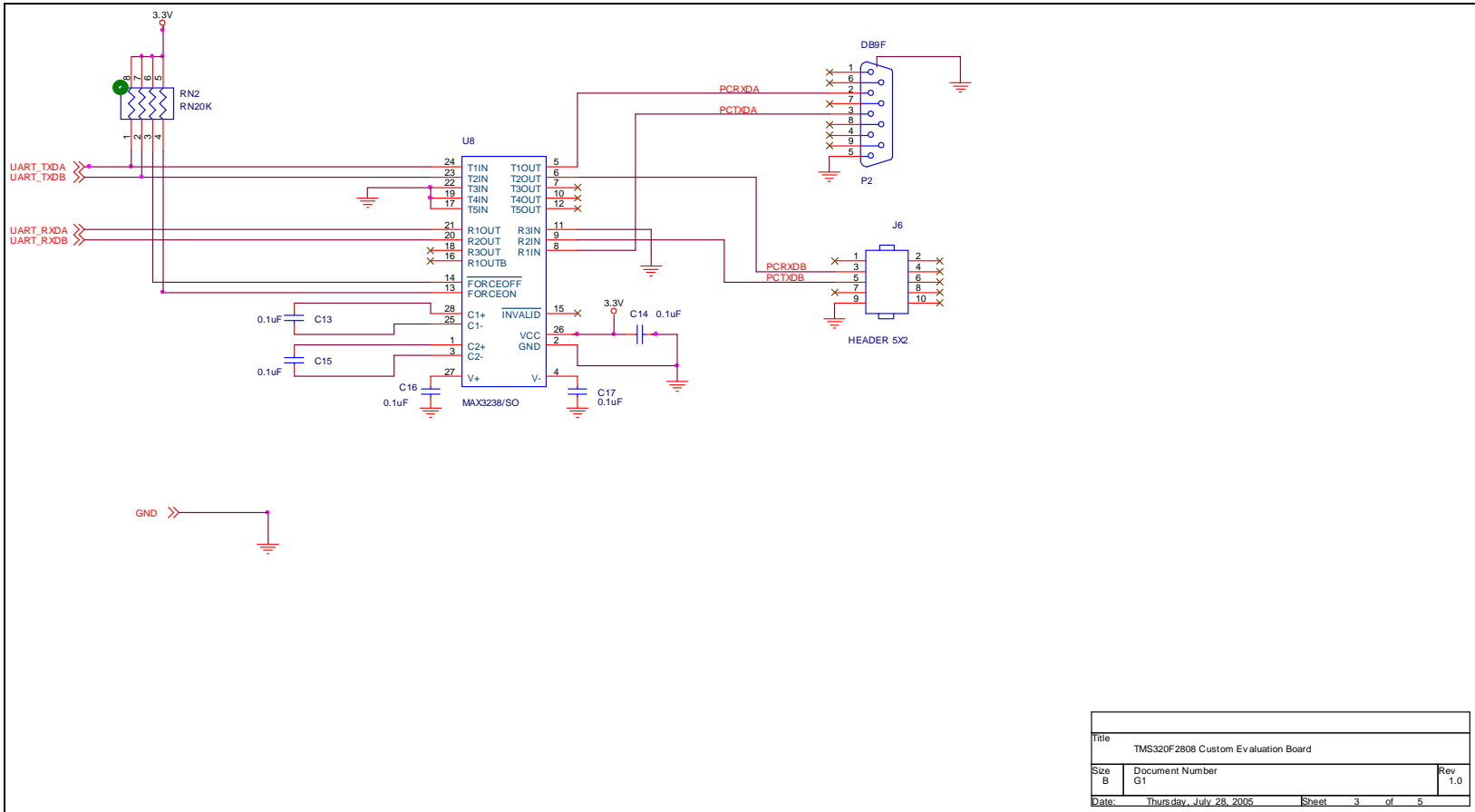


Figure A.3 OrCAD schematic: SCI interface

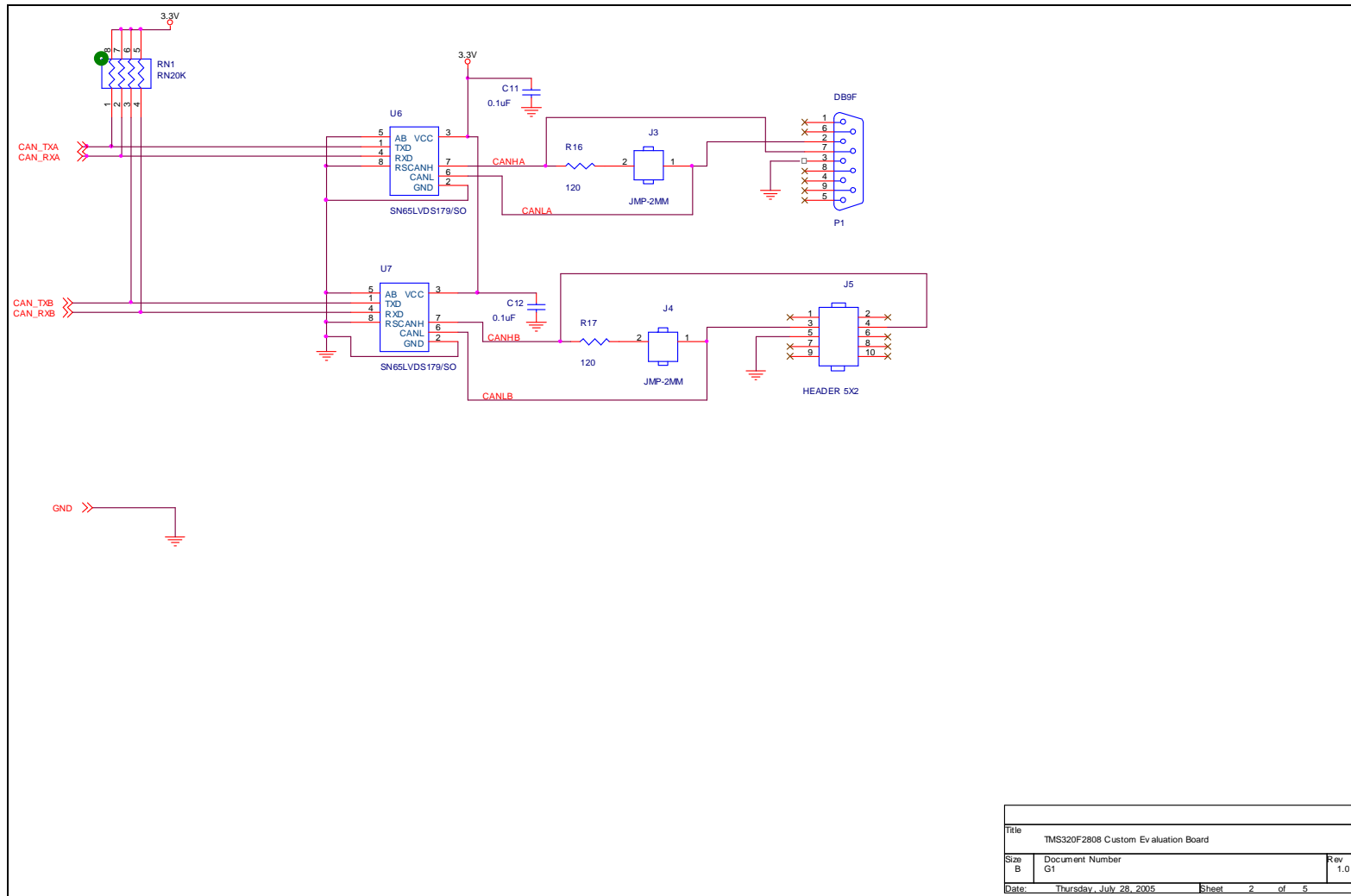


Figure A.4 OrCAD schematic: CAN interface

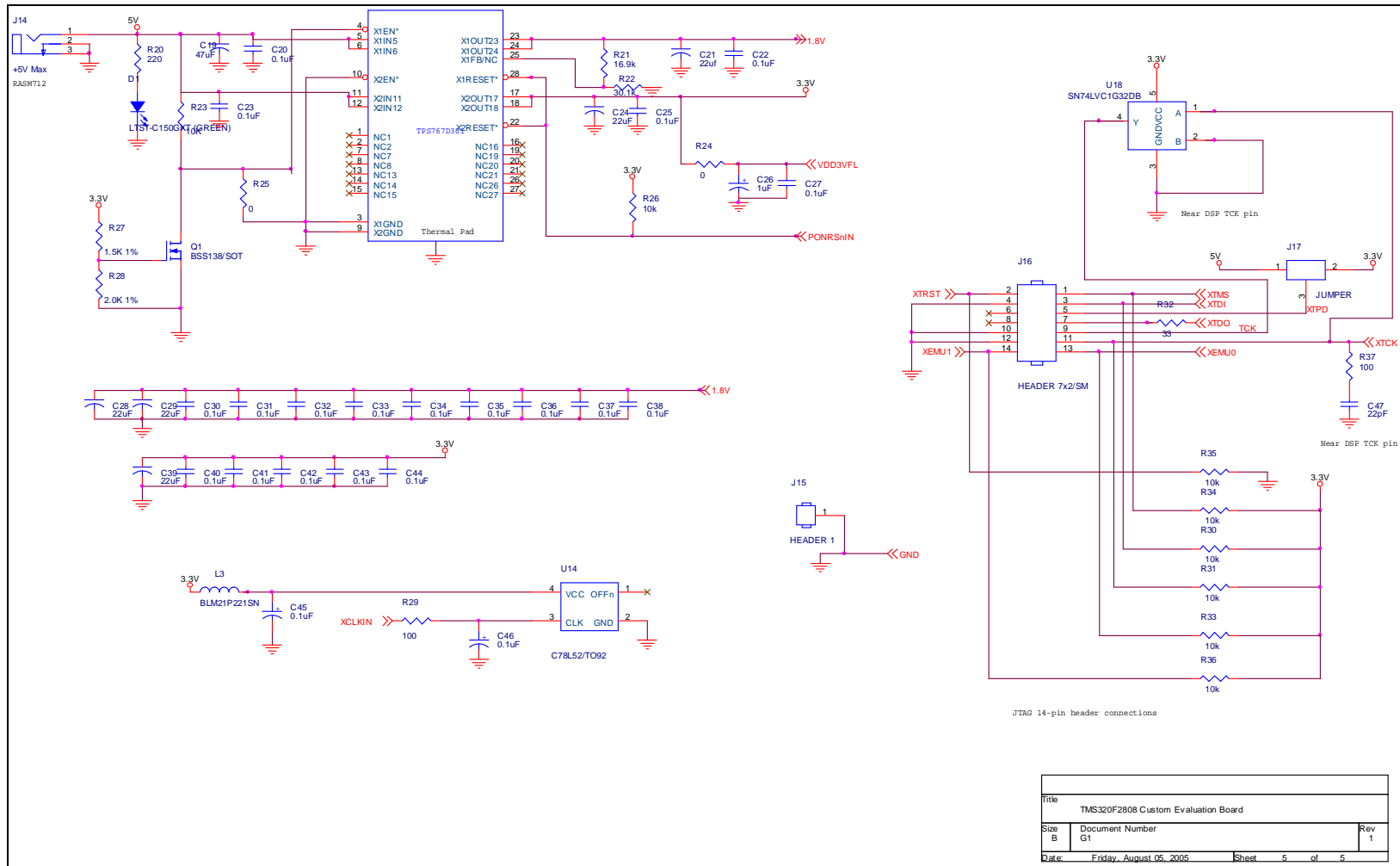


Figure A.5 OrCAD schematic: Power system, JTAG interface

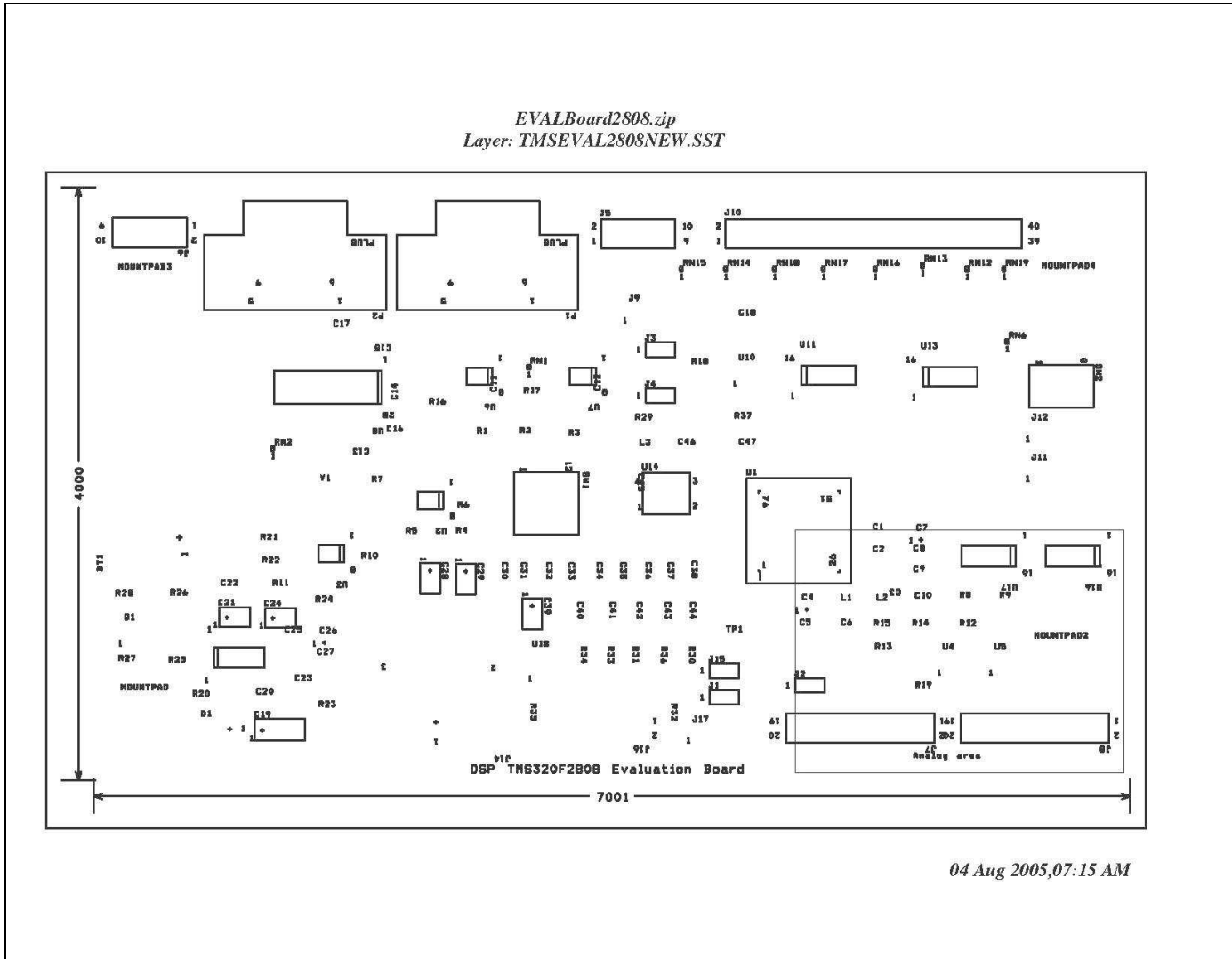
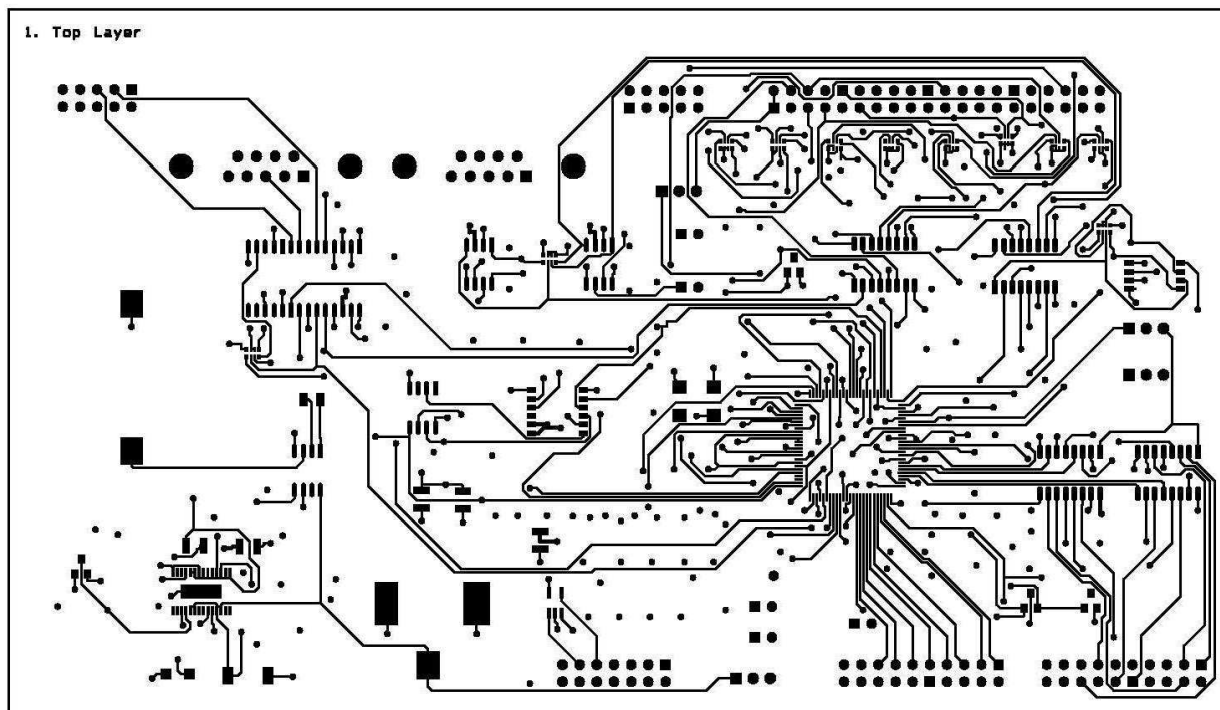


Figure A.6 OrCAD Layout: Silkscreen layer

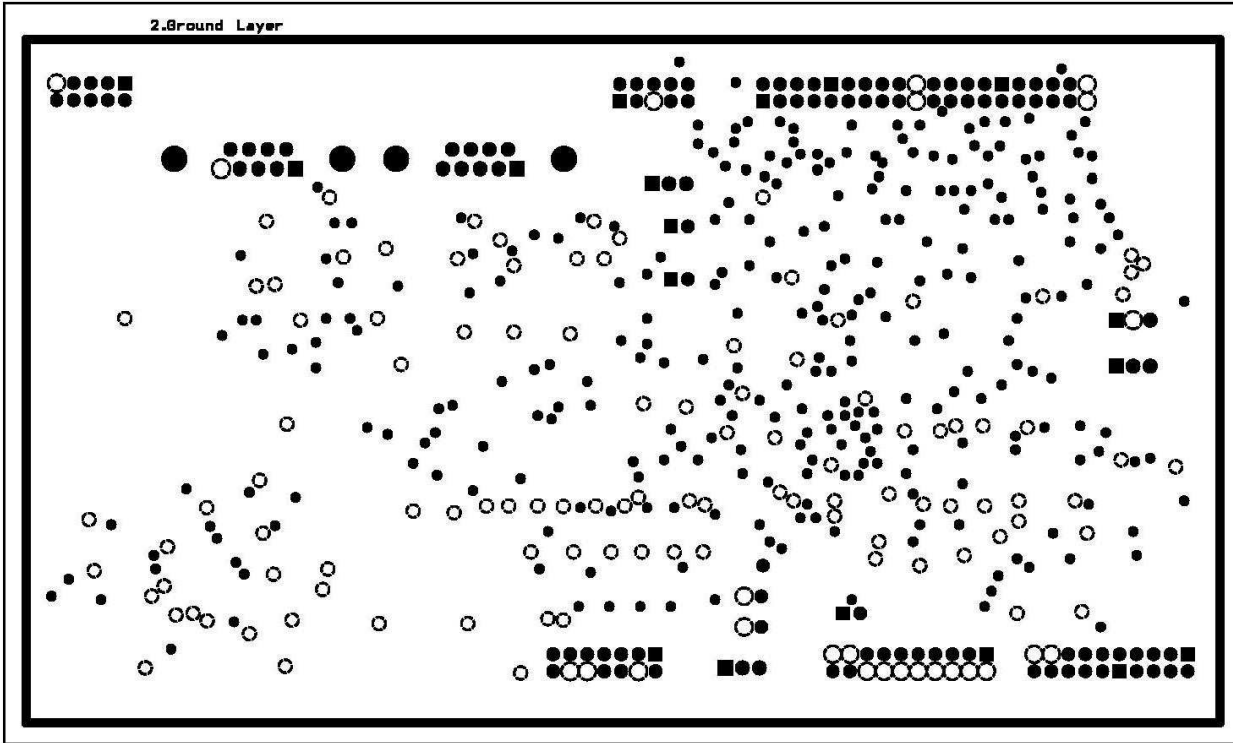
EVALBoard2808.zip
Layer: TMSEVAL2808NEW.TOP



04 Aug 2005,07:15 AM

Figure A.7 OrCAD Layout: Top layer (1)

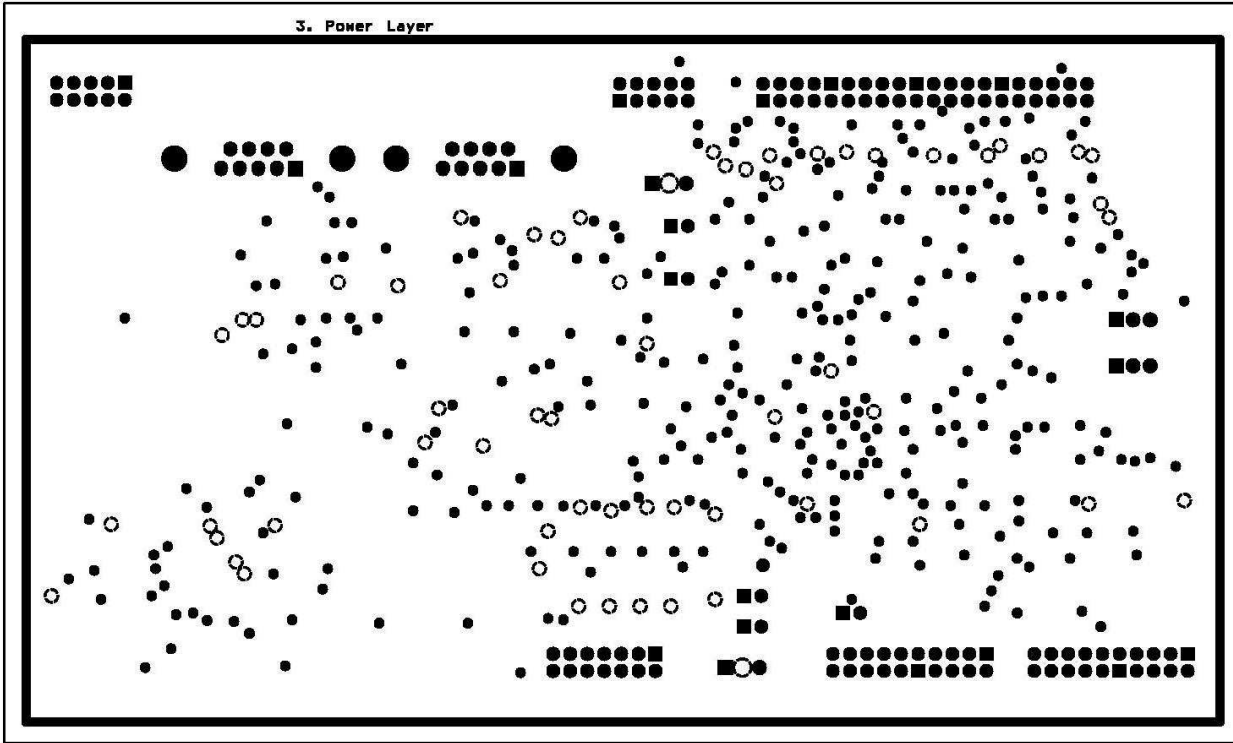
EVALBoard2808.zip
Layer: TMSEVAL2808NEW.GND



04 Aug 2005,07:15 AM

Figure A.8 OrCAD Layout: Ground layer (2)

EVALBoard2808.zip
Layer: TMSEVAL2808NEW.PWR

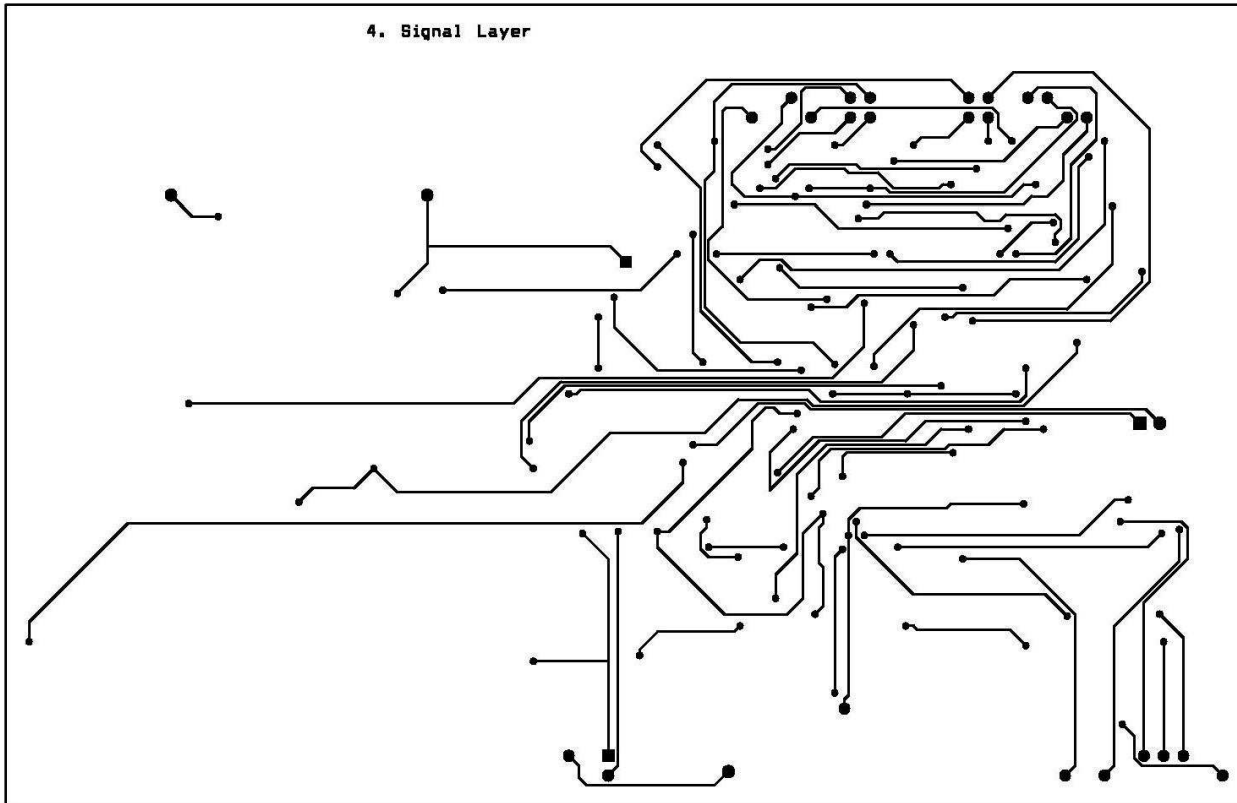


04 Aug 2005,07:15 AM

Figure A.9 OrCAD Layout: Power layer (3)

EVALBoard2808.zip
Layer: TMSEVAL2808NEW.IN2

4. Signal Layer



04 Aug 2005,07:15 AM

Figure A.10 OrCAD Layout: Signal layer (4)

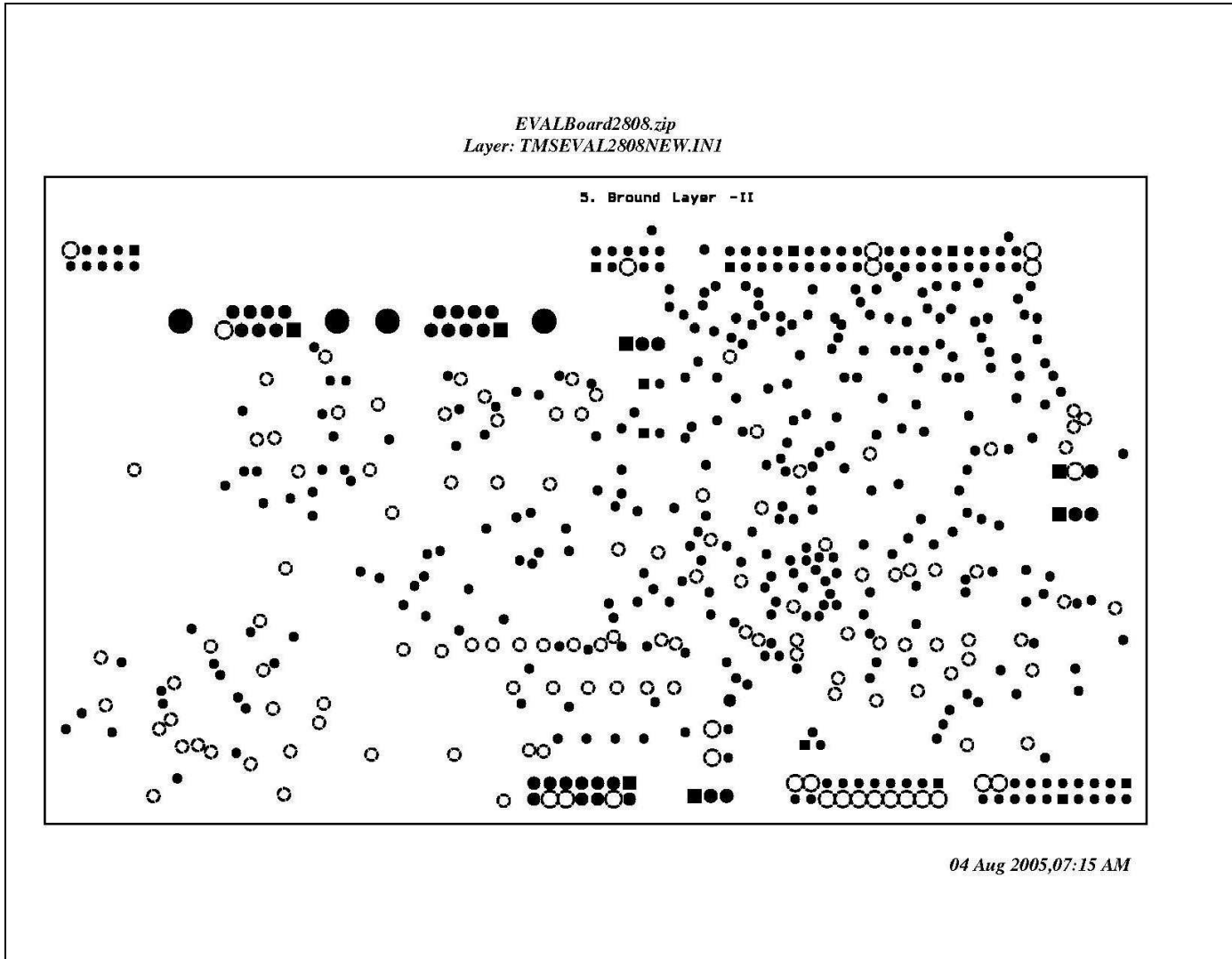


Figure A.11 OrCAD Layout: Ground layer (5)

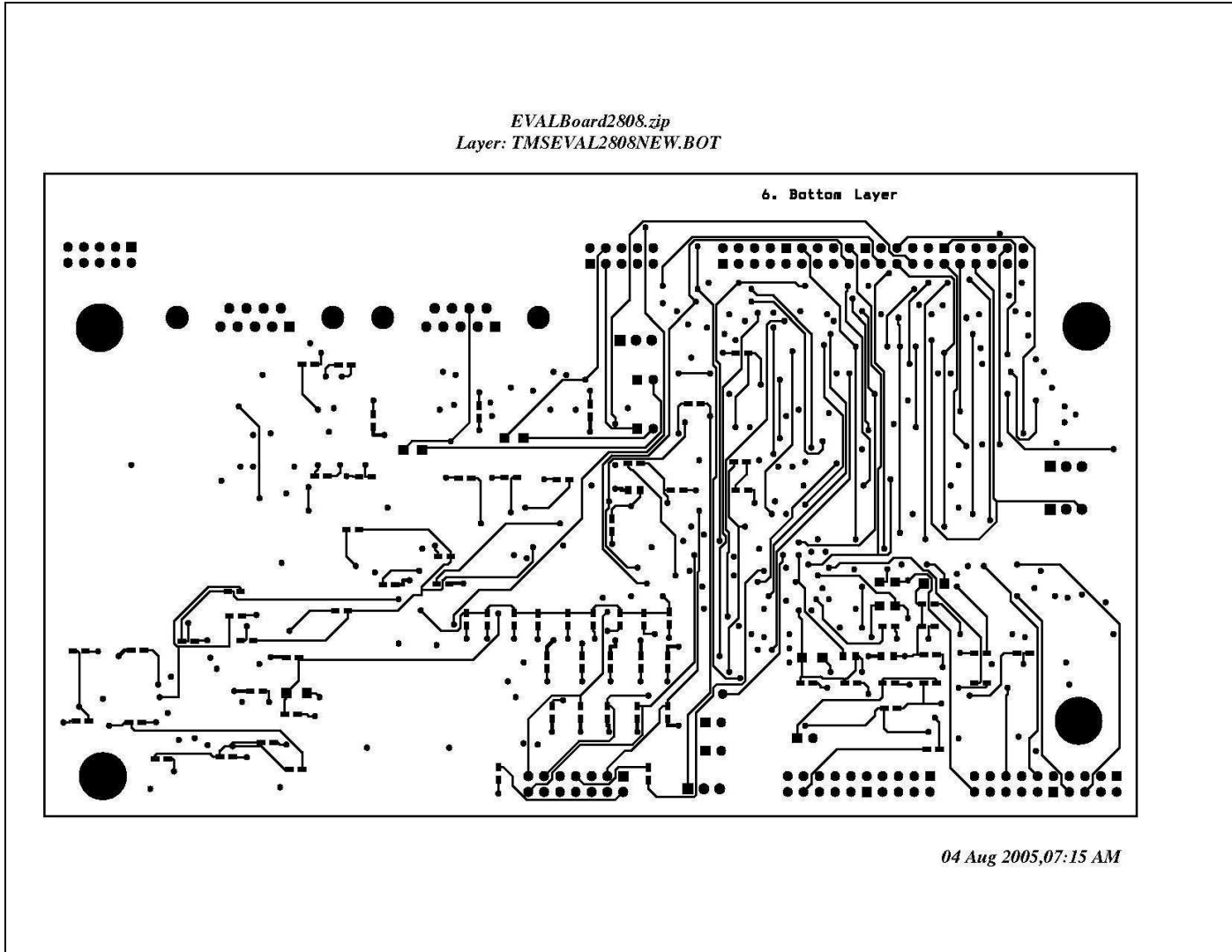


Figure A.12 OrCAD Layout: Bottom layer (6)

APPENDIX B

BILL OF MATERIALS

Serial No	Title	Mfr Name	Mfr P/N	Package	OrCAD Layout Footprint	Comments
1	IC, QFP100, DSP, TMS320F2808	Texas Instruments	TMS320F2808	PQFP-G100	quad0.5M/100/wg16.10	U1
2	IC,SO8, SERIAL EEPROM, 256K-BIT	Catalyst Semiconductor Inc	CAT24WC256J	8-Lead 150 Mil Wide SOIC (J,W)	sog.050/8/wg.244/l.200	U2
3	IC,TSOP28, RS-232 TRANSCEIVER, 10nA	Texas Instruments	MAX3238CPW	28-SOIC	sog.050/28/wg.420/l.725	U8
4	IC, SOT23, CMOS VOLTAGE REFERENCE, 2.048V	Texas Instruments	REF3020AIDBZT	SOT-23 (DBZ) 3	sm/sot23_123	U4
5	IC, SO8, TRANSCEIVER, 3.3V	Texas Instruments	SN65HVD230D	SOIC (D) 8	sog.050/8/wg.244/l.200	U6 U7
6	IC, QSOP16, QUAD 2:1 MUX/DEMUX	Texas Instruments	SN74CBT3257D	16-SOIC	sog.050/16/wg.244/l.400	U11 U13
7	IC, SSOP28, DUAL LOW DROP OUT VOLTAGE REGULATOR	Texas Instruments	TPS767D301PWP	HTSSOP(PWP) 28	htssop_pwp_28	TPS767D301
8	OSC, SMT, 24MHZ	CTS Electronics Corporation	CB3LV-3C-20.000-T	SMT (Custom) 4	sm_osc20Mhz_4pin	
9	TRANSISTOR, SOT23, MOSFET, N-CHANNEL, BSS138	ZETEX INC	BSS138TA	SOT-23 (DBZ) 3	sm/sot23_123	Q1
10	DIODE, SOT23, REFERENCE, 2.5V	National Semiconductor	LM4040CIM3-2.5	SOT-23 (DBZ) 3	sm/sot23_123	U5
11	DIODE, SOT23, REFERENCE, 4.1V	National Semiconductor	LM4040CIM3X-4.1	SOT-23 (DBZ) 3	sm/sot23_123	U10
12	LED, SMT 1206, GREEN	LITEON	LTST-C150GKT	SMT 2	sm/d_1206	D1
13	DIODE, MELFM ZENER, 6.2V, 500mW	DIODES Inc	ZMM5234B	SOD-80, mini MELF	sod80_minimelf	
14	FERRITE BEAD, SMT 0805, 220 OHMS	Murata Electronics	BLM21PG221SN1D	SMT 2	smb/l_0805	L1 L2 L3
15	CAP, CER, SMT 1206, 1uF, 16V, +/-20%, X7R	AVX Corporation	1206YC105MAT2A		smb/c_1206	C4 C7 C26
16	CAP, TANT, SMT 1311, 22uF, 6.3V	PANASONIC	ECS-T0JX226R	SMT	sm/c_tant1311	C21 C24
17	CAP, TANT, SMT 2816, 47uF, 10V	PANASONIC	ECS-T1AD476R	SMT	sm/c_tant2816	C19
18	CAP, CER, SMT 1206, 0.022uF, 50V, +/-10%, X7R	PANASONIC	ECU-V1H223KBM	SMT	sm/c_1206	
19	CAP, CER, SMT 0805, 2.2uF, 10V	TAIYO YUDEN	LMK212BJ225KG-T	SMT	smb/c_0805	C1 C2
20	CAP, CER, SMT 0603, 22pF, 50V, +/-5%, NPO	PANASONIC	ECU-V1H220JCV	SMT	sm/c_0603	C47

21	CAP, CER, SMT 0603, 0.001uF, 50V, +/-10%, X7R	AVX Corporation	06035C102KAT2A	SMT	sm/c_0603	C6 C10
22	CAP, CER, SMT 0603, 0.1uF, 16V, +/-10%, X7R	KEMET Electronics Corporation	C0603C104K4RAC	SMT	sm/c_0603	C3 C5 C8 C9 C18 C13 C15C16 C17 C14 C11 C12 C20 C23 C22 C25 C27 C30 C31 C32 C33 C34 C35 C36 C37 C38 C40 C41 C42 C43 C44 C45 C46
23	RES, NETWORK, SMT, 8 PIN, 4 RES, 20K OHM, 5%, 1/16 WATT	PANASONIC	EXB-28V203JX	SMT 8	smt_rn8pin	RN2
24	RES, NETWORK, SMT, 8 PIN, 4 RES, 100K OHM, 5%, 1/16 WATT	PANASONIC	EXB-28V104JX	SMT 8	smt_rn8pin	RN12 RN13 RN14 RN15 RN16 RN17 RN18 RN19
25	RES, SMT 1206 , 121 OHM, 1%, 1/8 WATT	PANASONIC	ERJ-8ENF1210V	SMT	sm/r_1206	R16 R17 R24 R25
26	RES, SMT 0603 , 0 OHM, 1%, 1/16 WATT	KOA SPEER ELECTRONICS, INC	RM73Z1J000	SMT	smb/r_0603	R9 R14 R12 R25
27	RES, SMT 0603 , 220 OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3GSYJ221V	SMT	sm/r_0603	R20
28	RES, SMT 0603 , 33 OHM, 1%, 1/16 WATT	KOA SPEER ELECTRONICS, INC	RM73B1JT33RJ	SMT	sm/r_0603	
29	RES, SMT 0603 , 2.2K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3GEYJ222V	SMT	sm/r_0603	R1 R2 R3
30	RES, SMT 0603 , 22K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3GEYJ223V	SMT	smb/r_0603	R8
31	RES, SMT 0603 , 100 OHM, 1%, 1/16 WATT	ROHM CORPORATION	MCR03F1000EZP	SMT	sm/r_0603	R29 R37
32	RES, SMT 0603 , 20K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3EKF2002V	SMT	sm/r_0603	
33	RES, SMT 0603 , 1.5K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3EKF1501V	SMT	sm/r_0603	R13 R18 R27
34	RES, SMT 0603 , 10K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3EKF1002V	SMT	sm/r_0603	R23 R26 R35 R34 R31 R33 R36 R30

35	RES, SMT 0603 , 16.9K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3EKF1692V	SMT	sm/r_0603	R5 R21
36	RES, SMT 0603 , 2K OHM, 1%, 1/16 WATT	ROHM CORPORATION	MCR03F2001EZP	SMT	sm/r_0603	R15 R28
37	RES, SMT 0603 , 30.1K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3EKF3012V	SMT	sm/r_0603	R22
38	RES, SMT 0603 , 100K OHM, 1%, 1/16 WATT	ROHM CORPORATION	MCR03F1003EZP	SMT	sm/r_0603	R4
39	RES, SMT 0603 , 4.99K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3EKF4991V	SMT	sm/r_0603	R6 R7 R10 R11
40	RES, SMT 0603 , 9.09K OHM, 1%, 1/16 WATT	PANASONIC	ERJ-3EKF9091V	SMT	sm/r_0603	
41	SWITCH, DIP, SMT, HALF-PITCH, 4 POS	C&K/UNIMAX, INC	TDA04HOSK1	SMT	sm/sw_dip_4	SW2
42	SWITCH, DIP, SMT, HALF-PITCH, 6 POS	C&K/UNIMAX, INC	TDA06HOSK1	SMT	sm/sw_dip_6	SW1
43	HEADER, 2X1, VERTICAL, 2mm	SPECTRUM DIGITAL INC		SMT	blkcon0.100/vh /tm1sq/w.100/2	J1 J2 J3 J4
44	HEADER, 5X2, VERTICAL, PIN	SPECTRUM DIGITAL INC		SMT	blkcon0.100/vh /tm20e/w.200/10	J5 J6 J15
45	CONN, DB9, FEMALE, RIGHT ANGLE, 0.318	KRISTA	24-326		dsub/rp.318/tm/9	P1 P2
46	CONN, SMT, JACK, RIGHT ANGLE, POWER, 2.5MM	SWITCHCRAFT	RASM712TR15	SMT	sm/power_connector	J14
47	HEADER, 7X2, VERTICAL, PIN	SAMTEC INC		SMT	sm/jtag_14_header	J16
48	IC, SOIC 8 REAL TIME CLOCK	Dallas Semiconductors	DS1307	SMT	sog.050/8/ wg.244/l.200	U3
49	IC SMT 2 , 32.768KHz	ABACON Corporation	ABS07	SMT	SM/RTC_ABS07	Y1
50	Battery, SMT 3V Lithium,	Meritline	CR2016	SMT	sm/bat_hold	BT1
51	HEADER, 10X2, VERTICAL, PIN			SMT	BLKCON.100/VH/ TM2OE/W.200/20	J7 J8
52	HEADER, 20X2, VERTICAL, PIN			SMT	BLKCON.100/VH/ TM2OE/W.200/40	J10
53	JUMPER, 3pin	SAMTEC INC	TSW-103-07-LS	SMT	SM/3PIN_JUMPER	J9 J11 J12
54	IC, SMT 16pin Analog MUX	Texas Instruments	TS3A5018D	SMT	SOG.050/16/ WG.244/L.400	U16 U17

APPENDIX C

SIMULINK SPACE VECTOR PWM
BLOCK DIAGRAM

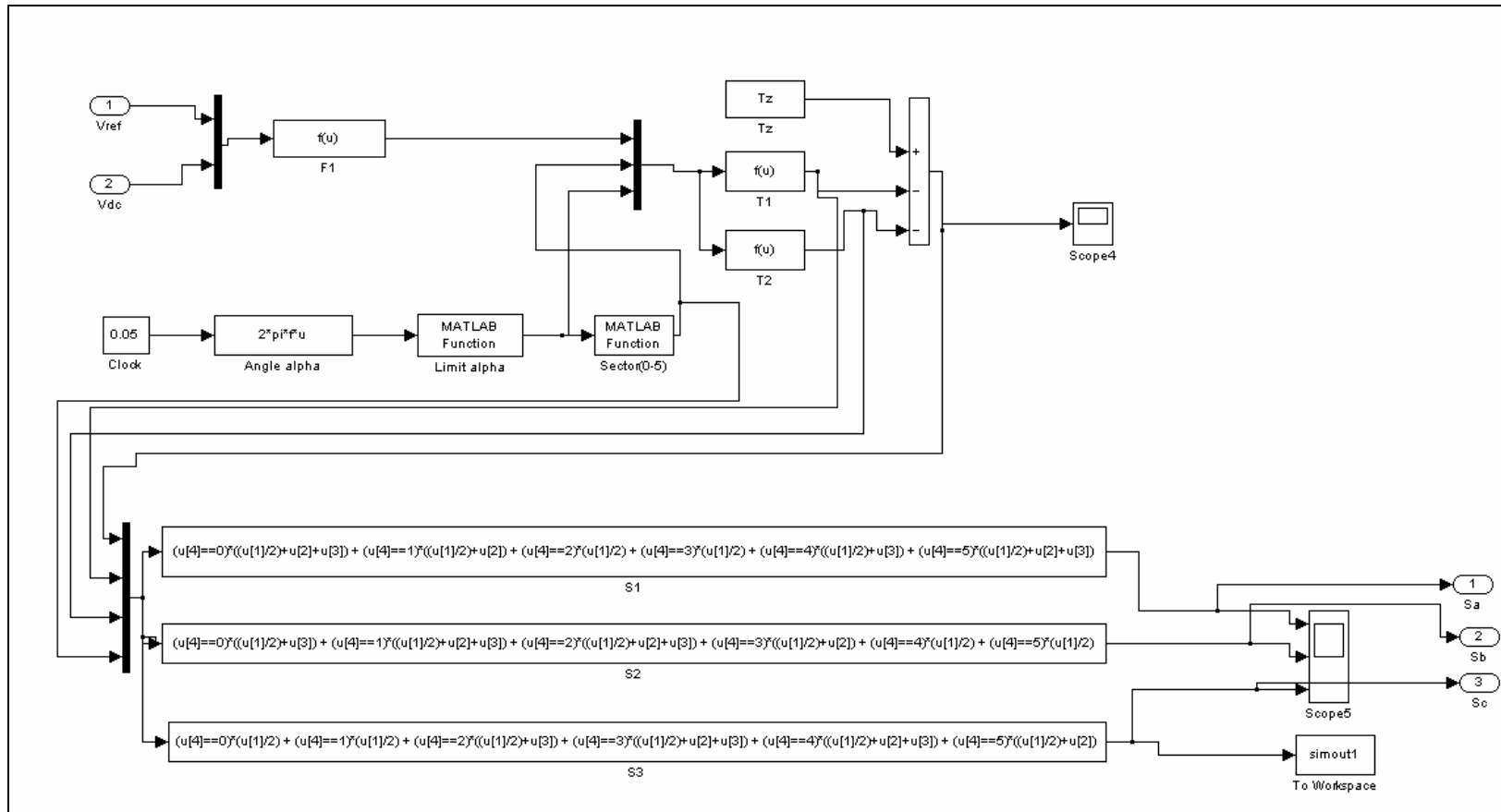


Figure C.1 Simulink model: Space Vector implementation [32]

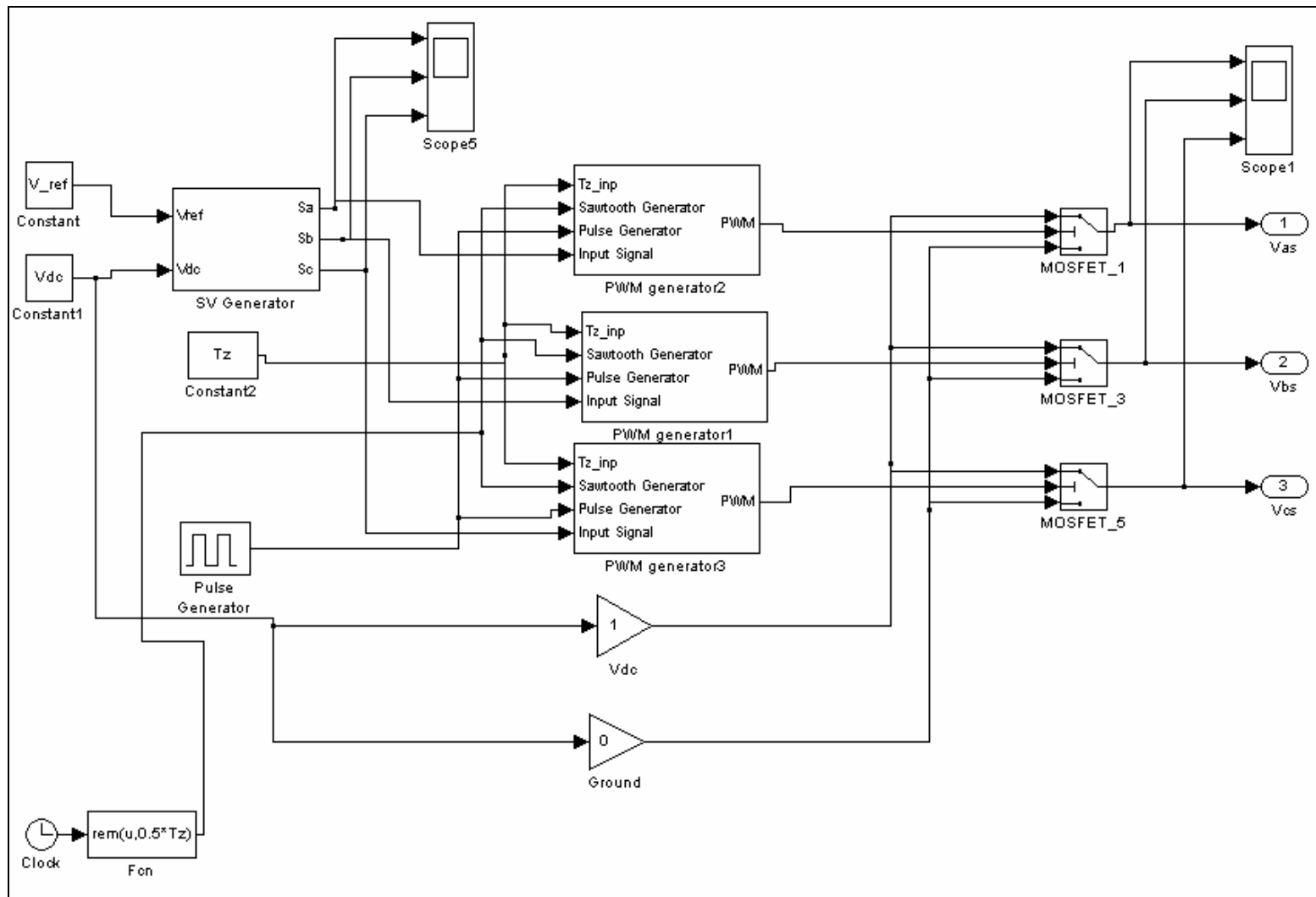


Figure C.2 Simulink model: Space Vector with PWM generator and MOSFETs

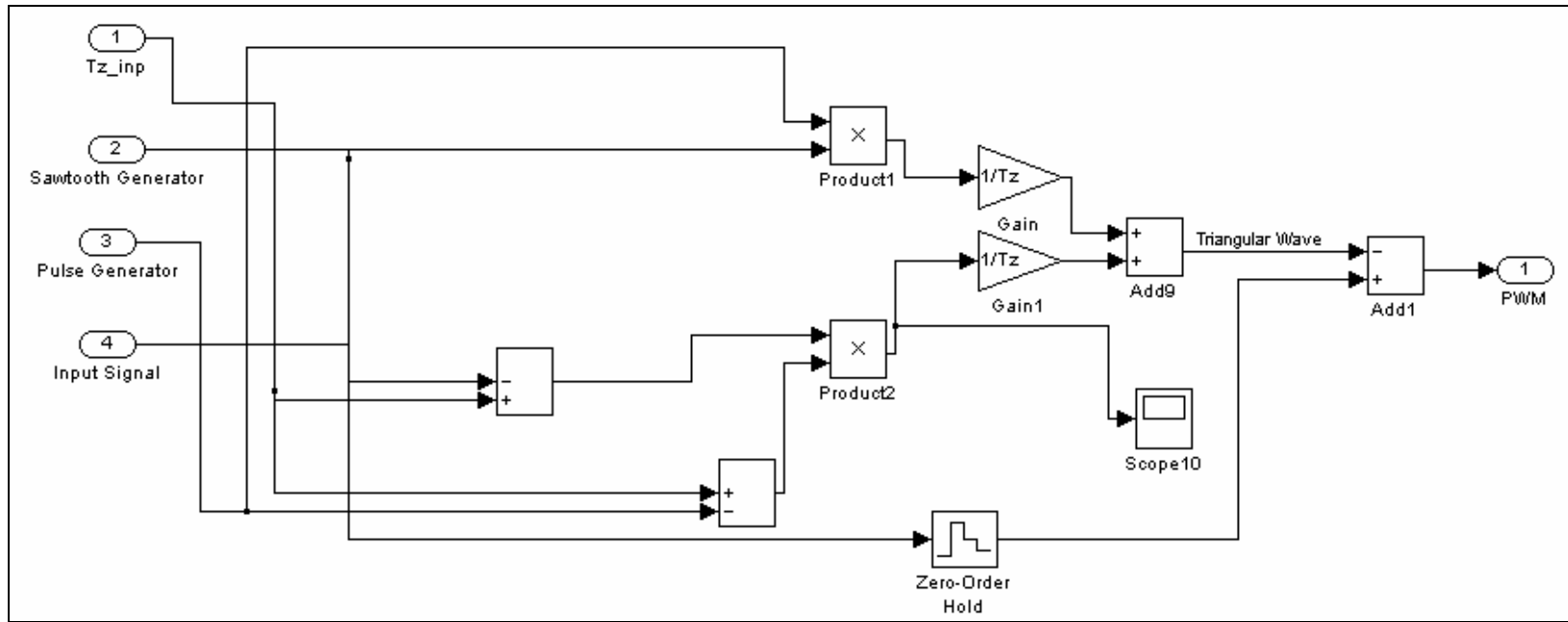


Figure C.3 Simulink model : Regular sampled symmetric PWM generator

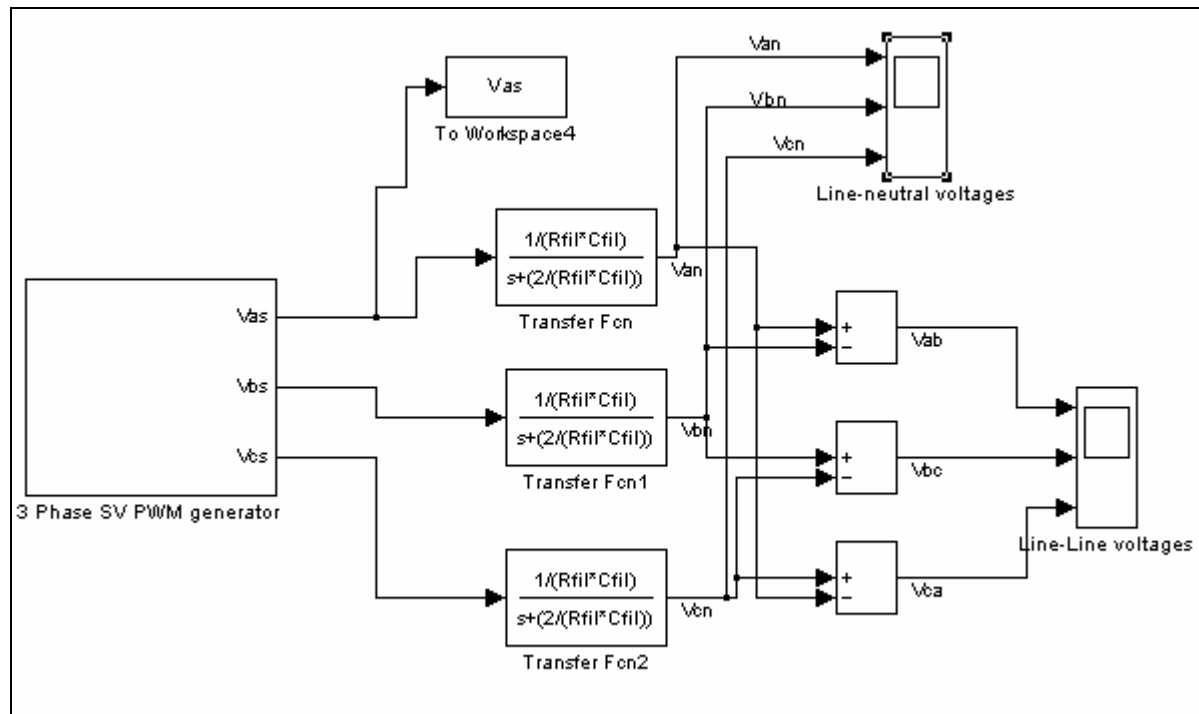


Figure C.4 Simulink model: RC filtered line to line voltage generation

APPENDIX D

THREE PHASE INVERTER SCHEMATICS

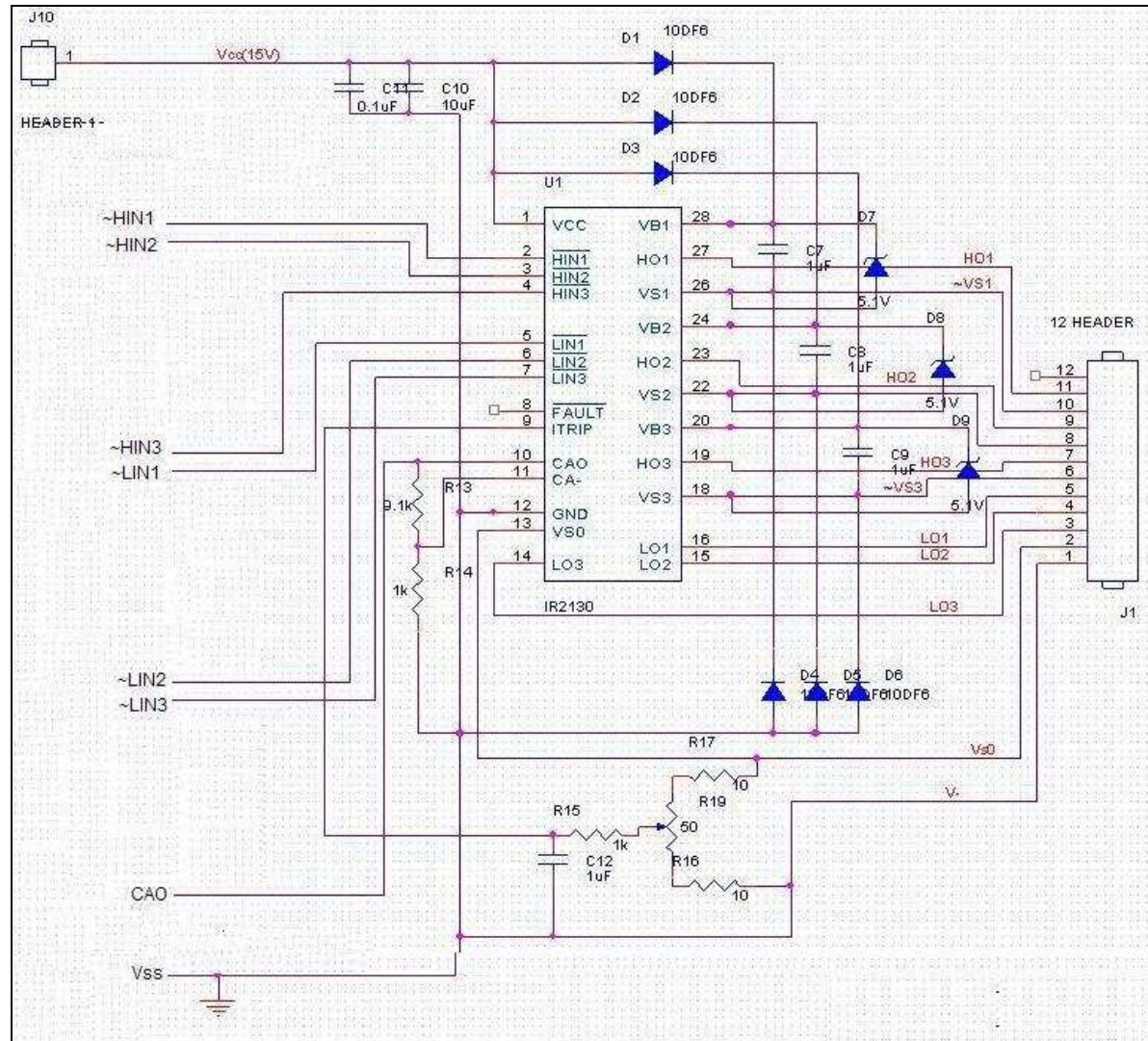


Figure D.1 IR2130 gate driver schematic [43]

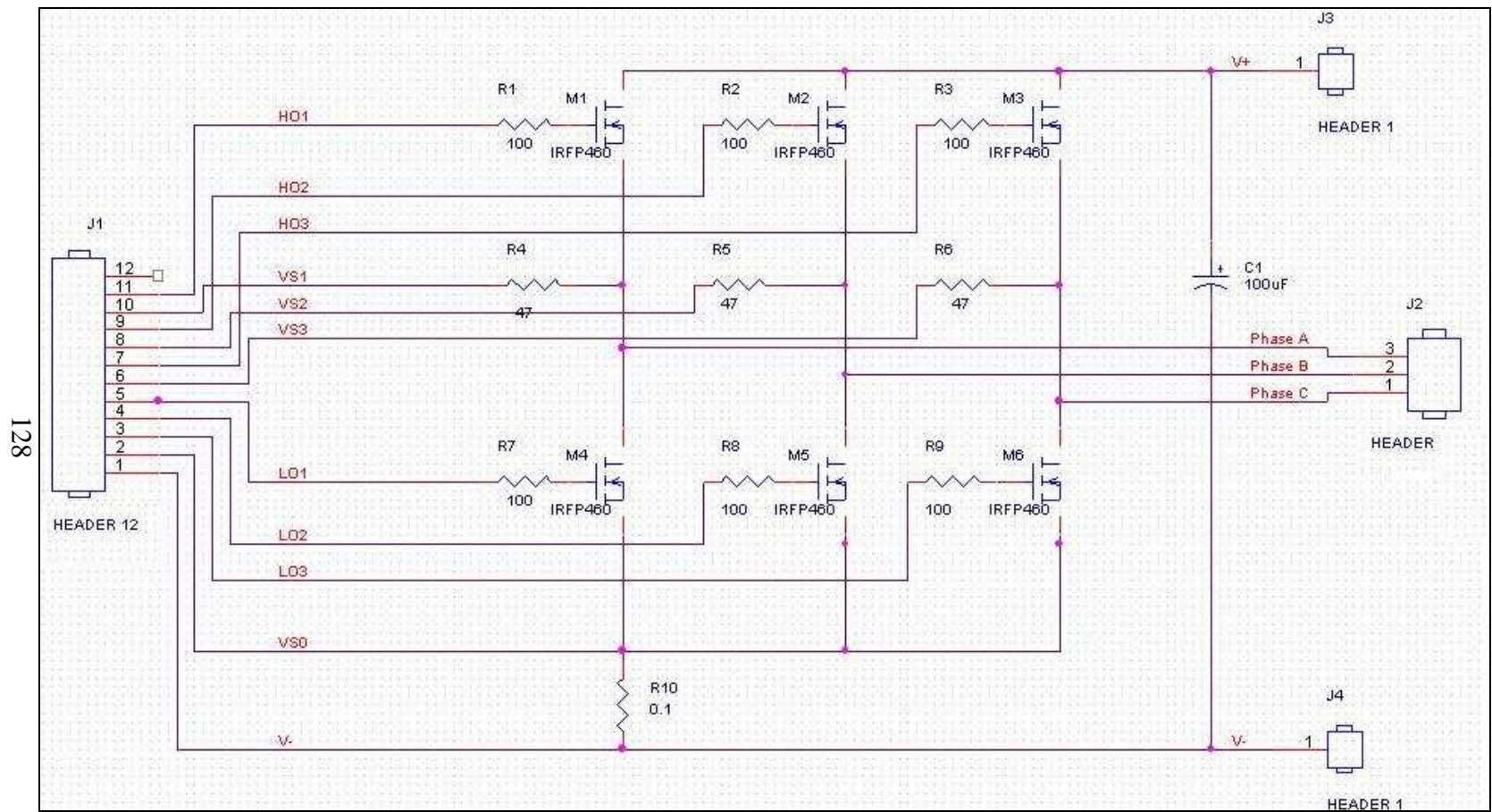


Figure D.2 Three phase inverter schematic

APPENDIX E

SPACE VECTOR PWM CODE

```

//*****
//
// FILE:    VSI_SpaceVectorPWM.c
//
// TITLE:   This program generates Space Vector PWM signals on outputs
//          ePWM1,ePWM2 and ePWM3
//
//
// DESCRIPTION:
//*****
// Developer: Harish Raman
// Created on: 18th Jan, 2006;
// Updated on: 4th Mar 2006
// Changes done: 1) corrected error in sector times
//              2) changed PWM frequency to 10kHz
// (enhanced PWM generation code obtained from TI 280x examples)
//*****

#include "DSP280x_Device.h"    // DSP280x Headerfile Include File
#include "DSP280x_Examples.h"  // DSP280x Examples Include File
#include "math.h"

// Prototype statements for functions found within this file.
void InitEPwm1(void);
void InitEPwm2(void);
void InitEPwm3(void);
void InitSpaceVector(void);
interrupt void epwm1_isr(void);
interrupt void epwm2_isr(void);
interrupt void epwm3_isr(void);

// Global variables used in this example
Uint32  EPwm1TimerIntCount;
Uint32  EPwm2TimerIntCount;
Uint32  EPwm3TimerIntCount;
Uint16  iFund_freq;           // fundamental frequency of required output
Uint16  iV_Ref;              // reference voltage - peak voltage of output
Uint16  iV_Dc;               // DC bus voltage
float   fTz;                  // sampling period
float   fTz_incr;            // temp variable to store temp increment of Tz

```

```
float  fAlpha;           // angle of space vector
int    iSector;         // sector number
float  fT0;             // time T0;
float  fT1;             // time T1;
float  fT2;             // time T2;
float  fS0;             // time of Switch 1(fS0/fTz=duty cycle for ePWM1)
float  fS1;             // time of Switch 2(fS1/fTz=duty cycle for ePWM2)
float  fS2;             // time of Switch 3(fS2/fTz=duty cycle for ePWM3)
float  fTempCoeff;      // temp variable
float  fTempArr[200];
float  ftemp;
int    i=0;
#define PI    3.142

void main(void)
{
// Step 1. Initialize System Control:
// PLL, WatchDog, enable Peripheral Clocks
// This example function is found in the DSP280x_SysCtrl.c file.
  InitSysCtrl();

// Step 2:
// For this case just init GPIO pins for ePWM1, ePWM2, ePWM3
// These functions are in the DSP280x_EPwm.c file
  InitEPwm1Gpio();
  InitEPwm2Gpio();
  InitEPwm3Gpio();

// Step 3. Clear all interrupts and initialize PIE vector table:
// Disable CPU interrupts
  DINT;

// Initialize the PIE control registers to their default state.
// The default state is all PIE interrupts disabled and flags
// are cleared.
// This function is found in the DSP280x_PieCtrl.c file.
  InitPieCtrl();

// Disable CPU interrupts and clear all CPU interrupt flags:
  IER = 0x0000;
```

```
IFR = 0x0000;

// Initialize the PIE vector table with pointers to the shell Interrupt
// Service Routines (ISR).
// This will populate the entire table, even if the interrupt
// is not used in this example. This is useful for debug purposes.
// The shell ISR routines are found in DSP280x_DefaultIsr.c.
// This function is found in DSP280x_PieVect.c.
    InitPieVectTable();

// Interrupts that are used in this example are re-mapped to
// ISR functions found within this file.
    EALLOW; // This is needed to write to EALLOW protected registers
    PieVectTable.EPWM1_INT = &epwm1_isr;
    PieVectTable.EPWM2_INT = &epwm2_isr;
    PieVectTable.EPWM3_INT = &epwm3_isr;
    EDIS; // This is needed to disable write to EALLOW protected registers

// Step 4. Initialize all the Device Peripherals:
// This function is found in DSP280x_InitPeripherals.c
// InitPeripherals(); // Not required for this example

    EALLOW;
    SysCtrlRegs.PCLKCR0.bit.TBCLKSYNC = 0;
    EDIS;

// Initialize space vector PWM variables
    InitSpaceVector();

    InitEPwm1();
    InitEPwm2();
    InitEPwm3();

    EALLOW;
    SysCtrlRegs.PCLKCR0.bit.TBCLKSYNC = 1;
    EDIS;

// Step 5. User specific code, enable interrupts
// Initialize counters:
    EPwm1TimerIntCount = 0;
    EPwm2TimerIntCount = 0;
```



```

    EPwm3TimerIntCount = 0;

// Enable CPU INT3 which is connected to EPWM1-3 INT:
IER |= M_INT3;

// Enable EPWM INTn in the PIE: Group 3 interrupt 1-3
PieCtrlRegs.PIEIER3.bit.INTx1 = 1;
PieCtrlRegs.PIEIER3.bit.INTx2 = 1;
PieCtrlRegs.PIEIER3.bit.INTx3 = 1;

// Enable global Interrupts and higher priority real-time debug events:
EINT;                // Enable Global interrupt INTM
ERTM;                // Enable Global realtime interrupt DBGM

// Step 6. IDLE loop. Just sit and loop forever (optional):
for(;;)
{
    asm("NOP");
}

}

// This interrupt implements the Space vector algorithm
// During every interrupt the times T0,T1 and T2 are calculated
// Based on the sector number, the switching times S1,S2 and S3 are
// calculated.
interrupt void epwm1_isr(void)
{
    if(fAlpha>6.28) // check if alpha >2*pi radians
        fTz_incr=0;
    fAlpha=2*PI*iFund_freq*fTz_incr; // fAlpha = 0-2PI
    iSector=floor(fAlpha/(PI/3));
    fT1=fTempCoeff*sin(((iSector+1)*(PI/3))-fAlpha);
    fT2=fTempCoeff*sin(fAlpha-(iSector*(PI/3)));
    fT0=fTz-fT1-fT2;
    //Determine switching times
    if(iSector==0)
    {
        fS0=(fT0/2)+fT1+fT2;
    }
}

```

```
        fS1=(fT0/2)+fT2;
        fS2=(fT0/2);
    }
    else if(iSector==1)
    {
        fS0=(fT0/2)+fT1;
        fS1=(fT0/2)+fT1+fT2;
        fS2=(fT0/2);
    }
    else if(iSector==2)
    {
        fS0=(fT0/2);
        fS1=(fT0/2)+fT1+fT2;
        fS2=(fT0/2)+fT2;
    }
    else if(iSector==3)
    {
        fS0=(fT0/2);
        fS1=(fT0/2)+fT1;
        fS2=(fT0/2)+fT2+fT1;
    }
    else if(iSector==4)
    {
        fS0=(fT0/2)+fT2;
        fS1=(fT0/2);
        fS2=(fT0/2)+fT1+fT2;
    }
    else if(iSector==5)
    {
        fS0=(fT0/2)+fT1+fT2;
        fS1=(fT0/2);
        fS2=(fT0/2)+fT1;
    }
}

// updating duty cycles of ePWM1,ePWM2, ePWM3

fTemp=(fS0/fTz);
fTemp=fTemp*EPwm1Regs.TBPRD;
// storing in array only to test SV waveform on Code Composer
fTempArr[i++]=fTemp;
```

```
        if(i>198)
            i=0;

        EPwm1Regs.CMPA.half.CMPA = ftemp; //(int)(dS0/dTz)*EPwm1Regs.TBPRD;
        EPwm2Regs.CMPA.half.CMPA = (fS1/fTz)*EPwm2Regs.TBPRD;
        EPwm3Regs.CMPA.half.CMPA = (fS2/fTz)*EPwm3Regs.TBPRD;

        fTz_incr=fTz_incr+0.0001;

        EPwm1TimerIntCount++;
        // Clear INT flag for this timer
        EPwm1Regs.ETCLR.bit.INT = 1;
        // Acknowledge this interrupt to receive more interrupts from group 3
        PieCtrlRegs.PIEACK.all = PIEACK_GROUP3;
    }

interrupt void epwm2_isr(void)
{
    EPwm2TimerIntCount++;

    // Clear INT flag for this timer
    EPwm2Regs.ETCLR.bit.INT = 1;

    // Acknowledge this interrupt to receive more interrupts from group 3
    PieCtrlRegs.PIEACK.all = PIEACK_GROUP3;
}

interrupt void epwm3_isr(void)
{
    EPwm3TimerIntCount++;

    // Clear INT flag for this timer
    EPwm3Regs.ETCLR.bit.INT = 1;

    // Acknowledge this interrupt to receive more interrupts from group 3
    PieCtrlRegs.PIEACK.all = PIEACK_GROUP3;
}
```

```

// function to initialize global variables used in Space Vector implementation
void InitSpaceVector()
{
    fTz = 0.0001;           // sampling period
    iFund_freq=100;        // fundamental frequency of required output
    iV_Ref=100;            // reference voltage - peak voltage of output
    iV_Dc=300;             // DC bus voltage
    fTz_incr=0.0;         // temp variable to store temp increment of Tz
    fAlpha=0;             // angle of space vector
    iSector=0;            // sector number
    fT0=0;                // time T0;
    fT1=0;                // time T1;
    fT2=0;                // time T2;
    fS0=0;                // time of Switch 1(fS0/fTz=duty cycle for ePWM1)
    fS1=0;                // time of Switch 2(fS1/fTz=duty cycle for ePWM2)
    fS2=0;                // time of Switch 3(fS2/fTz=duty cycle for ePWM3)
    fTempCoeff=((1.732*iV_Ref*fTz)/iV_Dc);
}

void InitEPwm1()
{
    // EPWM Module 1 config
    // 1) Set up ePWM Time Base module
    // TBCLK=1/(SYSCLKOUT/(HISPCLKDIV*CLKDIV) = 1/(100Mhz/(4*2))=(1/25MHz)
    // TPWM = 2*TBPRD/(25MHz)=0.0001s = Freq of pwm=10Khz;
    EPwm1Regs.TBPRD = 1250;           // Set timer period
    EPwm1Regs.TBPHS.half.TBPHS = 0x0000; // Phase is 0
    EPwm1Regs.TBCTR = 0x0000;        // Clear counter
    EPwm1Regs.TBCTL.bit.CTRMODE = TB_COUNT_UPDOWN; // Count up
    EPwm1Regs.TBCTL.bit.PHSEN = TB_DISABLE; // Disable phase loading
    EPwm1Regs.TBCTL.bit.HSPCLKDIV = TB_DIV2; // (HISPCLKDIV*CLKDIV) = (2*2=4)
    EPwm1Regs.TBCTL.bit.CLKDIV = TB_DIV2;
    EPwm1Regs.TBCTL.bit.PRDL = TB_SHADOW;
    EPwm1Regs.TBCTL.bit.SYNCSEL = TB_CTR_ZERO; // Sync down-stream module
    // 2) Set up ePWM Counter-compare module
    EPwm1Regs.CMPCTL.bit.SHDWAMODE = CC_SHADOW; // Load registers every ZERO
    EPwm1Regs.CMPCTL.bit.SHWBMODE = CC_SHADOW;
    EPwm1Regs.CMPCTL.bit.LOADAMODE = CC_CTR_ZERO;
    EPwm1Regs.CMPCTL.bit.LOADBMODE = CC_CTR_ZERO;
}

```

```

// Initial default compare value
EPwm1Regs.CMPA.half.CMPA = 10; // Initial value
// 3) Set up Action control module
EPwm1Regs.AQCTLA.bit.CAU = AQ_SET; // set actions for EPWM1A
EPwm1Regs.AQCTLA.bit.CAD = AQ_CLEAR;
// 4) Set up deadband
EPwm1Regs.DBCTL.bit.OUT_MODE = DB_FULL_ENABLE;
EPwm1Regs.DBCTL.bit.IN_MODE = DBA_ALL;
EPwm1Regs.DBCTL.bit.POLSEL = DB_ACTV_HIC; // Active Hi complementary
EPwm1Regs.DBFED = 50; // FED = 50 TBCLKs
EPwm1Regs.DBRED = 50; // RED = 50 TBCLKs
// 5) Interrupt where Space Vector switchin time is updated
EPwm1Regs.ETSEL.bit.INTSEL = ET_CTR_ZERO; // Select INT on Zero event
EPwm1Regs.ETSEL.bit.INTEN = 1; // Enable INT
EPwm1Regs.ETPS.bit.INTPRD = ET_1ST; // Generate INT on 1st event
}

```

```
void InitEPwm2()
```

```

{
// EPWM Module 2 config
// 1) Set up ePWM Time Base module
// TBCLK=1/(SYSCLKOUT/(HISPCLKDIV*CLKDIV)) = 1/(100Mhz/(4*2))=(1/25MHz)
// TPWM = 2*TBPRD/(25MHz)=0.0001s = Freq of pwm=10Khz;
EPwm2Regs.TBPRD = 1250; // Set timer period
EPwm2Regs.TBCTR = 0x0000; // Clear counter
EPwm2Regs.TBCTL.bit.HSPCLKDIV = TB_DIV2; // (HISPCLKDIV*CLKDIV) = (4*2=8)
EPwm2Regs.TBCTL.bit.CLKDIV = TB_DIV2;
EPwm2Regs.TBPHS.half.TBPHS = 0x0000; // Phase is 0
EPwm2Regs.TBCTL.bit.CTRMODE = TB_COUNT_UPDOWN; // Symmetrical mode
EPwm2Regs.TBCTL.bit.PHSEN = TB_ENABLE; // Slave module
EPwm2Regs.TBCTL.bit.PRDL = TB_SHADOW;
EPwm2Regs.TBCTL.bit.SYNCOSEL = TB_SYNC_IN; // sync flow-through
// 2) Setup ePWM Counter-compare module
EPwm2Regs.CMPCTL.bit.SHDWAMODE = CC_SHADOW;
EPwm2Regs.CMPCTL.bit.SHDWBMODE = CC_SHADOW;
EPwm2Regs.CMPCTL.bit.LOADAMODE = CC_CTR_ZERO; // load on CTR=Zero
EPwm2Regs.CMPCTL.bit.LOADM = CC_CTR_ZERO; // load on CTR=Zero
EPwm2Regs.CMPA.half.CMPA = 10;
// 3) Setup action qualifier module
EPwm2Regs.AQCTLA.bit.CAU = AQ_SET; // set actions for EPWM2A
}

```

```

    EPwm2Regs.AQCTLA.bit.CAD = AQ_CLEAR;
    // 4) Setup deadband module
    EPwm2Regs.DBCTL.bit.OUT_MODE = DB_FULL_ENABLE;
    EPwm2Regs.DBCTL.bit.IN_MODE = DBA_ALL;
    EPwm2Regs.DBCTL.bit.POLSEL = DB_ACTV_HIC; // Active Hi complementary
    EPwm2Regs.DBFED = 50; // FED = 50 TBCLKs
    EPwm2Regs.DBRED = 50; // RED = 50 TBCLKs
    // 5) Setup event trigger module
    EPwm2Regs.ETSEL.bit.INTSEL = ET_CTR_ZERO; // Select INT on Zero event
    EPwm2Regs.ETSEL.bit.INTEN = 1; // Enable INT
    EPwm2Regs.ETPS.bit.INTPRD = ET_1ST; // Generate INT on 1st event
}

void InitEPwm3()
{
    // EPWM Module 3 config
    // 1) Set up ePWM Time Base module
    // TBCLK=1/(SYSCLKOUT/(HISPCLKDIV*CLKDIV) = 1/(100Mhz/(4*2))=(1/25MHz)
    // TPWM = 2*TBPRD/(25MHz)=0.0001s = Freq of pwm=10Khz;
    EPwm3Regs.TBPRD = 1250; // Set timer period
    EPwm3Regs.TBCTR = 0x0000; // Clear counter
    EPwm3Regs.TBCTL.bit.HSPCLKDIV = TB_DIV2; // (HISPCLKDIV*CLKDIV) = (4*2=8)
    EPwm3Regs.TBCTL.bit.CLKDIV = TB_DIV2;
    EPwm3Regs.TBPHS.half.TBPHS = 0x0000; // Phase is 0
    EPwm3Regs.TBCTL.bit.CTRMODE = TB_COUNT_UPDOWN; // Symmetrical mode
    EPwm3Regs.TBCTL.bit.PHSEN = TB_ENABLE; // Slave module
    EPwm3Regs.TBCTL.bit.PRDL = TB_SHADOW;
    EPwm3Regs.TBCTL.bit.SYNCSEL = TB_SYNC_IN; // sync flow-through
    // 2) Setup ePWM Counter-compare module
    EPwm3Regs.CMPCTL.bit.SHDWAMODE = CC_SHADOW;
    EPwm3Regs.CMPCTL.bit.SHDWBMODE = CC_SHADOW;
    EPwm3Regs.CMPCTL.bit.LOADAMODE = CC_CTR_ZERO; // load on CTR=Zero
    EPwm3Regs.CMPCTL.bit.LOADBMODE = CC_CTR_ZERO; // load on CTR=Zero
    EPwm3Regs.CMPA.half.CMPA = 10;
    // 3) Setup ePWM action qualifier module
    EPwm3Regs.AQCTLA.bit.CAU = AQ_SET; // set actions for EPWM3A
    EPwm3Regs.AQCTLA.bit.CAD = AQ_CLEAR;
    // 4) Setup ePWM deadband module
    EPwm3Regs.DBCTL.bit.OUT_MODE = DB_FULL_ENABLE;
    EPwm3Regs.DBCTL.bit.IN_MODE = DBA_ALL;
    EPwm3Regs.DBCTL.bit.POLSEL = DB_ACTV_HIC; // Active Hi complementary

```

```
    EPwm3Regs.DBFED = 50;           // FED = 50 TBCLKs
    EPwm3Regs.DBRED = 50;           // RED = 50 TBCLKs
    // 5) Setup ePWM event trigger module
    EPwm3Regs.ETSEL.bit.INTSEL = ET_CTR_ZERO; // Select INT on Zero event
    EPwm3Regs.ETSEL.bit.INTEN = 1; // Enable INT
    EPwm3Regs.ETPS.bit.INTPRD = ET_1ST; // Generate INT on 1st event
}
```

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